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Single electron transistor based charge sensors: fabrication challenges and opportunities

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Measuring electric charge precisely is crucial in various fields including semiconductor device fabrication, particle physics, materials science, medical imaging, electrotherapy, electroplating, and electrolysis. It becomes even more demanding for quantum applications. Existing technology like voltmeters and electrometers are valuable tools, but limitations like low sensitivity, drift, and accessibility hinder their use in quantum applications. Researchers are addressing these issues by exploring new approaches like nano-material-based sensors with quantum mechanics for ultra-sensitive charge detection. The single-electron transistor (SET) achieves high sensitivity by controlling individual electron flow due to the Coulomb blockade principle and other quantum phenomena. Existing charge sensors have limited operation, as it is very challenging to detect very small changes in charge due to the continuous current flow. In contrast, SETs control the flow of individual electrons due to the discrete nature of flowing electrons. Furthermore, ultra-low power and highly reliable electronic components can be created by precisely controlling single electrons, which introduces a new era of miniaturized and energy-efficient electronics. In this review, the rudiments of SETs and the significance of material choice for a SET are highlighted. The nano-fabrication methods, leading to the development of next-generation ultra-sensitive and low-power quantum electronics are pointed out. The challenges and issues are incorporated into developing new ideas, approaches, and technologies for the field of quantum sensors. Finally, we discuss the future outlook and potential developments to accelerate the development of high-precision SET-based charge sensors for future research directions.

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Introduction

Quantum sensing is a rapidly growing area of science. It promises to greatly improve how we measure things, diagnose illnesses, and process information. This is because quantum sensors utilize quantum mechanics for precise measurements. Charge sensors detect electrical charge. When these charge sensors use quantum effects, they become quantum charge sensors. Single-electron transistors (SETs) are a prime example of quantum charge sensors, employing the Coulomb blockade effect for highly sensitive charge detection. These tiny devices can detect extremely small changes in electrical charge, more

precisely than ever before. Previously, quantum point contacts (QPCs) and capacitive-based charge sensors were used for charge-sensing applications. All those existing sensors generally responded to the total electric field, not just the charge of a specific object. Single-electron transistors (SETs) address this challenge by providing charge detection at the single-electron level, offering enhanced sensitivity beyond the classical sensor. A detailed overview of the single-electron transistor (SET) device's evolution is presented in Table 1.

The single-electron effects will be crucial in almost any electronic device with dimensions below ~30 nm, and this is considered a new physical basis for nanoscale digital circuits. The confinement of an electron can alter the number of energy levels and the bandgap of the semiconductor to provide a quantized flow of electrons. By accommodating these particles in a tiny space, their behaviour changes dramatically compared to bulk materials. If an electron is confined in three dimensions, it is called a quantum dot. The QD, which is also sometimes called an island of a SET, plays a key role in controlling electron movement. Because of this extreme confinement, the allowed energy levels become very discrete, almost like individual dots on a line. A QD exhibits unique optical and electrical

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properties and is being explored for applications in bioimaging,^{1,2} displays,^{3,4} photodetectors,⁵ photovoltaics, LEDs,⁶ solar cells,⁷ microscopy⁸ and quantum computing.^{9,10} Therefore, the degree of confinement influences the energy levels available to electrons. Also, it impacts various properties of the material, including electrical conductivity, mobility, mechanical, thermal, biocompatibility, chemical, and overall behaviour.

Nanomaterials can restrict electrons at the nanoscale; nanomaterials are essential for the functioning and promise of these devices. We can produce structures with specific quantum mechanical features, such as narrow channels or quantum dots, by modifying materials at the atomic scale. A fundamental idea of SET operation is controlled electron tunneling, made possible by nanomaterials with tiny insulating barriers. For a practical SET to operate, specific electrical properties, such as a high work function and low leakage current, are essential, and nanomaterials provide a means of obtaining these qualities.

The central island of SETs can be constructed using quantum dots created from materials like silicon or gallium arsenide, which enable exact control over electron tunneling. Certain kinds of carbon nanotubes (CNTs) can be utilized to make conducting channels perfect for regulated electron tunneling, with well-defined sizes and great purity. As the conducting island in SETs, single molecules with clearly defined energy levels provide the highest degree of miniaturization and the possibility of novel capabilities. Because of their capacity to confine electrons along a single dimension, narrow strips of graphene can display unique electrical properties appropriate for SET applications.¹¹ Nanomaterials are crucial for advancing single-electron transistors (SETs). They enable the creation of extremely sensitive, low-power devices for a range of applications by addressing existing constraints such as temperature requirements, fabrication challenges, and integration issues. Some nanomaterials, such as graphene and

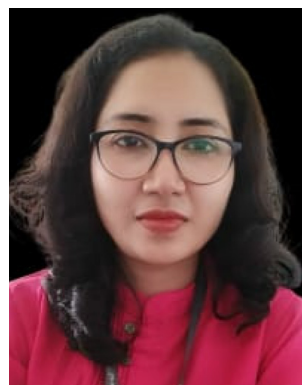
carbon nanotubes, have special electrical characteristics that allow SETs to function at higher temperatures, even at room temperature. Since it eliminates the need for expensive cryogenic cooling systems, this is a major advancement since SETs become more viable for general usage. Nanomaterials thus have great power to revolutionize the discipline of single-electron transistors. Further investigation and advancement may result in extremely sensitive, low-power gadgets that find use in quantum computing, next-generation electronics, and ultra-sensitive sensors.

Measuring a single-electron charge, fundamental quantum technology is of paramount importance. Charge sensing is a crucial component for measuring single spins, single photons, and single molecules, leading to applications in single-electron charge, single-electron spin, photon–electron quantum interface, and bio-sensors.¹² These SETs can detect when an electron has tunnelled from a source electrode to the drain (Fig. 1a). The sensitivity of the SET has been realized by the effect of coupling QDs to the source, drain, and gate electrodes. Thus, the number of electrons in the dot can be determined by tuning the gate voltage. The SET's sensitivity is measured from current–voltage observations of the device.¹³ Under specific gate–voltage settings, the conductance *via* the (SET) sensor is susceptible to the electrostatic environment. Single-electron charge sensing is made possible by single-electron charging in the QD, which dramatically alters the sensor's (SET) conductance because of the SET's proximity to the QD. Real-time detection of single-electron tunneling events is made possible by this technology, which functions even in cases where QD conductance is too tiny to measure.¹⁴ Furthermore, by converting other physical quantities into electron charge, this real-time charge sensing enables the measurement of other physical quantities: spin-dependent tunneling events have been used to readout single-electron spin,^{15–17} and single-photon detection has been demonstrated



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Table 1 Evolution of SET with respect to time period

Aspect	1980–1990	1990–2000	2000–2010	2010–2024
Theory and modeling	<ul style="list-style-type: none"> • Early theoretical discussions on SET behaviour • Exploration of quantum confinement effects 	<ul style="list-style-type: none"> • Refinement of SET models • QD energy level studies 	<ul style="list-style-type: none"> • Advanced modeling techniques • Room-temperature operation investigations 	<ul style="list-style-type: none"> • Comprehensive theoretical frameworks • Co-integration with CMOS explored
Design and fabrication	<ul style="list-style-type: none"> • Initial SET designs based on the Coulomb blockade • Fabrication challenges 	<ul style="list-style-type: none"> • Improved fabrication techniques • Nanoscale control of tunnel junctions 	<ul style="list-style-type: none"> • Electromigration-induced activation • Precise parameter evaluation 	<ul style="list-style-type: none"> • Co-integration with CMOS technology • Material choices for stability
Advantages	<ul style="list-style-type: none"> • Potential for ultra-low power operation • Exploitation of quantum effects 	<ul style="list-style-type: none"> • Compatibility with CMOS technology • Enhanced performance at scaled nodes 	<ul style="list-style-type: none"> • Room-temperature SETs demonstrated • QD-based computing systems 	<ul style="list-style-type: none"> • SET as a potential nano-device for futuristic applications • Heterogeneous 3D integration prospects
Challenges and drawbacks	<ul style="list-style-type: none"> • Low current drivability • Sensitivity to background charges 	<ul style="list-style-type: none"> • Small voltage gain • Cryogenic operation 	<ul style="list-style-type: none"> • Noise susceptibility • Stability issues • Short-channel effects • Aggregation of non-idealities 	<ul style="list-style-type: none"> • Seamless hybrid design trade-offs • Maintaining overall performance

by detecting single photoexcited electrons.^{18,19} A few investigations on charge sensing for vertical QDs,²⁰ carbon nanotube QDs,²¹ and nanowire QDs^{22,23} have also been published. These research efforts include either positioning a sensor (SET) close to a QD or linking a sensor and a QD *via* a floating gate.

A SET charge sensor is ideal for applications demanding ultra-high sensitivity for single-electron detection. The SET charge sensor finds use in areas like QD characterization, biomolecule sensing with high specificity, and real-time monitoring of single-electron processes.²⁴ The SET-based charge sensor can be used as a bio-sensor as well.²⁵ The gate electrode of a SET can be functionalized with biorecognition molecules like antibodies or enzymes. These molecules specifically bind to target biomolecules (*e.g.*, proteins, DNA) present in a

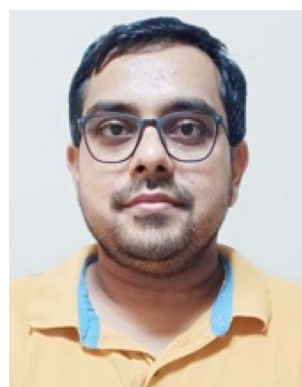
sample.²⁶ When a target biomolecule binds to the recognition element, it alters the local electrical environment around the SET gate. This change in charge can be detected by the SET as a shift in its current flow.

Researchers have focused on SETs because of their special qualities and potential for unprecedented applications. One of a SET's primary features is its extreme sensitivity.²⁷ This is made feasible by the incredibly sensitive detection and measurement of minute changes in charge made possible by quantum physics. They are therefore ideal for high-precision uses such as biosensing and QD research. Biosensors can detect the presence of biomolecules like proteins or DNA (deoxyribonucleic acid) by measuring the tiny changes in charge that occur when these molecules bind to the SET's

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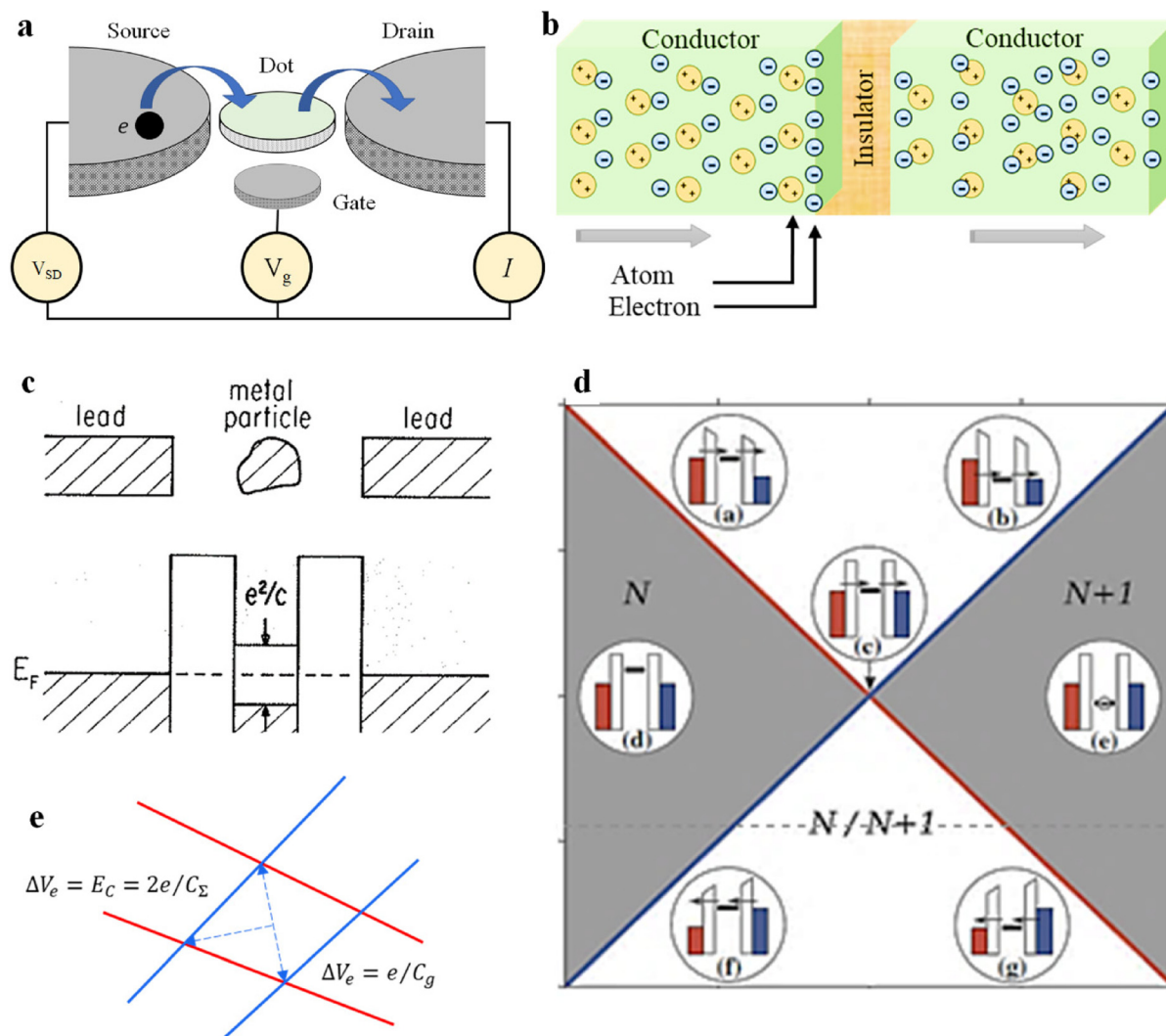


Fig. 1 a. Schematic diagram of quantum dot tunneling. b. Schematic diagram of a tunnel junction. c. Illustration of the Coulomb blockade system and its energy band structure with filled and empty levels (bottom) (this figure has been reproduced from ref. 41 with permission from the American Physical Society copyright 2024). d. Schematic diagram of the 2D charge stability plot (this figure has been reproduced from ref. 42 with permission from Springer Nature copyright 2024). e. Slope calculated from the charge stability diagram.

surface.²⁸ SETs can probe the quantum properties of individual electrons confined within tiny semiconductor structures called QDs, leading to quantum dot research.²⁹ Furthermore, a SET works on the premise of directing the flow of single electrons, in contrast to ordinary transistors that deal with millions of electrons. The basic informational elements of quantum computing are quantum bits, or qubits; SETs are appealing building blocks for their development. Encoding and processing quantum information depends on their capacity to control single electrons. This will lead to manipulation in a quantum computer and by integrating SETs with molecules exhibiting specific electronic properties, researchers can create novel devices with functionalities beyond conventional electronics. This is known as molecular electronics.^{30,31}

The small size and scalability of SETs make them attractive for building ultra-miniaturized electronic devices. This feature

of scalability can be used for high-density integrated circuits. SETs hold promise for creating powerful and compact integrated circuits with a much higher density of transistors compared to conventional devices. Also for nanoelectronics, where researchers aim to create electronic devices on the atomic and molecular scale. Due to their low current operation, SETs are inherently energy-efficient, and achieving room-temperature operation would enable their use in practical low-power applications. SETs could be used to build low-power logic circuits for applications where energy consumption is a major concern. Recent research in SET synthesis focuses on improving fabrication techniques to achieve room-temperature functionality and miniaturization for large-scale applications. Researchers are creating reconfigurable SETs that can switch between different operational modes. This allows for more versatile devices with potential applications in low-power, reconfi-

gurable logic circuits.³² As researchers pack more SETs onto a chip, reducing their size becomes crucial. New synthesis approaches aim to optimize the layout of SET arrays to minimize their overall width while maintaining functionality.³³ The scientific community is actively striving to overcome obstacles including room-temperature operation and fabrication complexity, even though these remain. SETs are a fascinating topic of research with great potential to transform several technical domains because of their special qualities and their uses. Therefore, this investigation seeks to explore SET fabrication, operational concepts, and several uses, thus revealing their promise as next-generation quantum sensors. We show how to construct high-performance SET-based sensors able to push the limits of measurement accuracy by analyzing current developments in nano-fabrication methods.

In this review, we discuss the evolution of SETs in terms of devices and the selection of suitable materials and SET-based quantum devices as sensors. Also, we discuss the fundamental concepts of SETs, such as tunnel junctions, the Coulomb blockade effect, QDs, Coulomb diamonds, and advancements in fabrication and characterization strategies. We then outline the challenges and problems of SETs, with particular attention paid to integration, noise, and operational conditions. Finally, in order to inspire hope and optimism, we highlight SETs' bright future and their potential as a research avenue for SET candidates.

Fundamentals of SETs

Single-electron transistor operation

A single-electron transistor (SET) fundamentally consists of a small conductive quantum dot (QD) connected to a gate electrode *via* a capacitive coupling and to source and drain metallic leads through thin tunneling junctions (Fig. 1a). The operational principle of a SET relies on the Coulomb blockade effect. Due to electrostatic repulsion between electrons within the confined space of the QD, significant energy is required to add an additional electron. This phenomenon, which arises from the discrete nature of charge, dictates the conductance behavior of the SET. Specifically, the energy required to add or remove a single electron is given by $e^2/2C$, where 'C' represents the total capacitance of the QD.³⁴ The tunneling junctions, acting as insulating barriers, prevent classical electron flow. However, quantum mechanical resonant tunneling allows electrons to traverse these barriers when their energy aligns with the discrete energy levels of the QD. The quantum dot, by storing charges, behaves as a capacitor, similar to a metal-insulator-metal structure (Fig. 1c). Consequently, controlling the gate voltage enables precise manipulation of the QD's energy levels, thereby regulating electron tunneling and the SET's conductance.

The SET has some requirements for charge to affect it and we call this the "Orthodox theory".³⁵ It is necessary for the *capacitance to be lower* than the energy needed to charge one electron (*i.e.*) $E_c = e^2/2C$ where E_c is the electrostatic energy of

charge and C is the capacitance.³⁶ This is regarded as the prerequisite for the measurement of single electron tunneling. Since the capacitance and size of the QD are directly correlated, the electrostatic energy of the charge can be controlled.³⁷ The maximal charging energy of the QD can only be retained at a size of roughly less than a few nanometers. However, tunneling electrons from the source to the QD is complex because of the "Coulomb blockade" principle. Hence, a tunneling electron requires more energy to tunnel through the barrier.

The second requirement is that charging and discharging of the QD should have a *finite time*. The rate (Δt) at which the capacitance builds up charge or discharges is proportional to $R_T C$. Because of the tunnel resistance, the charging and discharging of QDs can take place over an exponentially long time. This means that even a small increase in tunnel resistance can significantly increase the time it takes to charge or discharge the QD. Then, the SET device has to be operated in a *very low temperature* (below 4 K) environment, which is an essential requirement,³⁸ because thermal energy should not be involved in the electron transport mechanism. Otherwise, temperature controls electron transport, which is not desired. Tunnel resistance, which must be kept at a high level, is a particular criterion that must be met to overcome the uncertainty principle. We know that the uncertainty principle is a fundamental limitation of quantum mechanics. It states the inherent limitation of knowing the position and momentum of a particle with perfect accuracy simultaneously.³⁹

$$\Delta E \Delta t \geq \hbar$$

$$\Delta E \sim \frac{\hbar}{\Delta t} \sim \frac{\hbar}{R_T C} < E_c$$

$$\frac{\hbar}{R_T C} < \frac{e^2}{2C}$$

$$\frac{R_T}{\hbar} > \frac{2}{e^2}$$

$$R_T > \frac{2\hbar}{e^2} \sim 2(25.8 \text{ k}\Omega)$$

$$R_T > 51.6 \text{ k}\Omega$$

From the above relationships, a high tunnel resistance (R_T) can reduce the current fluctuations in an SET, which leads to a smaller uncertainty in the measurement of the charge on the QD. However, it does not eliminate the limitation of the fundamental uncertainty principle.

The Coulomb diamond (charge stability diagram)

The charge stability diagram shows how the quantity of electrons on the SET QD relates to its operational parameters and depicts the QD's energy state. The charge stability diagram is a 2D graph that plots the conductance (or current) through a single-electron transistor (SET) as a function of the gate voltage, V_g , and the bias voltage, V_{ds} , revealing the Coulomb blockade regions and conductance peaks. This plot contains a diamond-shaped region in the middle of the graph; hence it is

called a Coulomb diamond.⁴⁰ Every diamond signifies a specific quantity of electrons occupying the QD, which is known as the charge state, Q_0 . The boundaries of these diamonds mark the points at which adding or removing an electron becomes energetically unfavourable. The characteristics of QDs such as the charging energy needed to add or remove an electron can be analysed using the size, shape and position of these diamonds. Electrons cannot pass through the QD unless the electrodes have a specific chemical potential of μ , where μ represents the average energy per electron in a reservoir (electrode) connected to the QD. The alignment of the chemical potential (μ) of the QD with regard to the potentials of the source, μ_s , and drain, μ_d , has a significant impact on the electron transfer process. Consider electron transport through the QD, not including the excited states of the QD and level-broadening behaviour (Fig. 1d). For the condition of a chemical potential of $\mu_{\text{dot}} = \mu_s = \mu_d$, the respective gate voltage is $V_g = 0$.

As the charges inside these regions are locked to N or $N + 1$, the charge stability diagram's grey-coloured zone provides the Coulomb blockade region. The white colour of the QD represents the ability of electrons to tunnel into and out of it. However, due to a smaller number of electrons available at the QD, it is always better to determine conductance, dI/dV , than current, I , for a more sensitive measurement. So, even tiny changes in gate voltage (dV) can lead to significant changes in conductance, making it easier to detect and analyse the behaviour of the SET.⁴³ So, the current I can be substituted with conductance dI/dV for measurement. Red and blue lines are thus the only visible indication of the change in current I . The red and blue lines indicate that the QD's chemical potential is equal to that of the source and drain (Fig. 1d). The chemical potential of the QD is higher than the source and drain leads at the initial zero bias voltage, $V_{\text{ds}} = V_s = V_d = 0$, and $V_g < 0$. Consequently, there is a charge fluctuation between the N and $N + 1$ states and the electron cannot be transferred because the SET is in the off state (Fig. 1d). Raising V_g to zero will therefore suppress the chemical potential level of the QD to the source and drain levels. Now, the electrons tunnel into and out of the QD from both the leads (source and drain), which results in charge fluctuations in the N and $N + 1$ states. The term "charge degeneracy point" refers to this particular operational zone (Fig. 1d). The QD's chemical potential is lowered from any of the leads by increasing the gate voltage even further. As a result, the SET is in the off position but the QD has $N + 1$ electrons. When the charge inside the diamond is fixed, the SET is in the Coulomb blockade phase because it would require energy to overcome the Coulombic contact force with an extra electron. Current is observed even when $V_{\text{ds}} \neq 0$, and the chemical potential shifts between the drain and source, within the energy window of $\mu_s - \mu_d = eV_{\text{ds}}$, if the gate voltage is $V_g \neq 0$. Turning the SET on or off by crossing the red lines causes a conductance ridge to form along the line. The equivalent circuit can be used to calculate the slope, which is given by $-C_g/(C_g + C_s)$, by setting the potential difference between the QD and source to zero (Fig. 1e). A blue-coloured conduc-

tion regime may emerge if the chemical potentials of the drain and the QD line up (Fig. 1e). Setting the potential difference between the drain and the QD to zero enables computation of its slope, C_g/C_d , which has the opposite sign. Consequently, the SET is in a Coulomb blockade in the grey zone while the transistor is on inside the white region.

Single electron tunneling

The tunneling effect can be measured when the tunnel junctions are made too small and at low temperatures. If the existing charge (Q) at the junction is greater than half an electron's positive charge ($+e/2$), an electron can tunnel the barrier because ' e ' is subtracted from the charge ' Q ', thereby reducing the electrostatic energy of the QD. Similarly, the charge Q at the junction is smaller than $-e/2$, so an electron can tunnel because ' e ' is added to the charge ' Q ', thereby reducing the energy of the QD. But, in the range $-e/2 < Q < +e/2$, the electrostatic energy of the QD will be increased. Hence, in this region electrons cannot flow and this range is called the Coulomb blockade.⁴⁴

To observe the tunneling effect, the tunnel junction is connected to a constant current source. Initially, the system is in the Coulomb blockade region when the charge Q is zero, hence tunneling is forbidden. As a result, the source current begins to increase and exceeds $+e/2$. Then sufficient energy can pass one electron through the tunnel junction, and then again, the charge Q is greater than $-e/2$. Consequently, the system once more reaches the zone of the Coulomb barrier, making tunneling impossible. The charge Q increases until it attains $+e/2$ as the current stores positive charges in the junction at a consistent rate. After that, it repeats the procedure once again, which leads to the development of single-electron tunneling oscillations. The SET's oscillation frequency is calculated by dividing the current by the basic unit of charge (e).⁴⁵ The concept of single electron tunneling can be explained using water leaking from a faucet for a better understanding (Fig. 2).³⁷ The interface between an electrode and the insulator has no charge initially. As the electrons starts to flow onto the electrode, charges are stored on the conductor. When enough charges reach the electrode, an electron passes to the insulator and thereby reduces the surface charge. The process will repeat again if the charge is refilled. However, as the size of the droplet can vary in size, the quantity of tunneling charge is quantized and it is always equal to e .⁴⁶ Thus, a time correlation of the tunneling events takes the form of coherent SET oscillations with the frequency.

But the gate voltage, V_g , controls the energy required for the addition of the electron to a QD. Thus, the electrostatic energy of a charge Q on a QD under the influence of V_g is given as,

$$E = QV_g + Q^2/2C \quad (1)$$

The first term of eqn (1) represents an attractive interaction between negatively charged Q and a positively charged gate electrode. The second term defines the repulsive force between charges on the QD.

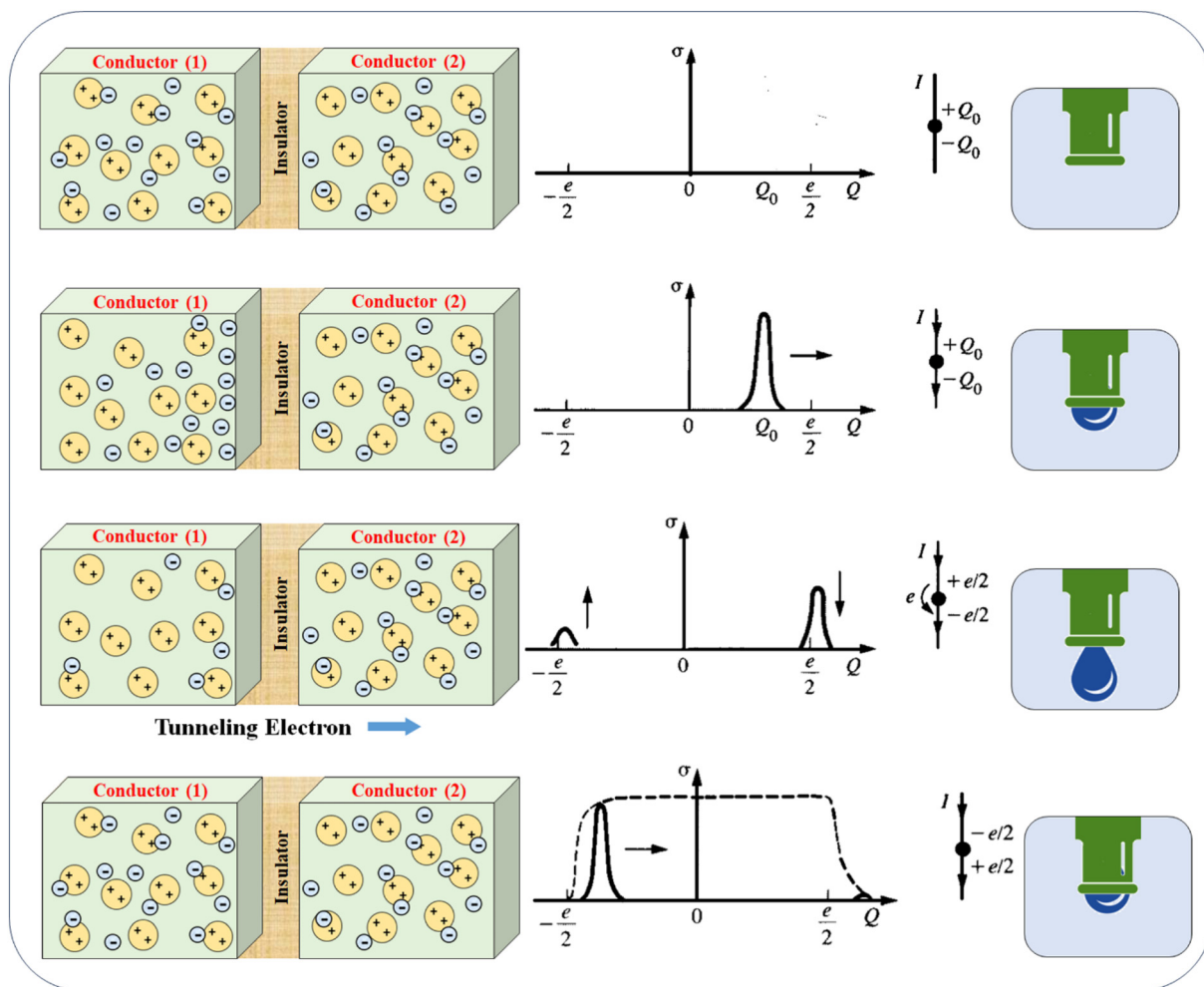


Fig. 2 Single-electron tunneling through a small junction resembles a water droplet falling from a faucet (this figure has been reproduced from ref. 37 with permission from Scientific American copyright 2024).

The single tunnel junction provides insights into the behaviour of a simple SET (Fig. 3a, top). When an insignificant drain–source bias voltage (V_{ds}) is applied, the left lead has a greater Fermi energy level than the right lead by eV_{ds} . The energy level eV_{ds} represents a unit of energy convenient for describing the energy levels in quantum systems that refers to the product of the electron charge (e) and the source–drain bias voltage (V_{ds}). It represents the potential energy difference experienced by an electron due to the applied voltage between the source and drain electrodes of the SET. Afterward, the current that is passing through the tunnel intersection can be written as,

$$I = \int \mathcal{T}(E)[f(E) - f(E - eV_{ds})]dE \quad (2)$$

where $\mathcal{T}(E)$ is the tunnel barrier transmission coefficient at energy E , and $f(E)$ is the Fermi–Dirac distribution function. In this expression, the term ‘ $-f(E - eV_{ds})$ ’ refers to electron tunneling from the right lead to the left lead. For a metallic QD, the coefficient $\mathcal{T}(E)$ is a slowly varying function based on its

energy E . Thus, determining the conductance of the system also varies slowly with bias voltage V_{ds} . This means that as the energy level (E) changes slightly, the number of available states ($\mathcal{T}(E)$) does not change dramatically. In simpler terms, there are always plenty of energy states available for electrons in the metal over a small energy range. As a result, the overall conductance of the SET through the metallic leads changes gradually with V_{ds} . In semiconductors, the density of states can change more abruptly with energy. This can lead to sharper variations in conductance with changes in V_{ds} , offering more control over the current flow. Next, consider the SET with two tunnel barriers in series with a large metal QD between them (Fig. 3a, right). If the metallic QD is larger in size, the size of the tunnel barriers will be reduced. Hence, an electron can easily pass into the QD and off of the QD. Thus, the controllability over tunneling will get lost. In another case, consider a small metallic QD in between both tunnel junctions, the size of the tunnel barriers will not get reduced. So, an electron cannot tunnel easily through the barrier. As a result, the conductance in a SET might vary dramatically depending on the

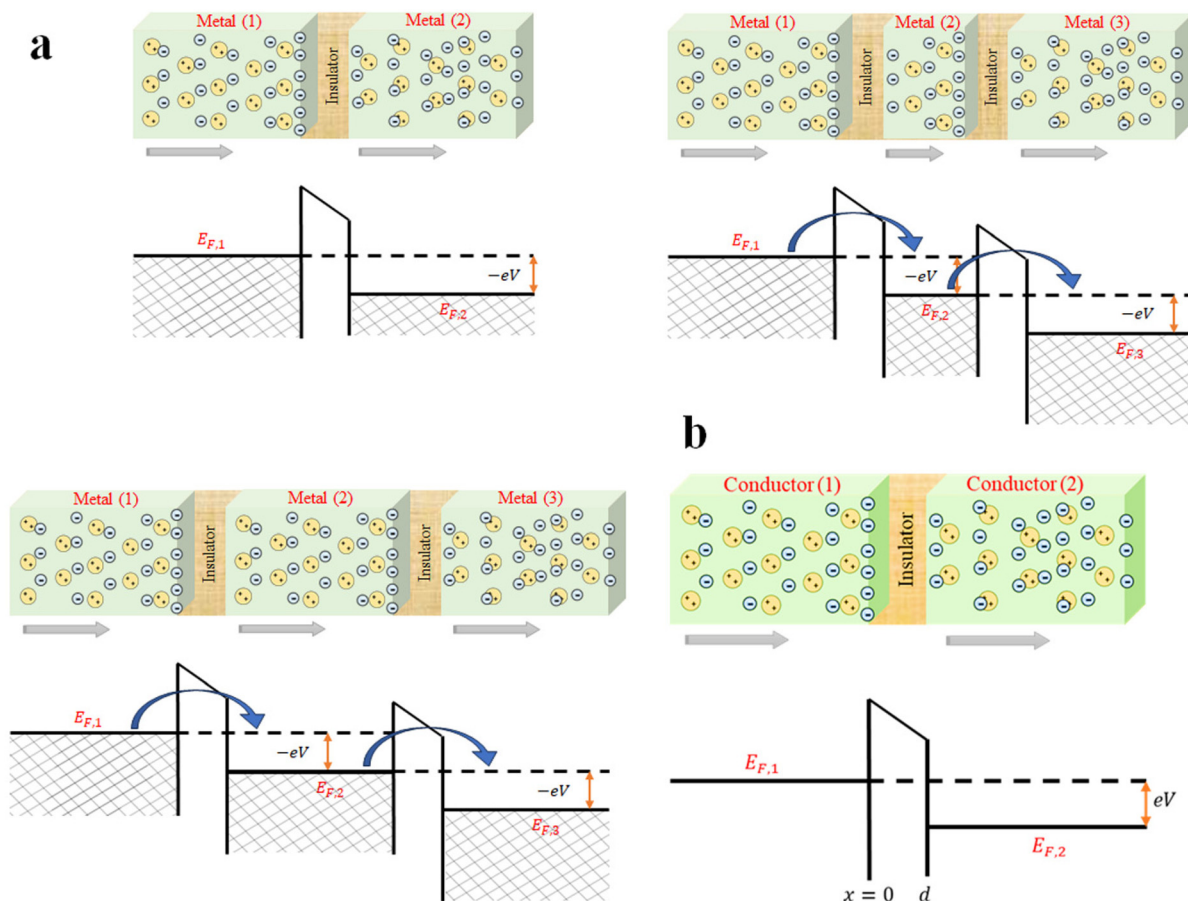


Fig. 3 a. Tunnel barrier between two metal electrodes and their respective energy band structures in the context of single electron tunneling. b. A tunnel barrier junction between two electron reservoirs 1 and 2 (top); tunnel barrier energy landscape using Fermi energies (bottom).

size of the QD. The energy of the system can be raised by charging the capacitance of the tunnel junctions, which occurs when an electron moves from the source to the drain. Traditionally, the charging energy is calculated as $U = e^2/2C$, where C represents the total capacitance of both junctions.³¹ If the metal QD is small, the capacitance value is also low, allowing charging energy U to surpass the value of ' kT '. The small size of the metal QD can be made possible by designing the capacitance of the sphere to be on the order of 10^{-16} farad since the capacitance is directly proportional to the size of the metal QD ($C = \epsilon A/d$). A very small capacitance can provide a charging energy on the order of meV (Fig. 3a, right and bottom) and the charging energy creates a gap in the transmission spectrum, $\mathcal{T}(E)$. Adding or withdrawing a single electron from the QD needs an energy of $U/2$. Furthermore, no current will flow at voltages for which $eV \geq U$ and temperatures for which $kT \geq U$, which describes the Coulomb blockade of tunneling.

Charging effects on SETs

The inherent quantization of electric charge, whereby it exists in discrete multiples of elementary charge, is a fundamental principle. Within confined systems, such as the island of a

single-electron transistor (SET), energy levels are similarly quantized, restricting electrons to specific, discrete energy states. As aforementioned, an additional energy of $e^2/2C$ is required to add an electron to the QD due to the Coulomb blockade principle. Eqn (1) represents the parabola of energy as a function of charge and the minimum energy occurs when the charge on the capacitor (tunnel junction) is $Q_0 = -CV_g$. From the concept of elementary charge e , the capacitance, C , of a capacitor can be expressed in terms of the number of electrons, N , that flow onto the capacitor and the voltage applied across it (*i.e.*), $C = Ne/V_g$. Hence, Q_0 becomes

$$Q_0 = -\frac{Ne}{V_g} = -Ne. \text{ At controlling charge state } Q_0 = -Ne, \text{ the}$$

energy of the system is at a maximum. Hence a greater energy difference is required to tunnel an electron from the source to the drain. If the controlling charge state increases further to $Q_0 = -(N + 1/4)e$, the energy of the system drops slowly and requires less energy to make an electron tunnel. Further increasing the controlling charge state to $Q_0 = -(N + 1/2)e$ will lead to a reduction in the energy of the system and make an electron transition with much less energy (Fig. 4a). These points are called charge degeneracy points because both

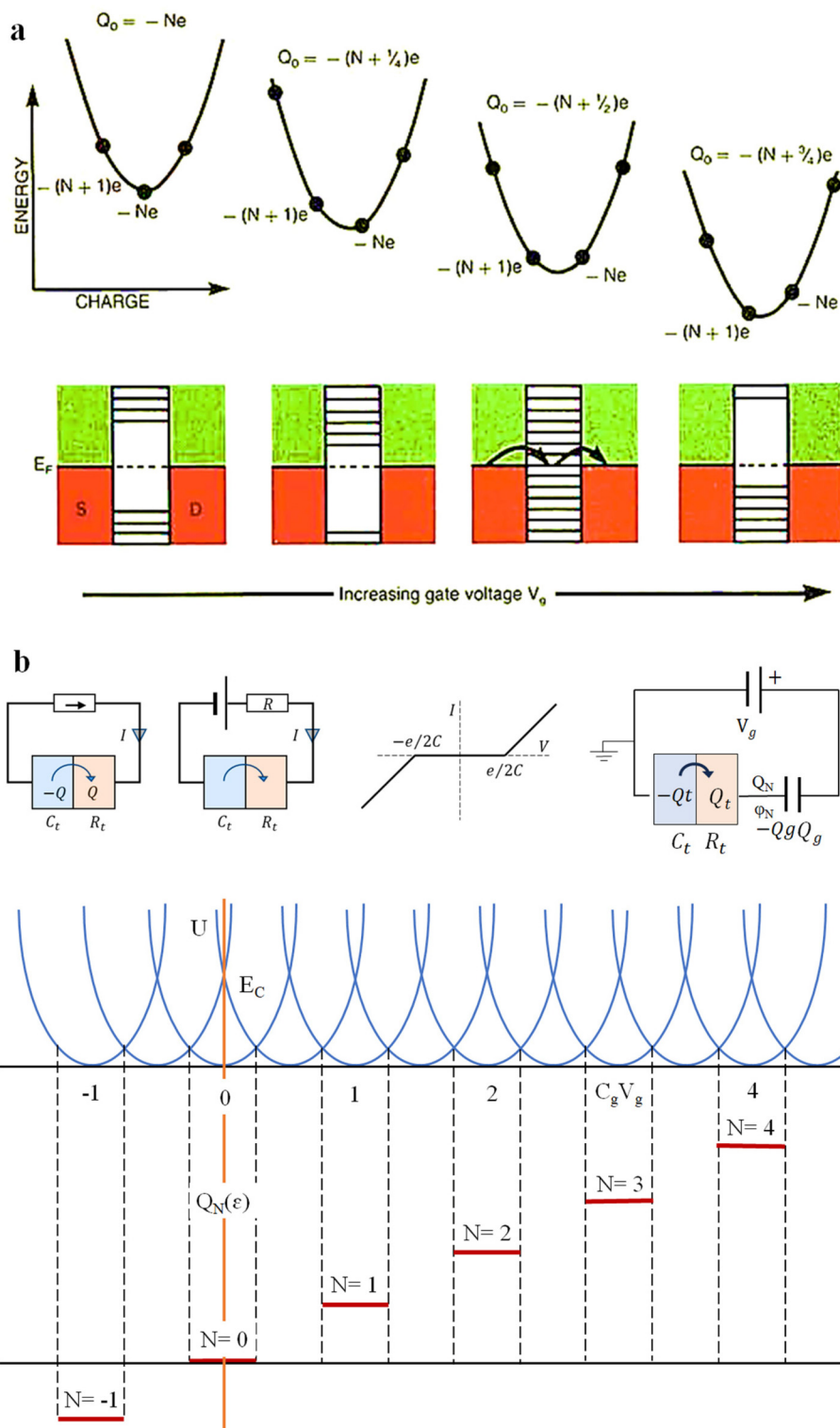


Fig. 4 a. Total energy and charge function in relation to four distinct gate voltage levels (this figure has been reproduced from ref. 31 with permission from AIP Publishing copyright 2024). b. Coulomb blockade I - V characteristics of a single-electron transistor (SET) with tunnel junctions.

energy states $N + 1$ and N have the same energy, which makes an electron fluctuates between N and $N + 1$. Finally, at the controlling charge state of $Q_0 = -(N + 3/4)e$, the energy of the system again increases and it is difficult to make the transition

unless or until the required energy is provided to make a tunnel. Thus, these iterations make an electron transition from the N state to the $N + 1$ state. As the controlling charge state (Q_0) increases steadily, a point of charge transition

(degeneracy point) and a peak in conductance are observed repeatedly. These occur at specific voltage intervals, corresponding to the energy needed to add a single electron to the artificial atom ($e^2/2C$).⁴⁷

The potential energy in the tunnel junction (Fig. 3b) can be affected by the tunnel junction capacitance. This can be understood from two limiting cases. First, the junction is connected to the voltage source with low internal resistance. The second case denotes the connection of the current source to a tunnel junction with high internal resistance. Initially, the voltage source or electrochemical potential difference of $\Delta\mu = eV$ is applied to the tunnel junction.⁴⁸ If the tunnel junction has a resistance of $R_t = 1/G_t$ and capacitance C , the metal system builds up charges $+Q$ and $-Q$ at the two sides of the barrier. Consequently, the accumulated charges $+Q$ and $-Q$ effectively result from a shift in the average positions of the electrons on the two sides of the barrier. This shift can lead to a continuously variable polarisation charge, which is linearly dependent on the difference in electrochemical potential.⁴⁹ This means the charge is related to the capacitance of the tunnel barrier *i.e.* $Q = CV$. However, under these conditions, the tunnel resistance is $R_t \gg h/2e^2$, so any charge that would tunnel will be quantised in units 'e'.

In order to examine the charges' time-dependent behaviour on a single junction, the current source must be linked to the tunnel junction. The current source has a very large internal resistance, R_s , and so it forces a constant current, I , through the junction. If a single electron with charge $-|e|$ tunnels through the barrier, the charge changes from Q to $Q - |e|$. Thus, the electrostatic potential changes from U_{initial} before tunneling to U_{final} after the tunneling event and can be given as

$$\Delta U = U_{\text{final}} - U_{\text{initial}} = \frac{(Q - |e|)^2}{2C} - \frac{Q^2}{2C} = \frac{-|e|}{C} \left(Q - \frac{|e|}{2} \right) \quad (3)$$

But at zero temperature ($T = 0$ K), tunneling will occur only if $\Delta U < 0$, *i.e.* whenever the system may enter a lower energy state, and this condition gives $Q > |e|/2$ or $V = Q/C > |e|/2C$. If tunnel resistance R_t is in the infinite range, the electrons tunneling across the barrier cannot take place. This implies that the constant current linearly increases charge Q with time. However, if R_t is finite, tunneling is allowed whenever the second condition is met. Thus, the total charge Q oscillates between approximately $-e/2$ and $e/2$ and so the voltage is between $-e/2C$ and $+e/2C$. This indicates that the voltage at the junction has the opposite polarity for half of the oscillation.⁵⁰ Consequently, the sawtooth oscillatory behaviour of the charge has an average time period $\Delta t = e/I$. This oscillatory characteristic denotes a single electron tunneling of $f_{\text{SET}} = 1/\Delta t = I/e$. The number of electrons that tunnel through the barrier can be determined using I/e . The solitary electron can only tunnel when the voltage across the junction is higher than $e/2C$. This condition lowers the voltage V of the source, which enables a tunnel current to flow. Thus, only for $|V| > |e|/2C$, the current I will be non-zero, but for smaller $|V|$, the current will be zero

(Fig. 4b). This is the Coulomb blockade of single electron tunneling.⁵¹

Here, the behaviour of a SET with respect to constant current and voltage source is discussed. A very high resistance is connected to a constant current to highlight the characteristics of a single junction (Fig. 4b). Moreover, the single junction is connected to a voltage source by replacing a constant current source and connecting a very low resistance $R \sim 0$ (Fig. 4b second). Consequently the voltage across the tunnel junction is fixed by the source with a constant charge at $Q = CV$. Since the voltage source securely fixes the charge on the tunnel capacitor, any charges that tunnel through the capacitor are promptly balanced by the voltage source. Thus transport through the junction is identified by its conductance, $G_t = 1/R_t$, for all applied voltages. Therefore connecting a low resistance to the source will mitigate the Coulomb blockade.⁵² Hence the charging effects are determined by the resistance or impedance of the environment from these two limiting cases of large and small resistance. Hence the SET requires a resistance of $R \sim 100$ k Ω or more; in addition, the capacitance of the resistor has to be much smaller than the junction. Otherwise it will increase the total capacitance of the system, which reduces charging effects. Also the size of the resistor should be made small, typically <1 μm . However designing a larger resistance with a small size is very complicated.

A tunnel junction connected in series with a capacitor C_g that has a gate voltage V_g applied to it, is used to calculate the energy of the system (Fig. 4b). To be more precise, the process focuses on figuring out the system's potential difference caused by the system's tunneling electron. This is the system's free energy, 'U', for electrons interacting with their surroundings.

The free energy of the system (U) is the combination of three terms (U_1 U_2 U_3) of contributions, among them two are natural electrostatic potentials and the other one is the electrochemical potential due to the work done by the voltage source.⁵³

U_1	U_2	U_3
The first potential energy term due to effective charging effects of the two series capacitance by the application of V_g (Fig. 4b). This condition occurs if no net charge is available in an island.	The addition or removal of electrons on the isolated island Q_N , which takes part in the second contribution	The third potential energy term is based on the charge of a capacitor, C_{N_g} , from the voltage source, V_g , when an electron tunnels through the system.
$U_1 = \int_0^{V_g} v dQ = \int_0^{V_g} C_s v dV$ $= \frac{C_s V_g^2}{2C_\Sigma}$ (4)	$U_2 = \frac{Q_N^2}{2C_\Sigma}$ (5)	$U_3 = Q_{N_g} V_g = \frac{C_g V_g}{C_\Sigma} Q_N$ (6)
where C_s is a series of capacitors, $C_s = C_g C_t / C_\Sigma$;	where Q_N is an isolated charge island; $Q_N = -Q_g + Q_t = N e $	where Q_{N_g} is the charge on a capacitor, C_g , upon the application of V_g .
C_g is the gate capacitance; C_Σ is total capacitance.		

Therefore the free energy calculated due to the charging effects of the tunneling event is provided based on eqn (4)–(6). Since the first term occurs when no net charge is available on an island, thus $U_1 = 0$.

$$U = \frac{(Q_N + C_g V_g)^2}{2C_\Sigma} - \frac{(C_g V_g)^2}{2C_\Sigma} \quad (7)$$

If the last term were excluded since this expression does not depend on Q_N , then the final expression for the free energy is

$$U = \frac{(N|e| + C_g V_g)^2}{2C_\Sigma} \quad (8)$$

The parabolic dependence is derived from eqn (8) and each parabola is linked to an integer “island filling number”, $N = -2-1012$ and so on (Fig. 4b). As long as the charge on the island remains constant, each parabola can be traced by adjusting the control voltage, V_g .

The impact of interface charges on SETs

The interface charge density often induces unwanted charges trapped at the interface between the conductor and the insulator. These trapped charges will lead to undesirable current flow even when the applied gate voltage is insufficient to overcome the Coulomb blockade conditions. This leakage current disrupts the single-electron charging process.⁵⁴ Traditionally silicon has been used in the production of SETs, which have the possibility of high interface charge density. But instead of the conventional way, one can use other nanomaterials for their fabrication. For example, materials such as high- k dielectric wide bandgap semiconductors and 2D nanomaterials can be used for fabricating SETs with minimum charge density at the interface between the semiconductor and insulator instead of the Si-SiO₂ model.⁵⁵ The lower interface charge density allows for the creation of well-defined and precisely controlled potential barriers. A cleaner interface with fewer background charges enhances the well-defined energy barrier for adding single electrons thereby strengthening the Coulomb blockade effect and leading to more precise control of the SET. For instance, Meirav fabricated a SET using GaAs as a lower interface charge density material. He realized that the distance separating these two well-defined barriers could be intentionally controlled during the fabrication process of the SET, which had significant implications. This finding paves the way for future research on the optimization of the SET fabrication process potentially leading to more efficient and precise devices. The schematic structure of a SET begins with GaAs material, which is a group III-V element (Fig. 5a). The heavily doped GaAs material is used as the top layer of the SET transistor (n^+ layer). Successively AlGaAs material is formed using the molecular beam epitaxy (MBE) method.⁵⁶ Techniques like molecular beam epitaxy (MBE) or atomic layer deposition (ALD) can create ultra-clean interfaces with minimal defects, which can significantly reduce the number of trapped charges.⁵⁷ Also AlGaAs has a wider band gap than GaAs and

hence it can be used as an insulator. Subsequently growth of another GaAs layer is required for where electrons will accumulate. The positive voltage supply of the n^+ substrate can regulate the electron density. Finally a metal electrode (gate) is placed on top after being etched using electron-beam lithography (EBL). If the metal gate is applied with a negative bias, the electrons in the gate are repelled from each other and within the channel beneath the gate into a narrower region. This type of SET made of GaAs will open many research directions. Electrons can flow through the narrow channel since the top metal gates create constrictions. The narrow channel strengthens the Coulomb blockade effect making it more difficult for individual electrons to pass through the channel. With a stronger Coulomb blockade even small changes in the gate voltage can significantly affect the flow of single electrons. This allows for more precise control over the SET's operation.⁵⁸ Thus low interface charge density is critical for achieving the single-electron charging phenomenon that underpins the operation of SETs. So by reducing these unwanted charges, more sensitive reliable and ultimately more powerful SET devices can be built.

SETs as charge sensors/charge detectors

A SET is a very sensitive charge sensor due to its unusual operation, which is based on the principles of quantum physics. The high sensitivity comes from the gate voltage-based Coulomb peaks because the gate electrode is capacitively coupled with the QD. In essence the current flow through the SET is drastically altered by a single extra charge close to the QD.⁶⁶ Thereby there is a shift in the Coulomb peaks with respect to the gate voltage, which is a measurable change in current (Fig. 5b). This high sensitivity allows researchers to detect tiny changes in charge making it a valuable tool for various applications such as QD characterization.⁶⁷

The sensitivity of the sensor is based on the tunneling event of a single charge, which results in a Coulomb peak shift, ΔV . But it is always advisable to measure change in current instead of change in voltage since ΔV depends on the charging energy of the sensor. Hence the sensitivity can be enhanced by a change in the increased current.⁶⁸ SETs are more sensitive to charge changes than any other existing charge sensors because their sensitivity depends on the amount of current flowing through them. Electrons move more easily than holes (higher mobility) leading to a higher current and a sharper response (steeper slope) in SETs when charge changes occur. There are two main methods for using SETs to sense charge: passive and active, which we will explore further.

Passive sensing. Passive sensing can be measured from the Coulomb peaks of the sensor but without any feedback mechanism upon addition or subtraction of charges from the target QD.⁶⁹ By monitoring the shift of Coulomb peaks, which directly corresponds to changes in charge, SETs provide a method for precise charge sensing (Fig. 5b). But since this mechanism depends on the position of the Coulomb peaks,

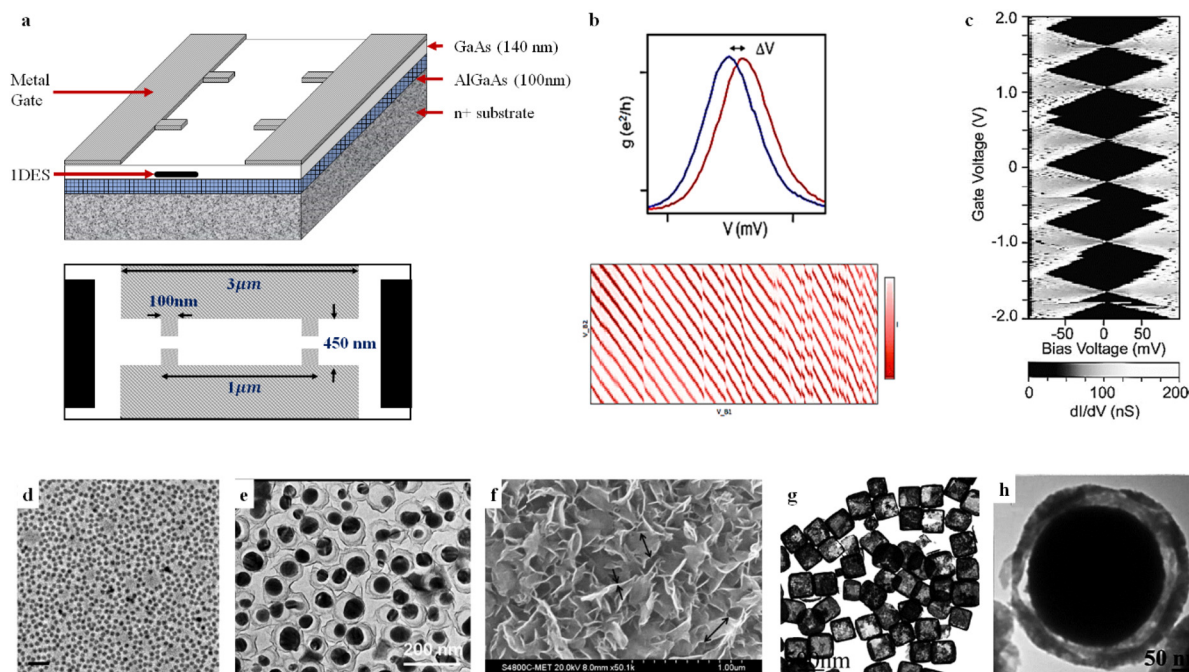


Fig. 5 a. Formation of a one-dimensional electron gas (1DES) formed on the top layer of the GaAs–AlGaAs interface and its respective top view (this figure has been reproduced from ref. 41 with permission from the American Physical Society copyright 2024). b. A single Coulomb peak before and after the addition of an electron due to the presence of another charge near the QD or charge trap near the QD sensor and its charging effects (this figure has been reproduced from ref. 59 with permission from Springer Nature copyright 2024). c. Grayscale plot of dI/dV displaying Coulomb diamonds with sudden variations as a result of the SET QD's background charge as V_g changes (this figure has been reproduced from ref. 60 with permission from AIP Publishing copyright 2024). d. TEM images of 0D nanoparticle quantum dots (this figure has been reproduced from ref. 61 with permission from Springer Nature copyright 2024). e. Nanoparticle arrays (this figure has been reproduced from ref. 62 with permission from Nanotechnology copyright 2024). f. Core–shell nanoparticles (this figure has been reproduced from ref. 63 with permission from Springer Nature copyright 2024). g. Hollow cubes (this figure has been reproduced from ref. 64 with permission from RSC Publication copyright 2024). h. Nanospheres (this figure has been reproduced from ref. 65 with permission from RSC Publication copyright 2024).

the change in current depends on the peak positions. If the change occurs near the peak, the resulting difference in current might be too small to be noticeable. Thus to overcome this issue, multiple peaks need to be measured.⁵⁹

Active sensing. While sensing through active sensing, the highest transconductance of the Coulomb peak is noted and the SET current has to be fixed with respect to that. Suppose the Coulomb peak shifted because of the charge sensing process, one can adjust the gate voltage so that the same SET current can be measured. Again the system is reinitialised by setting the same current to the respective peak position using a feedback mechanism. Active sensing with Coulomb peaks allows us to detect electron tunneling events across a wider range of voltage adjustments compared to traditional methods like direct measurement or passive sensing.⁶⁹

When the SET is functioning as a charge sensor, we are searching for variations in the amount of electrons on its QD. External variables such as photon absorption or the presence of neighbouring charges can induce these changes. The charge stability diagram may contain important information about the QD's distinctness from other QDs. By analysing the behaviour of the charge stability diagram or Coulomb diamond, one can predict charge detection (Fig. 5c). Some of the locations in this Coulomb diamond are crooked and

change in style. The electrostatic environment around the SET is changed by the presence of an extra charge, which affects the energy levels needed to add or remove electrons from the QD. This translates into a shift in the entire Coulomb diamond pattern. The external charge's type and position determine the shift's precise direction and size. Researchers may track the location of the Coulomb diamonds by continuously observing the I – V properties of the SET. The diamond pattern functions as a way to read the SET's charge status; any sudden changes in it indicate a change in the quantity of electrons on the QD.

Nanomaterials in SETs

In a SET a QD plays a crucial role in controlling the flow of current with incredible precision at the level of single electrons. The QDs are zero-dimensional (0D) materials existing as isolated entities on the atomic or molecular scale with a diameter of less than 10 nm and offer unique properties with vast potential for future technologies. Among their main benefits are their high quantum yield, low toxicity, and improved electrical and optical performance in 0D nanomaterials. However their minuscule size presents a significant challenge during fabrication. Traditional manufacturing techniques could be better suited for manipulating objects at the atomic level.

In this article, recent nanofabrication technology has been explored in a later session.⁷⁰ The field of 0D nanostructured materials has advanced significantly over the last ten years and numerous physical and chemical techniques for creating these structures have been discovered. QD nanoparticles and nanospheres are just a few examples of the nanomaterials that fall under this category. We have included some electron microscope images of these nanostructures (Fig. 5d–h), which are crucial for understanding their structure and properties.

The material properties are crucial in the design performance and potential of SETs. They influence quantum confinement tunneling characteristics, carrier mobility scalability and room-temperature operation. Traditionally researchers have used conventional materials like silicon and germanium for QD fabrication. However the future of SETs lies in the exploration of novel nanomaterials such as II–VI semiconductors (CdSe), III–V semiconductors (GaAs), carbon-based materials (carbon nanotubes, graphene), transition metal dichalcogenides (MoS₂, WS₂), and the perovskite QDs. These materials offer high tunability and are compatible with existing fabrication techniques promising a bright future for the field.^{71,72}

Earlier QDs were made using metals such as aluminum,³⁷ gold⁷³ and so on. However the quantum confinement of a metal does not lead to discrete energy levels as in semiconductors since a metal consists of continuous energy levels due to a different electronic structure from that of semiconductors. Thus in addition to the metallic precursor, the chalcogen precursor is also required for effective QD synthesis. Therefore to enhance their stability, some applications have involved the use of Al₂O₃-coated QDs instead of purely metallic Al.⁷⁴ Similarly the electronic structure of the gold particle does not exhibit the same electrical properties as in the semiconductor. Hence the core–shell structure has been utilized for good size control by coating the Au layer with another thin layer of silica or polymer.⁷⁵ The tuneable plasmon resonance remains a valuable tool in manipulating Au nanoparticles to alter their size, shape and composition to achieve desired light absorption or scattering characteristics. This leads to applications in sensing, photocatalysis and solar energy conversion. Another commonly used QD is based on cadmium, which is composed of a cadmium (Cd) metal element and a chalcogen (oxygen sulfur selenium) element.⁷⁶ The common ligand and solvent for cadmium is trioctylphosphine (TOP) and hexane or octane; also the common reducing agent is sodium borohydride. Ligands are molecules that bind to the surface of the QD after its formation and the ligands selected can influence the final size distribution of the QDs, indirectly affecting the degree of quantum confinement. The solvent plays a critical role in dissolving the precursors that lead to QD formation. Choosing the right solvent with suitable polarity and reactivity is also essential for successful synthesis. The reducing agent plays a vital role in the synthesis by controlling the reduction of precursor ions into the desired QD material. By varying the reducing agent's strength and the reaction conditions, researchers can influence the growth rate of QDs. As cadmium is a toxic heavy metal and unstable to the exposure of air and

light, researchers are exploring alternative materials but with similar properties to those of cadmium.⁷⁷

The lead QD can be formed by using a metal (Pb) with a chalcogen material (sulfur selenium). The Pb QD realizes quantum confinement while the size is reduced to below 10 nm.⁷⁸ But similar to cadmium, Pb is also a toxic heavy metal, so researchers are exploring alternative materials but with similar properties to those of Pb. The common ligand and solvent for Pb are oleic acid and toluene; also the common reducing agent is sodium borohydride. The PbS/PbSe QDs are used in infrared detectors.⁷⁹ Unlike their lead and cadmium counterparts, Zn QDs offer a compelling combination of desirable properties and environmental friendliness making them a sustainable choice for various applications.⁸⁰ Zinc QDs can be made by the combination of zinc with oxygen (ZnO) and when the size of the Zn QD is reduced to 10 nm, quantum confinement is achieved, which leads to discrete energy levels and tuneable properties. The tuneable properties of Zn QDs can be used for bio-imaging and their eco-friendly nature opens doors for applications in biological fields. The common ligand and solvent for Zn are dodecylamine and hexane; also the common reducing agent is sodium borohydride. Due to the tunable and quantum confinement properties of Zn QDs, they are employed in displays and sensors.⁸¹ Copper indium sulfide (CIS) is a fascinating alternative to traditional semiconductor QDs particularly those containing toxic elements like cadmium or lead.⁸² CIS QDs are ternary compounds composed of copper (Cu), indium (In) and sulfur (S) and exhibit a unique crystal structure and electronic bandgap, making them distinct from both purely copper and purely indium-based QDs. The unique properties of CIS QDs such as tunable bandgap and lower toxicity can be used in bio-imaging and solar cells. The solvent and reducing agent for Zn are polar solvents and sodium borohydride. CNT QDs show promise for creating highly sensitive SETs due to their ability to confine electrons and exhibit a Coulomb blockade. However CNT QDs have a one-dimensional tubular structure based on rolled-up graphene. Hence CNT QDs can inherit some of the unique electronic characteristics of nanotubes like their chiral nature.⁸³ Researchers have investigated graphene-based SETs for their charge-sensing capabilities due to their remarkable electrical properties.⁸⁴ Beyond graphene, other 2D materials like transition metal dichalcogenides (TMDCs)⁸⁵ and black phosphorus (BP)⁸⁶ have been explored. TMDCs such as MoS₂ and WSe₂ exhibit strong quantum confinement effects and could be integrated into SETs.^{87–89} However fabricating stable and reproducible nanostructures remains a challenge. Besides this, achieving room temperature operation and scalability is crucial. Room-temperature operation can be realized when low-inherent thermal noise materials such as silicon carbide (SiC)^{90,91} and gallium nitride (GaN)^{92,93} are used. These materials can improve the signal-to-noise ratio and make single-electron effects more observable at room temperature. The perovskite quantum dots (PQDs) are a new and exciting class of nanomaterials with immense potential in optoelectronics and other fields. PQDs are based on the perovskite

crystal structure, which is similar to that of the mineral calcium titanium oxide (CaTiO_3).⁹⁴ However unlike the mineral, PQDs are engineered at the nanoscale (typically less than 10 nm) using various metal cations (positively charged ions) and a halide anion (negatively charged ion). The most commonly used metal ions are lead (Pb) and cesium (Cs) and halide ions are chloride (Cl), bromide (Br) and iodide (I). Similar to other QDs, PQDs exhibit quantum confinement effects when their size shrinks to the nanoscale, which leads to discrete energy levels and tunable optoelectronic properties. PQD applications are found in LED displays, lasers and bio-imaging.⁹⁵

The two main techniques utilized to create nanoparticles are top-down and bottom-up approaches. Several physical and chemical techniques are used in these procedures to create 0D nanoparticles for SETs. The top-down process starts with a 3D material in bulk form and slices it into nanomaterial sized particles using techniques including milling, lithography and mechanical deterioration. The bottom-up process is a complex and intriguing process requiring a multitude of physical methods. These include the inert gas phase condensation technique, a lithography process, spray pyrolysis, the sputtering technique, hot and cold plasma pulsed laser ablation, and sonochemical reduction. Compared to top-down techniques, bottom-up procedures have the advantage of producing nanostructures with fewer imperfections and a chemical composition that is not just uniform but also of superior quality and reliability.⁹⁶

By exploring alternative nanomaterials for SETs, researchers are pushing the boundaries of charge sensing technology. Addressing the specific challenges associated with each material and optimizing their properties are key areas of focus. As this research continues, we can expect future SETs based on novel nanomaterials to revolutionize various fields requiring ultra-sensitive charge detection from biomolecular diagnostics to quantum computing.

Fabrication methods

Quantum dot formation

Quantum dots are tiny semiconductor particles with diameters ranging from 2 to 10 nm.⁹⁷ The unique optical and electronic properties of quantum dots arise from quantum confinement where electrons and holes are confined in all three dimensions. This confinement leads to discrete energy levels similar to atoms, resulting in size-dependent optical and electronic properties. Factors affecting the quantum dot properties are the choice of semiconductor material and the size of the QD, which directly influences its bandgap.⁹⁸ The quantum dot has been synthesised by top-down and bottom-up approaches.

Top-down approach. Top-down approaches involve breaking down larger materials into smaller quantum dots. While not as prevalent as bottom-up methods for quantum dot synthesis, certain techniques can be employed such as mechanical exfoliation, liquid exfoliation, ion-intercalation exfoliation, electrochemical exfoliation, laser ablation and cryo-mediated exfoliation (Fig. 6a).

Mechanical exfoliation. Mechanical exfoliation involves physically breaking down the bulk materials into nanoscale fragments. Mostly this method is applied to graphene for achieving a single-layer material. But it can be applicable to 2D materials like TMDCs such as MoS_2 , WS_2 and other layered materials. There are many mechanical exfoliation methods, such as Scotch tape, ball milling and grinding assisted methods. The Scotch tape method is a classic way of exfoliating layers from the bulk graphene material.⁹⁹ This method involves repeatedly peeling layers off a bulk crystal using adhesive tape, gradually thinning the material. However the Scotch tape method is less practical for large-scale QD production (Fig. 6c). It can however produce very high-quality QDs. The ball milling technique uses mechanical grinding to break down the bulk material. The material is placed in a container with grinding objects such as balls and subjected to vigorous shaking or rotation.

The impact and friction forces break the material down into nanoscale fragments. The grinding-assisted exfoliation method combines grinding with liquid phase exfoliation. The bulk material is ground in a liquid solvent and then sonication is used to further exfoliate the material into QDs. With this method, also achieving uniform QD size and distribution can be challenging. Techniques like centrifugation can be used to separate QDs of different sizes. Mechanical forces can introduce defects into the QDs. Careful control of the exfoliation process is necessary to minimize defects.

Liquid exfoliation. Liquid exfoliation is especially suitable for layered materials such as 2D materials like transition metal dichalcogenides (TMDCs) and graphene. Also this method is a relatively simple and scalable approach compared to other complex techniques. The starting material for liquid exfoliation is bulk layered materials such as MoS_2 , WS_2 and graphene. The layers are weakly attached to each other with weak van der Waals forces. If the shear forces applied to the bulk material can overcome the van der Waals forces between each layer, the layers are separated and turned into individual or few-layer nanosheets. The liquid environment helps to stabilize the exfoliated nanosheets and prevent them from re-aggregating. The process begins with the bulk material dispersed in a suitable solvent such as *N*-methyl-2-pyrrolidone (NMP) or isopropyl alcohol (IPA) with water. The shear forces are applied to the dispersion for separating layers through ultra-sonication or probe sonication. After exfoliation, the dispersion is centrifuged to separate the exfoliated nanosheets from the unexfoliated bulk material. The centrifugation speed is adjusted to select nanosheets of a specific size. Prolonged sonication can break the nanosheets into smaller QDs (Fig. 6b). Thermal annealing and pressure in a liquid environment can also cut the sheets and synthesise the QD.

The features of liquid exfoliation enable a large quantity of QDs to be produced but with various sizes of QDs. Therefore size control can be challenging and it will lead to a broad size

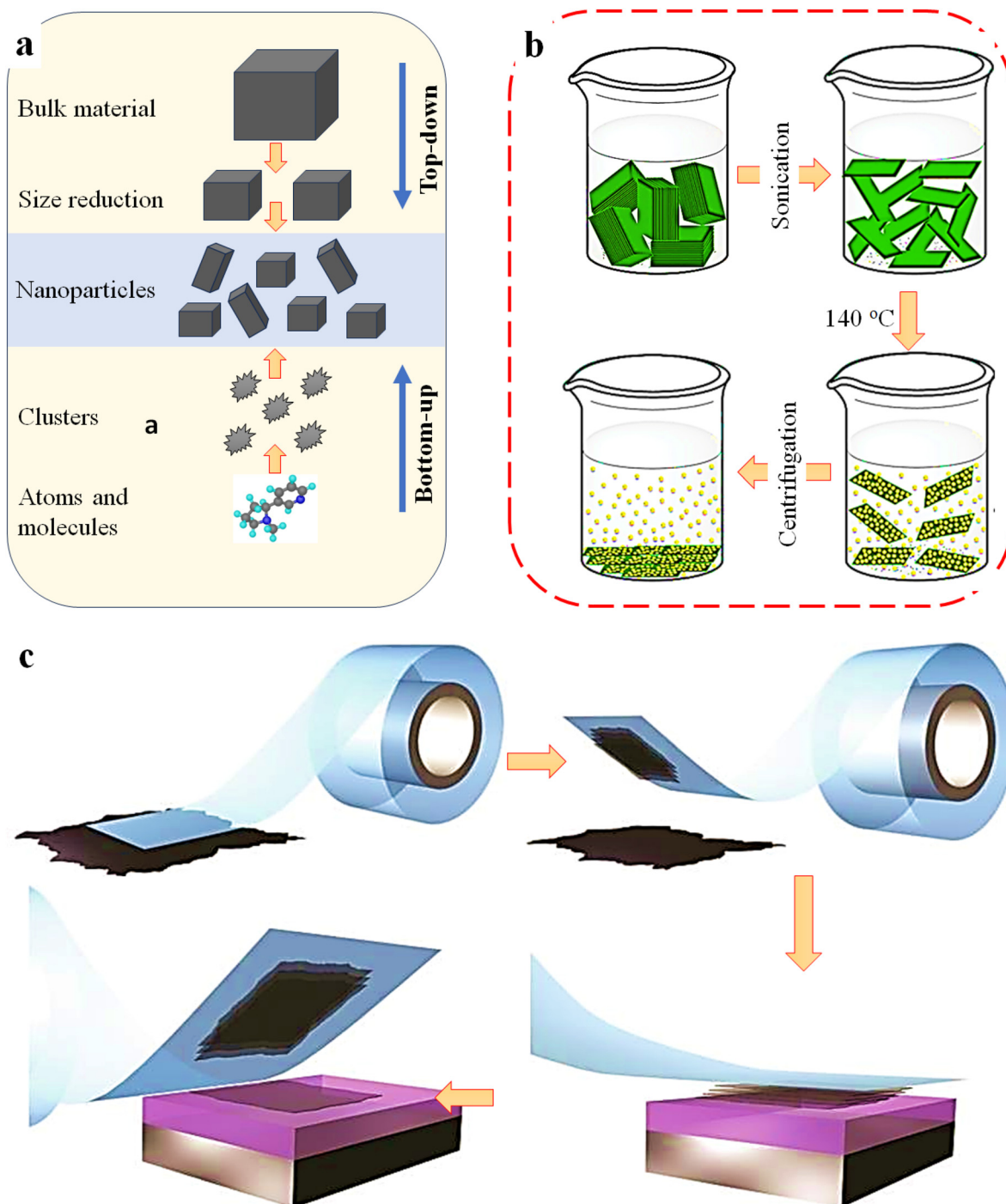


Fig. 6 a. Top-down process. b. Liquid exfoliation–ultrasonication (this figure has been reproduced from ref. 100 with permission from John Wiley and Sons copyright 2024). c. Mechanical exfoliation – Scotch tape assisted method (this figure has been reproduced from ref. 99 with permission from Taylor and Francis copyright 2024).

distribution. But this method is relatively simple and suitable for a wide range of layered materials. The QDs are produced in a liquid environment, making them easy to integrate into various applications. Simultaneously this method can introduce defects into the QDs. Also the choice of solvent can affect the properties of the QDs.

Ion intercalation. This is a less common approach for producing QDs from layered materials. It leverages the ability of ions to insert themselves between the layers of these materials, leading to their expansion and eventual exfoliation into QDs. The process involves introducing ions (typically alkali metal ions) into the spaces between the layers of a layered

material.¹⁰¹ The layered material is exposed to a solution or vapor containing the ions. The ions diffuse into the spaces between the layers, causing them to expand and weakening the van der Waals forces that hold them together. The weakened layers can then be exfoliated or fragmented into QDs using further processing (Fig. 7a). Chemical processes or electrochemical techniques can boost this process. The resultant QDs are next refined to eliminate any unreacted components and side effects. Usually this comprises washing procedures and centrifugation. More regulated exfoliation is offered by the ion-intercalation technique than by just mechanical ones. Moreover ion intercalation can influence the properties of the QDs by inducing chemical modifications in them. Chemical interactions involved in the intercalation process could cause flaws or change the QD composition. Eliminating the intercalated ions can prove difficult. The technique might be more complicated than basic mechanical exfoliation.

Electro-chemical method. Quantum dots (QDs) can be created in a variety of ways using electrochemical techniques. It is a most appropriate method for producing metallic and semiconducting QDs. Electrochemical synthesis involves using an electrochemical cell to control the formation of QDs. The electrochemical cell consists of electrodes, an electrolyte and a current source. There are three electrodes, namely, the working electrode, the counter electrode and the reference electrode.¹⁰³ The QD forms at the working electrode and the reference electrode provides a stable potential reference. The electrolyte solution contains the precursor ions, such as metal salts, and ligands that stabilize the growing QDs. A potentiostat or galvanostat is used to apply a controlled potential or current to the electrochemical cell.

The QD can form using the electrochemical reduction method and it is a general technique. Reducing metal ions in the electrolyte solution at the working electrode produces metal atoms. These atoms then nucleate and grow into QDs. Another electro-chemical method is anodic dissolution, which consists of a working electrode that can act as the source of the QD material. By applying a potential, the electrode material is dissolved in the electrolyte solution as ions. These ions then react to form QDs (Fig. 7b). Then an electrodeposition approach is used for depositing QDs onto a conductive substrate. The QDs are formed at the electrode surface and adhere to it. This enables the creation of QD films or coatings. With this method, control of film thickness is good.

This approach provides precise control over the QD size, shape and composition, so it can be used to synthesize a wide range of QDs. Also it can be scaled up for larger scale production. Significantly it allows for direct deposition on substrates that are used for device fabrication. But impurities in the electrolyte can affect the QD quality. Moreover the choice of electrode material can limit the types of QDs that can be synthesized. Also it needs a complex setup, which consists of an electrochemical cell and control equipment.

Laser ablation. Laser ablation involves using a high-intensity laser beam to vaporize a target material. A solid target made of

the desired QD material (*e.g.* metals, semiconductors) is used. A pulsed laser is typically used, such as a Nd:YAG laser or an excimer laser. The high-intensity laser pulse vaporizes the target material, creating a plume of atoms, ions and clusters. The vaporized material then cools and condenses, forming nanoparticles. Condensation can occur under vacuum, resulting in dry nanoparticles. If condensation occurs in a liquid environment, it results in colloidal QDs.¹⁰⁴ The QDs are then collected from the surrounding environment. In liquid ablation, the QDs are collected as a colloidal solution (Fig. 8a). There are certain parameters that need to be controlled for good quality QDs. The ablation efficiency and the characteristics of the QDs may change with changing the laser wavelength. The laser pulse energy regulates the QD size and the material ablation dosage. Furthermore, the laser pulse duration affects the ablation process and QD morphology. The production rate of QDs is determined by the repetition frequency. It can also synthesise a wide range of QDs, including metals, semiconductors and composites. Changing the laser parameters helps one to control the size and characteristics of the QDs.

Cryo-mediated exfoliation. Cryo-mediated exfoliation is a method that utilizes the brittleness of layered materials at cryogenic temperatures to increase the yield of quantum dots (QDs) and enhance the exfoliation process. At cryogenic temperatures (very low temperatures typically using liquid nitrogen or even lower), layered materials become significantly more brittle. While van der Waals forces are still present, the increased brittleness makes it easier to overcome them. The combined effect of increased brittleness and easier interlayer separation leads to more efficient exfoliation. While the material is at cryogenic temperatures, mechanical forces such as grinding/milling, ultrasonication and cryo-cleaving are applied to exfoliate it (Fig. 8b). After exfoliation, the material is allowed to warm up. The exfoliated QDs are then dispersed in a suitable solvent. It is very important to use a solvent that will stabilize the QDs.¹⁰⁵ The resulting QD dispersion may contain a range of sizes. Techniques like centrifugation can be used to separate QDs of different sizes. The advantage of using this method is that increased brittleness at cryogenic temperatures leads to more efficient exfoliation. Cryo-mediated exfoliation can result in a higher yield of QDs. It can handle some materials that are hard to exfoliate at room temperature. But it has increased complexity, as it requires cryogenic equipment and handling.

Exfoliation as a potential technique for two-dimensional material production has numerous drawbacks when used in quantum dot synthesis (Table 2). It is challenging to create the desired-dimension quantum-sized particles, as it requires breaking down the bulk material into tiny flakes. The process often results in a wide range of particle sizes, including larger flakes that are unsuitable for quantum dot applications. Usually exfoliation results in a low concentration of quantum dots in the finished product, highlighting the crucial need for further concentration and purification processes. The optical and electrical properties of quantum dots can be affected by

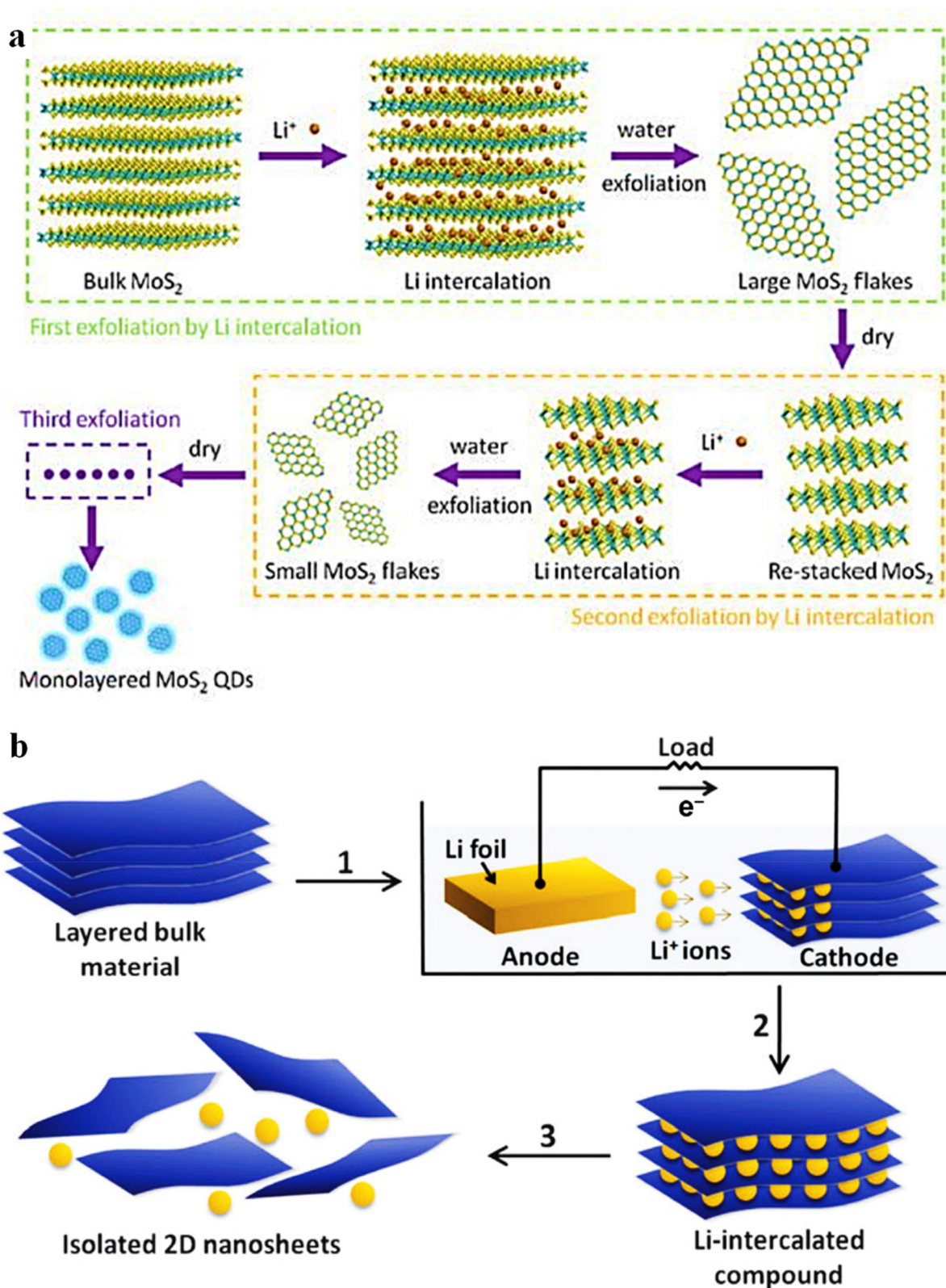


Fig. 7 a. Ion intercalation (this figure has been reproduced from ref. 101 with permission from Elsevier copyright 2024). b. Electrochemical exfoliation (this figure has been reproduced from ref. 102 with permission from Royal Society of Chemistry copyright 2024).

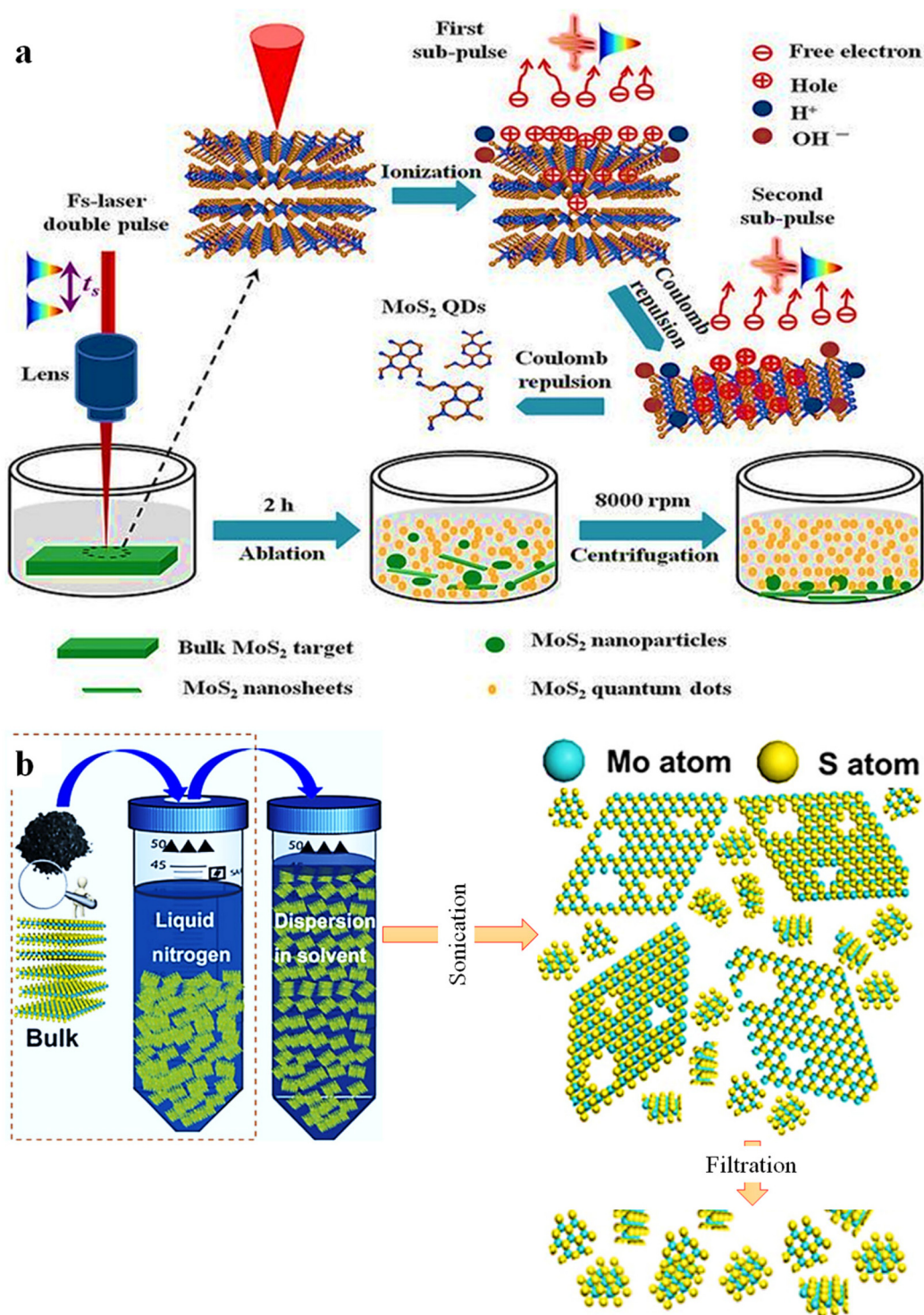


Fig. 8 a. Laser ablation (this figure has been reproduced from ref. 104 with permission from Springer Nature copyright 2024). b. Cryo-mediated exfoliation (this figure has been reproduced from ref. 105 with permission from The American Association for the Advancement of Science copyright 2024).

flaws introduced into the structure due to the involvement of mechanical forces in exfoliation. Also most importantly, exfoliation is primarily effective for layered materials with weak interlayer interactions. Its application to other materials for

the creation of quantum dots is restricted.¹⁰⁶ Specific exfoliating techniques employ harsh chemicals or surfactants, which may have an adverse effect on the environment. Although exfoliation is a valuable method for creating two-dimensional

Table 2 Top-down techniques reported in the literature for preparing QDs

Methods	Procedure	Size	Transfer method	Advantages	Issues
Mechanical exfoliation ⁹⁹	Scotch tape assisted method	>100 μm	Wet transfer/dry transfer	<ul style="list-style-type: none"> • Easy to perform • Low cost 	<ul style="list-style-type: none"> • Time consuming • Low-quality QDs • Introduced contamination to the sample • Generation of irregular shape & size • Not suitable for large-scale production • Low yield
Liquid exfoliation ¹⁰⁰	Ultrasonication + centrifugation	~ 5 nm	Spin coating/drop casting	<ul style="list-style-type: none"> • Enable larger-scale production than mechanical exfoliation • Produce high-quality flakes 	<ul style="list-style-type: none"> • Suitable solvent selection is challenging • Accurate characterization is complex • Transferring exfoliated flakes onto substrates is challenging • Exfoliated flakes tend to restack
Ion-intercalation exfoliation ¹⁰¹	Ion-intercalation + sonication + centrifugation	~ 4 nm	Dielectrophoretic/vacuum filtration	<ul style="list-style-type: none"> • Increase inter-layer spacing, which eases the exfoliation process • Control over flake thickness 	<ul style="list-style-type: none"> • Environmental impact • Achieving high yield of pure & single layer flakes can be challenging
Electro-chemical exfoliation ¹⁰³	Suitable electrolyte selection + intercalation + sonication	2–3 nm	Spin coating/drop casting	<ul style="list-style-type: none"> • Control over size and shape • Produce high purity QDs • Less harmful to the environment 	<ul style="list-style-type: none"> • Achieving consistent QD properties can be challenging due to factors like electrolyte purity and electrode material
Laser ablation ¹⁰⁴	Ablation + centrifugation	~ 2.6 nm	Spin coating/drop casting	<ul style="list-style-type: none"> • High purity QDs • Control over size & shape 	<ul style="list-style-type: none"> • Low yield • Equipment is expensive • Safety concerns
Cryo-mediated exfoliation ¹⁰⁵	Cryo-mediated exfoliation (liquid nitrogen) + sonication + centrifugation	~ 2.5 nm	Spin coating/dielectrophoretic	<ul style="list-style-type: none"> • High quality flakes • Improved exfoliation efficiency • Control over flake thickness 	<ul style="list-style-type: none"> • Complex and expensive • Low throughput • Safety concerns • Restacking

materials, its extensive use in quantum dot synthesis is hampered by its limitations in size control, yield, defect development, material compatibility and environmental impact.¹⁰⁷

The bottom-up approach for the preparation of quantum dots involves atom-by-atom deposition of ions to produce nanoparticles of a specific element. Prominent techniques among the bottom-up exfoliation methods include sol-gel, atomic layer deposition (ALD), hydrothermal synthesis and chemical vapor deposition (CVD). The bottom-up approach offers precise control over the QD's properties. Also this method has the potential for large-scale production and compatibility with various materials (Fig. 9).

Sol-gel method. The sol-gel method is a chemical process used to synthesize quantum dots (QDs), particularly metal oxide QDs. This technique has good control over the size and composition of the QDs. The sol-gel method involves the transition of a "sol" to a "gel". The "sol" refers to a colloidal suspension of solid particles in a liquid and "gel" refers to a solid network containing a liquid phase. This transition is achieved through hydrolysis and condensation reactions of metal alkoxides or other precursors. The resulting gel is then processed to form QDs.¹⁰⁸ The precursors for the sol-gel mostly involve

metal alkoxides (*e.g.* tetraethyl orthosilicate (TEOS), titanium isopropoxide) or metal salts dissolved in a solvent (*e.g.* ethanol, water). The choice of precursor and solvent depends on the desired QD material.

Bottom-up approach. Water should be added to the precursor solution to start the hydrolysis process. Hydrolysis involves the replacement of alkoxy groups (–OR) in the metal alkoxide with hydroxyl groups (–OH). This step is often catalyzed by acids or bases (Fig. 9a). The hydroxyl groups formed during hydrolysis react with each other, releasing water or alcohol molecules. This condensation reaction leads to the formation of metal–oxygen–metal (M–O–M) bonds, creating a network of interconnected particles that acts as a "sol". As the condensation reactions proceed, the sol becomes more viscous and eventually forms a semi-solid gel. The gel is a three-dimensional network. The gel is often aged to allow further condensation reactions to occur and strengthen the network. The gel is dried to remove the solvent and water. The resulting QDs are then dispersed in a suitable solvent. Surface ligands can be added to the solvent to improve dispersion and stability. The morphology and crystal size of the QDs can be controlled by varying the precursor concentration, pH, temperature and

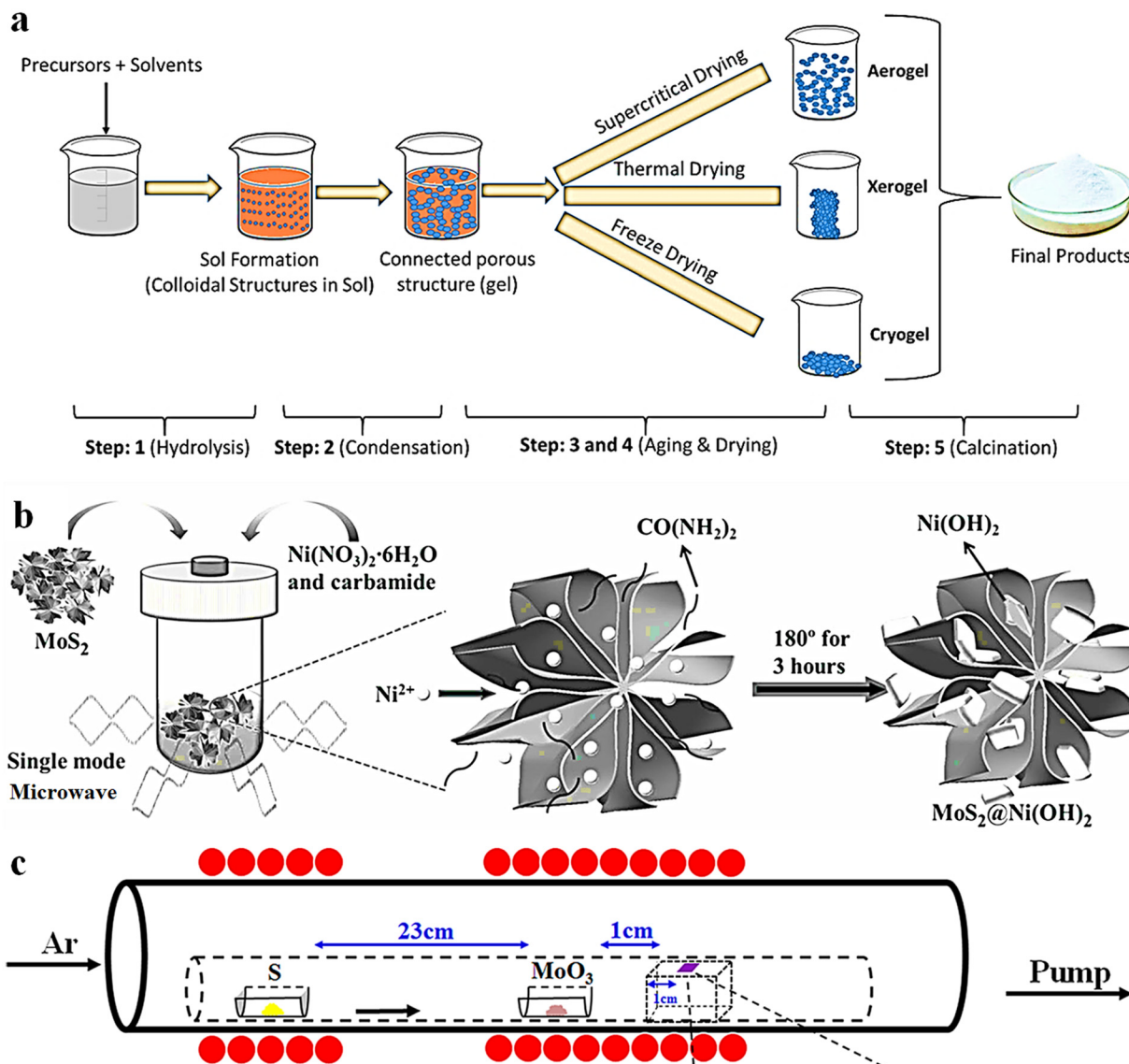


Fig. 9 a. Sol-gel technique (this figure has been reproduced from ref. 108 with permission from Springer Nature copyright 2024). b. Hydrothermal process (this figure has been reproduced from ref. 109 with permission from John Wiley and Sons copyright 2024). c. CVD method (this figure has been reproduced from ref. 110 with permission from American Chemical Society copyright 2024).

drying conditions. Thus this method enables good control over the QD size and composition. And it can produce homogeneous QDs. Also, it is relatively inexpensive compared to other methods. But drying the gel can lead to cracking and shrinkage. At the same time, the sol-gel process can be time-consuming since hydrolysis and condensation are slow reactions. Moreover, achieving a very narrow size distribution can be difficult.

Hydrothermal process. The hydrothermal process is a relatively simple method for producing QDs, particularly metal oxide and chalcogenide QDs. It involves conducting chemical reactions in a sealed vessel (autoclave) under high temperature and pressure in an aqueous solution. The precursors for this method involve any metal salts or metal oxides dissolved in water and other reactants, such as reducing agents or sulfur

sources (for chalcogenide QDs), may be added. Ligands can also be added to control the size and stability of the QDs. The precursor solution is transferred to a sealed autoclave, which is a pressure-resistant vessel (Fig. 9b). The autoclave is sealed to prevent the escape of vapors and maintain the high pressure. The autoclave is heated in an oven, typically in the range of 100–300 °C but can be higher for some materials.¹⁰⁹ The reaction is allowed to proceed for a specific period of time, which can range from a few hours to several days. By controlling the reaction parameters, the nucleation and growth of QDs can be precisely managed. The reaction time influences the size and crystallinity of the QDs. After the reaction is complete, the autoclave is cooled to room temperature. The resulting QDs are collected from the solution by centrifugation or filtration. They are then washed with water and other solvents to

remove any unreacted precursors and byproducts. The purified QDs are dried in an oven or vacuum oven.

This method has a relatively simple setup and operation. Also, it requires relatively inexpensive equipment. And it produces highly crystalline QDs. It uses water as a solvent, minimizing the use of toxic chemicals. It gives good control over the QD size and morphology. It can be used to synthesize a wide range of QDs, but reactions can take several hours or days. In addition to that it requires careful handling of high-pressure vessels. Achieving a narrow size distribution can be challenging.

Chemical vapour deposition (CVD). Chemical vapour deposition is a technique used to produce semiconducting QDs by depositing materials from a vapor phase onto a substrate. CVD involves introducing gaseous precursors into a reaction chamber where they react and decompose at elevated temperatures. The gaseous precursors that contain the elements needed to form the QDs are introduced into the reaction chamber. Carrier gases such as nitrogen or argon are used to transport the precursors. The reaction chamber is a controlled environment where the precursors react and decompose. The chamber is typically heated to a high temperature to facilitate the reactions (Fig. 9c). The reaction products deposit onto a heated substrate, forming a thin film or nanostructures including QDs.¹¹⁰ By controlling the reaction parameters, the size, composition and morphology of the QDs can be precisely managed. This method involves vapor-liquid-solid growth, Stranski-Krastanov growth, and aerosol CVD to form QDs.

Vapour-liquid-solid growth uses metal catalyst nanoparticles to initiate and control the growth of nanowires or QDs. SK growth exploits lattice mismatch between the deposited material and the substrate to form self-assembled QDs. The aerosol gel creates nanoparticles in the gas phase and then deposits them onto the substrate. Tuning the precursor flow rate, substrate, temperature, reaction chamber pressure and carrier gas flow rate influences the nucleation and growth of QDs. There are many CVD types based on specific requirements and applications. Thermal CVD is used to initiate the chemical reactions. Plasma-enhanced CVD (PECVD) uses plasma to enhance the reactions, allowing for lower deposition temperatures. Metal-organic CVD (MOCVD) uses metal-organic precursors. Likewise, aerosolized precursor materials are used in aerosol CVD for thin film deposition. This type of synthesis process can produce uniform QDs and nanostructures. And it supports large-scale production. However it often requires high temperatures, which can limit the choice of substrates. Also it requires specialized equipment and control systems.

Atomic layer deposition (ALD). Atomic layer deposition (ALD) provides a robust method for fabricating quantum dots (QDs) on substrates, offering unparalleled control over size, composition and uniformity at the atomic scale. Although ALD does not yield free-standing QDs in solution, its precision in substrate-based QD synthesis is a significant advantage. ALD relies on sequential self-limiting surface reactions. Precursor gases are introduced into the reaction chamber one at a time

separated by purging steps. A volatile first precursor gas is introduced into the reaction chamber. The precursor reacts with the substrate surface forming a monolayer. A second precursor gas is introduced. This precursor reacts with the modified surface completing the atomic layer.¹¹¹ Each precursor reacts with the substrate surface in a self-limiting manner, depositing a single atomic layer or a fraction of an atomic layer. The cycle of precursor introduction and purging is repeated until the desired thickness or QD size is achieved (Fig. 10a).

The QD formation mechanism consists of nucleation and growth on a substrate. By carefully controlling the ALD process, nucleation sites can be promoted, leading to the formation of QDs on the substrate surface. Then layer-by-layer growth and patterning are involved. ALD can be used to deposit thin films with precise thickness control. By combining ALD with lithographic patterning, QDs of defined size and location can be created. ALD can be used to coat pre-existing nanoparticles, create core-shell QDs or modify the surface properties of QDs. Varying the precursor selection, pulse time and substrate temperature determines the thickness or size of the QDs. It leads to precise control over QD size and composition. And it produces highly uniform films and nanostructures. Also it can produce high-purity QDs. However ALD is a relatively slow deposition technique and it requires specialized equipment and control systems.

Colloidal method. Colloidal synthesis is a widely used and versatile method for producing quantum dots (QDs) particularly for semiconductor QDs. Colloidal synthesis involves the controlled growth of nanocrystals (QDs) within a liquid solution. The process relies on carefully controlling the chemical reactions and growth kinetics to achieve QDs with desired size, shape and composition. Ligands play a crucial role in stabilizing the QDs and preventing aggregation. The key components of colloidal synthesis are precursors, solvents, ligands and surfactants (Fig. 10b). The precursors are the starting materials that provide the elements needed to form the QDs.¹¹² They are typically metal salts or organometallic compounds. The solvent provides a liquid medium for the reaction to occur. It must be compatible with the precursors and ligands. The ligands are molecules that bind to the surface of the growing QDs, preventing them from aggregating and controlling their growth. They also help to solubilize the QDs in the solvent. The surfactants are similar to ligands and also help with surface control. The precursors are prepared by dissolving the precursor materials in a suitable solvent. The concentration of the precursors is carefully controlled to influence the nucleation and growth rates.

Nucleation is the initial step where the precursor molecules combine to form tiny “seeds” or nuclei. This is often achieved by rapidly injecting the precursor solution into a hot solvent containing ligands (“hot injection”). Rapid injection creates a supersaturated solution, leading to a burst of nucleation and a narrow size distribution of the seeds. After nucleation, the seeds grow by the addition of more precursor molecules from the solution. The growth rate is controlled by adjusting the

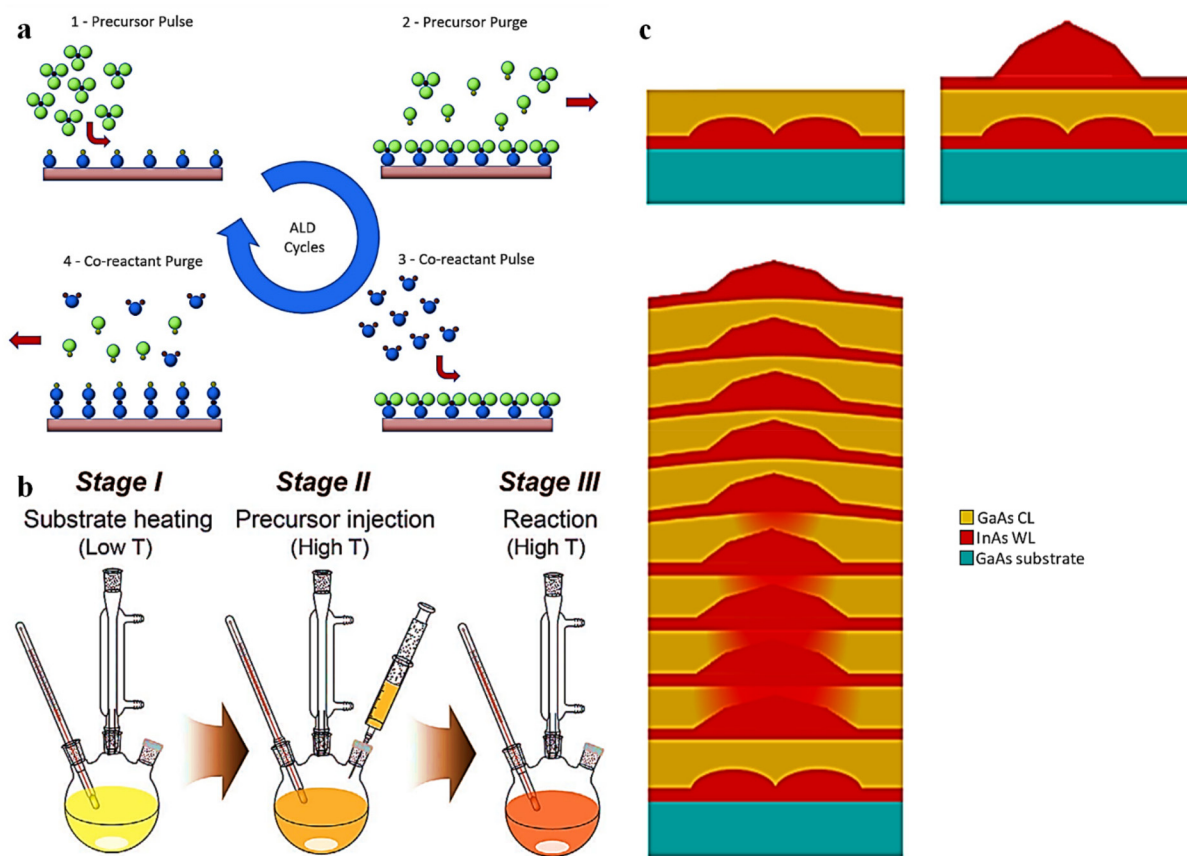


Fig. 10 a. Atomic layer deposition process.¹¹¹ b. Colloidal method (hot-injection) (this figure has been reproduced from ref. 112 with permission from John Wiley and Sons copyright 2024). c. Molecular beam epitaxy method (this figure has been reproduced from ref. 113 with permission from Elsevier copyright 2024).

temperature, precursor concentration and reaction time. Ligands play a crucial role in controlling growth, ensuring that the QDs grow to the desired size and shape. After growth, the QDs are purified to remove unreacted precursors, byproducts and excess ligands. This typically involves precipitation, centrifugation and redispersion in a suitable solvent. The operating temperature, precursor concentration, reaction time, ligands and solvents influence the growth rate, surface properties and stability of the QDs. It can be used to produce large quantities of QDs. Also it allows for easy integration of QDs into various devices and applications. However the colloidal QDs can have surface defects that affect their optical and electronic properties. Sometimes ligands can be difficult to remove or exchange, which can limit certain applications.

Molecular beam epitaxy (MBE). MBE is a technique that allows for the epitaxial growth of thin films with atomic layer precision. Epitaxial means a crystalline layer is grown on a crystalline substrate. It requires an ultra-high vacuum environment in which beams of atoms or molecules are directed onto a heated substrate. By controlling the flux of these beams and the substrate temperature, the growth of crystalline layers can be precisely controlled. The QDs can be formed by using the Stranski–Krastanov (SK) growth method. This is the general technique for QD formation in MBE. SK growth happens when

a material is grown on a substrate with a lattice mismatch. Lattice mismatch is the difference in lattice constant between the depositing material and substrate. Initially, a thin two-dimensional “wetting layer” forms. The “wetting layer” is an initial growth stage where it wets the substrate surface. As more material is deposited, the strain caused by the lattice mismatch leads to the spontaneous formation of three-dimensional islands, which become the QDs. At a critical thickness, the strain energy becomes too high. And it becomes energetically favourable for the material to form 3D islands (QDs) instead of continuing to grow in a layer (Fig. 10c). This “self-assembly” process allows for the formation of QDs without the need for complex lithographic patterning.¹¹³

The common material systems for MBE-grown QDs include InAs/GaAs or InGaAs/GaAs. MBE allows for precise control over growth rate by controlling the flux of atomic beams. Also substrate temperature influences the diffusion and nucleation of atoms. The process starts with depositing a buffer layer, such as GaAs, on the substrate to provide a high-quality crystalline surface. After that the QD material (*e.g.* InAs) is deposited, triggering the SK growth mode. Growth parameters such as temperature flux are carefully controlled to achieve the desired QD size and density. Then a capping layer (*e.g.* GaAs) is grown over the QDs to protect them and improve their optical properties.

This allows for precise control over the layer thickness and QD formation. The ultra-high vacuum environment minimizes contamination, resulting in high-purity QDs. MBE allows for atomic layer control, enabling precise control over QD size and composition. MBE-grown QDs typically exhibit high crystalline quality and excellent optical properties. However MBE systems are expensive to purchase and maintain. MBE growth rates are relatively slow, limiting throughput.

Out of all the bottom-up approaches, CVD provides high purity since this process is carried out in a closed vacuum chamber, minimizing contamination from atmospheric gases (Table 3).¹¹⁴ Also a wide range of materials, such as metal semiconductors and even certain complex oxides, can be deposited. Process parameters like temperature, pressure and precursor concentration can be precisely controlled to tailor the film's properties like thickness, composition and crystallinity.¹¹⁵ There are various types of CVD techniques, including low-pressure CVD (LPCVD), plasma-enhanced CVD (PECVD) and atomic layer deposition (ALD). ALD (atomic layer deposition) is a specialized form of CVD known for its exceptional control over film thickness and uniformity at the atomic level.¹¹⁶ This precise control makes ALD a potential candidate for depositing thin gate oxide layers used in SETs.¹¹⁷ ALD offers the most promise for SET manufacture due to its exceptional control over film thickness and homogeneity both of which are critical for the gate oxide layer.¹¹⁸ However some studies indicate that two methods are used for thin film deposition: low-pressure CVD (LPCVD) and plasma-enhanced CVD (PECVD).^{119,120}

SET device fabrication

QD transfer. Generally silicon is chosen as a substrate material due to its higher electron mobility and good control over the energy bandgap. The silicon substrate has to be cleaned by following the standard RCA cleaning procedure. Then an oxide layer of ~300 nm thick is deposited using any technique, such as CVD, physical vapour deposition (PVD), plasma spray or the sol-gel method. The QDs grown in the previous step (either top-down or bottom-up) have to be deposited on the silicon substrate by following any transfer method, such as the wet transfer method or spin coating^{121–123} (Fig. 11a and b).

Metal deposition to define the boundaries of the QD. The developed QD has a very large-scale boundary. To control the size of the QDs, metal contacts are deposited between them, necessitating the deposition of an aluminium-like metal element of 80 nm thick using electron beam evaporation or DC sputtering.¹²⁴ However the unique properties of ultra-high vacuum (UHV) sputtering have recently made it an attractive option for depositing thin films over a single particle system like a SET.¹²⁵ Before that a PMMA resist of 200 nm needs to be spin-coated on a substrate. Then an electron beam of 25 keV can be directly written on a substrate, according to the design (Fig. 11c).

Tunnel barrier formation. The selected oxide layer should exhibit a larger bandwidth and should form a stable interface

with the QD material. The most used oxide layers for tunnel barriers are Al₂O₃, SiO₂ and HfO₂. The tunnel barrier is formed by the double angle evaporation method, the electrophoresis method, oxygen plasma etching or reactive ion etching (RIE).¹²⁶ The oxide layer is one of the optimization parameters because the desired tunneling barrier height and capacitance will influence the choice of oxide¹²⁷ (Fig. 11d).

Metallization and lift-off. Metallization has to be performed to obtain source, drain and gate electrodes. Finally the unwanted metal element and resist can be etched away in a process called lift-off (Fig. 11e).

Reported works indicate that EBL is an effective lithography tool for SET fabrication (Table 4). Because EBL offers unparalleled resolution, it enables the creation of extremely small and precise patterns that are essential for defining the nanoscale features of SETs.¹²⁸ Due to the presence of a focused electron beam deflector, control over the electron beam's direction is possible. Therefore a mask is not necessary when writing a pattern on a resist. Due to its feasibility, EBL is a very versatile technique that is frequently employed in SET fabrication.¹²⁹ The required design can be patterned on a resist down to about 30 nm in size with the help of an advanced microscope.

Charge sensors

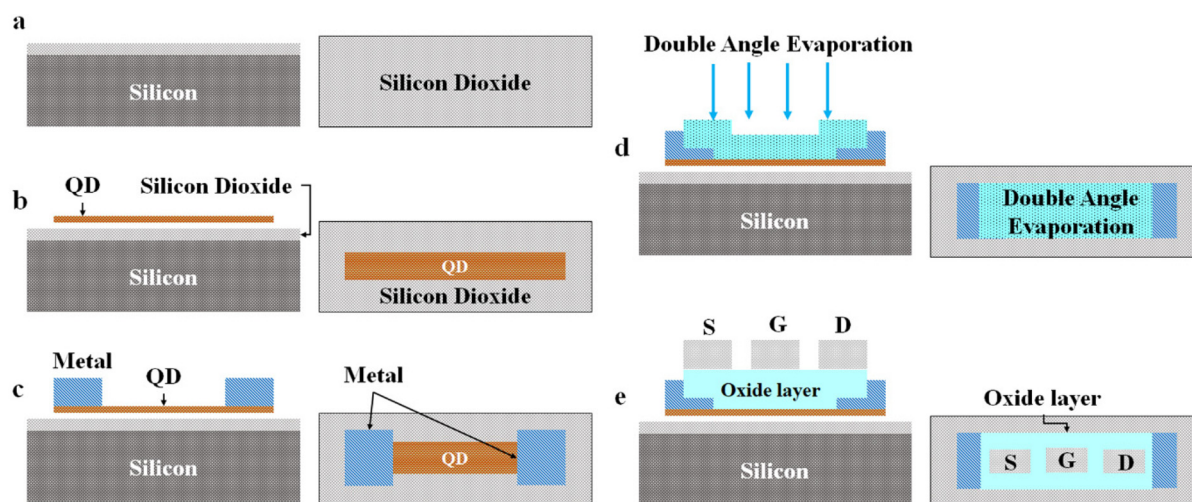
The fabricated single electron transistors can be used for charge sensing applications by bringing a charge source close to the SET. This could be another quantum dot, a single electron trapped in a potential well or a nearby charge impurity.¹³⁵ The charge on the source will induce a change in the electrostatic environment of the SET, altering its current. The change in SET current is measured to detect the presence of the charge. This change in potential manifests as a shift in the SET's current-voltage characteristics. By carefully analyzing current variations, one can infer the magnitude and timing of the charge changes.¹³⁶ The accuracy of the charge sensor can be enhanced using low-noise electronics, such as a low-noise amplifier, which amplifies and measures the tiny current changes in the SET. These can help to improve the signal-to-noise ratio by modulating the SET's gate voltage and demodulating the current signal.

Nanoscale characterization techniques

Characterization is the process of evaluating the performance and functionality of a device. Since the SET depends on the behaviour of a single electron, further techniques are needed to estimate these characteristics. The role of characterization in achieving optimal performance in quantum devices, with specific reference to SETs. The foremost characterization method includes electrical transport measurements such as *I-V* characteristics and gate dependence. The current (*I*) across the source and drain electrodes is measured in response to the applied voltage (*V*) using the SET. The energy required to add or remove an electron from the QD inhibits the passage of current, resulting in Coulomb blockade diamonds, which are produced by the current measurement. Additionally, by adjusting the gate voltage, the conductance of the SET may be seen.

Table 3 Bottom-up techniques reported in the literature for preparing QDs

Method	Procedure	Size	Transfer method	Advantages	Issues
Sol-gel method ¹⁰⁸	Hydrolysis (sol + gel) + condensation + aging and drying + calcination	20–50 nm	Screen printing	<ul style="list-style-type: none"> • Support for a wide range of materials • Creates highly homogeneous materials at the molecular level 	<ul style="list-style-type: none"> • Time consuming • Sensitivity to impurities • Leads to drying and cracking
Hydrothermal synthesis ¹⁰⁹	Template-assisted synthesis	~4 nm	Spin coating	<ul style="list-style-type: none"> • High purity • Versatility • Environmentally friendly 	<ul style="list-style-type: none"> • Time consuming • Difficulty in scaling up • Potential for impurities • Limited control over particle size
CVD ¹¹⁰	Precursor + nucleation and growth + cooling and removal	Less than < 5 nm	Wet transfer	<ul style="list-style-type: none"> • High purity QDs with minimal impurities • Control over size and shape • Large-scale production • Uniformity • Compatibility with other processes 	<ul style="list-style-type: none"> • High equipment costs • Safety concerns • Substrate limitations
ALD ¹¹¹	Precursor + purge	~5–10 nm	Wet transfer	<ul style="list-style-type: none"> • Large-area uniformity • Material versatility 	<ul style="list-style-type: none"> • Equipment costs • Low throughput • Material impurity • Stress
Colloidal synthesis ¹¹²	Substrate heating + precursor injection + reaction	~10–20 nm	Spin coating	<ul style="list-style-type: none"> • Controlled size and shape • Rapid nucleation • High quantum yield • Versatility • Large-scale production • Precise control over QD size • High crystalline quality 	<ul style="list-style-type: none"> • Safety concerns • Oxygen and moisture sensitivity • Post-synthesis purification
MBE ¹¹³	Epitaxial growth of a thin film	70 nm	NA		<ul style="list-style-type: none"> • Expensive • Slow process

**Fig. 11** a. Substrate preparation. b. QD transfer using a wet transfer method. c. Metal deposition to define the boundaries of the QD. d. Tunnel barrier formation by the double angle evaporation technique. e. Metallization and a lift-off process.

This indicates how sensitive the apparatus is to variations in the QD's electron count. Then a spectroscopic approach can be used to characterize the SET. In this method, a low-frequency AC voltage is used with the DC bias voltage. Current measurements provide useful information for researchers

such as the capacitance of the tunnel junction and the charging energy of the QD. Utilizing noise spectroscopy to measure variations in the current passing through the SET is an additional technique for characterization. By analysing the fluctuations, researchers can determine the discreteness of the

Table 4 Reports on SET fabrication

Method	E-beam energy/wavelength	Beam diameter	Oxide layer thickness	Resist (thickness)	Electrode	Island	Tunnel junction formation	Operating temp.
EBL ⁵⁶ (1997)	40 keV	<20 nm	—	MAA (450 nm) PMMA (50 nm)	Al	Al	Double angle evaporation	43 mK
EBL ¹³⁰ (2004)	40 keV	20 nm	200 nm	NEB22A (90 100 110 nm)	Al	Polysilicon/20 nm	—	4 K
EBL ⁶⁰ (2015)	—	—	400 nm	PMMA	—	Si/50 nm	Thermal oxidation	70 K
EBL ¹³¹ (2007)	100 kV	—	300 nm	PMMA (350k) PMMA (100k)	Al	Al/10 nm	RIE	2 K
EBL ¹³² (2009)	—	—	200 nm	PMMA	Titanium (40 nm)	SWCNT	O ₂ plasma etching	1.5 K
EBL ⁶⁰ (2004)	—	—	—	—	Au	Au/10 nm	Electromigration + e-beam evaporation	4.2 K
EBL ¹³³ (2016)	—	4 nm	300 nm	MMA (450 nm) PMMA (150 nm)	Ti (10 nm) Al (70 nm)	Graphene nanoribbon	O ₂ + RIE	4.2 K
EBL ¹³⁴ (1994)	30 kV	—	200 nm	PMMA 70 nm MAA 200 nm	Al	Al	Two-angle shadow evaporation	4.2 K

charge carriers. This measurement helps to acknowledge the single-electron nature of the device's operation. Then the research community uses electron microscopy as a better characterization technique. A high-resolution image of the SET device is recorded by using imaging techniques such as transmission electron microscopy (TEM) and cryo-electron microscopy (Cryo-EM). This information is used to verify the device's geometry and identify any fabrication defects. Advanced characterization methods like radio-frequency (RF) and low-temperature measurements are also discussed in this article. By incorporating the SET into an RF circuit, researchers can explore its high-frequency characteristics and potential for applications in radio frequency electronics. Since thermal fluctuations can obscure the quantum effects in SETs, characterization often happens at cryogenic temperatures (near absolute zero).

Material characterization

Transmission electron microscopy (TEM). TEM is an excellent tool for high-resolution imaging, providing atomic-level detail on the SET's physical structure. After fabrication, TEM allows researchers to validate the actual dimensions of the QD tunnel junctions and electrodes in the SET. These dimensions are critical factors influencing the electrical behaviour. Deviations from the intended design can be identified and potentially addressed for future iterations. Imperfections like irregularities in the QD shape or tunnel junctions can significantly impact the SET's performance. TEM's high magnification allows for the visualization of such defects, aiding in optimizing fabrication processes to minimize them (Fig. 12a left). TEM can be used for compositional analysis to identify the materials used in the SET and any impurities. Understanding the material's properties is crucial for tailoring the device for specific electrical characteristics. For instance, the presence of unwanted dopants might affect the SET's ability to achieve the desired Coulomb blockade effect.

By providing high-resolution structural information, TEM complements the insights gained from electrical characteriz-

ation techniques. Observed electrical behaviour in the SET can be linked to specific structural features visualized using TEM. This makes it possible to comprehend the device's atomic-level operation on a deeper level.¹³⁷ Also identifying structural issues through TEM can guide the refinement of fabrication processes to create more consistent and higher-performing SETs. Future developments in the fascinating subject of nanoelectronics can be facilitated by utilizing the insights obtained from TEM research to optimize the design and manufacture of SETs. TEM's structural insights are helpful for enhancing the functionality and design of these innovative gadgets.¹³⁸

Cryo-transmission electron microscopy (cryo-TEM). Cryo-TEM is an effective material characterization tool for analysing the morphology of the electrodes and gate structure and the presence of defects or imperfections at the nanoscale level. In contrast to conventional TEM, which runs at room temperature, cryo-TEM subjects the sample to an environment close to the temperature of liquid nitrogen, which is approximately $-170\text{ }^{\circ}\text{C}$ or 103 K .¹⁴³ The sample is flash-frozen at this extremely low temperature in a vitrified (glassy) form, maintaining the nanoparticles' natural structure and reducing artifacts from chemical fixation or dehydration processes that are employed in traditional approaches.¹⁴⁴ Cryo-TEM, pushing the limits of resolution, makes it possible to see individual atoms inside the QD structure. Because of this feasibility, the presence of dopant atoms in the QD lattice can be identified and also any imperfections or defects can be detected that can affect QD performance.¹⁴⁵ Cryo-TEM provides information about the elemental composition and electronic structure of the QD. Also the spatial distribution of different elements within the QD can be determined and this can reveal the presence of any unwanted elements or contaminants within the QD.¹⁴⁶ One of the important properties related to quantum confinement is the bandgap energy of the material, which can also be analysed. The quantum confinement effect of a 2D material lies within its tuneable layers. The number of layers can be effectively viewed in cryo-TEM analysis (Fig. 12a

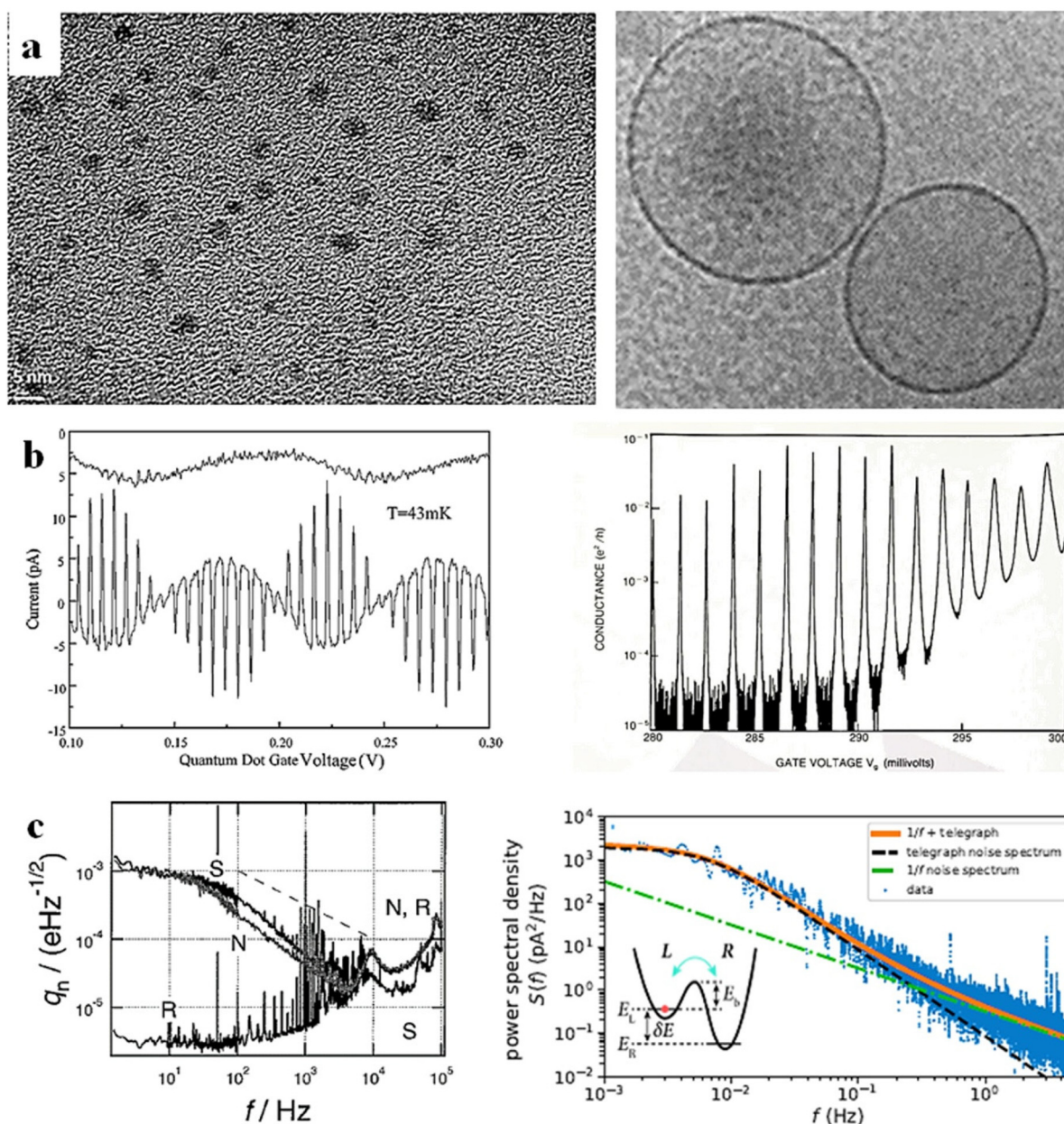


Fig. 12 a. TEM (left) (this figure has been reproduced from ref. 139 with permission from JOVE copyright 2024) and cryo-TEM image of quantum dots (right) (this figure has been reproduced from ref. 140 with permission from European Chemical Societies Publishing copyright 2024). b. I - V (left) and G - V (right) characteristics of a SET (this figure has been reproduced from refs. 31 and 56 with permission from AIP Publishing copyright 2024). c. Noise spectra of a SET (left) (this figure has been reproduced from ref. 141 with permission from AIP Publishing copyright 2024) and power spectral density of the SET (right) (this figure has been reproduced from ref. 142 with permission from Springer Nature copyright 2024).

right).¹⁴⁰ The above-discussed information is essential for understanding the fundamental properties of QDs and paving the way for advancements in QD-based technologies.⁶¹

Electrical characterization. The electrical characterization of SETs depends on an understanding of their unusual behaviour, which is based on the ideas of single-electron tunneling and the Coulomb blockade. Low-temperature environments are often preferred for SET characterization, as thermal noise can obscure delicate single-electron effects. The tiny currents

passing through the SET are measured using specialized setups that include transimpedance amplifiers and voltage sources.

Cryogenic probe station. An essential tool for precise electrical characterization of SETs is a cryogenic probe station.¹⁴⁷ At room temperature, thermal noise can mask the subtle effects arising from single-electron tunneling in SETs.¹⁴⁸ By lowering the temperature using a cryogenic probe station (typically reaching temperatures below 4 K), thermal noise is significantly suppressed, allowing for a clearer observation of the

device's single-electron behaviour. The Coulomb blockade effect is strengthened by decreased thermal noise. Thermal noise-induced energy variations are suppressed at cryogenic temperatures in comparison with the SET QD's charging energy. Consequently sharper current peaks are seen in the I - V characteristics, providing a better picture of single-electron tunneling events. This is how the device is configured. The probe station provides a platform to precisely position sharp metallic probes onto the delicate electrodes of the fabricated SET on a semiconductor wafer. These probes make electrical contact with the source, drain and gate electrodes of the SET, enabling the application of voltages and the monitoring of currents. The cryostat within the probe station cools the sample stage, reaching cryogenic temperatures. Thermal insulation and specialized transfer lines ensure the cold environment is maintained around the device.¹⁴⁹ Special low-noise cables and amplifiers are often used within the cryogenic environment to minimize noise introduced during measurements due to cable resistances and thermal fluctuations.

Similar to room temperature characterization, current-voltage (I - V) sweeps are performed. The cryogenic environment allows for more precise observation of the current peaks corresponding to single-electron tunneling events. Techniques like capacitance-voltage (C - V) sweeps and four-probe methods can be employed to measure the gate capacitance (C_g) and tunnel junction resistances (R_t) at cryogenic temperatures. These parameters are crucial for understanding the device's behaviour and can be compared to theoretical models. By minimizing thermal noise, cryogenic characterization provides a more accurate picture of the SET's single-electron transport properties. This allows researchers to determine key parameters with greater precision. Understanding the behaviour of SETs at cryogenic temperatures is crucial for optimizing their performance for applications like quantum computing where low-noise operation is essential (Fig. 12b). The data provided show the electrical characteristics of a single-electron transistor (SET) at ultra-low temperatures. On the left, " I - V characteristics at 43 mK" depict current *versus* voltage, revealing conductivity changes. On the right, " G - V characteristics at 60 mK" show conductance *versus* gate voltage, illustrating gate modulation. Both measurements, taken at millikelvin temperatures, demonstrate the SET's quantum behavior, specifically the Coulomb blockade essential for single-electron control. Cryogenic probe stations are a vital tool for researchers studying and developing SETs. By enabling characterization at ultra-low temperatures, they provide valuable insights into the single-electron transport mechanisms within these devices, paving the way for advancements in nanoelectronics and quantum technologies.¹⁵⁰

Noise characterization. Understanding the noise properties of SETs is crucial for optimizing their performance in various applications, particularly those requiring high sensitivity. Noise spectroscopy provides a powerful tool for this purpose. The power spectral density (PSD) of electrical noise emitted from a device over a variety of frequencies is measured in noise spectroscopy. The kind and intensity of the many noise

sources that are present in the device are disclosed by the PSD. SETs, due to their nanoscale operation and single-electron tunneling phenomena, are inherently susceptible to various noise sources. The device's sensitivity and operation may be restricted by some noise sources. By analysing the PSD obtained from noise spectroscopy, researchers can identify the dominant noise contributions in the SET. Thermal flicker and shot noise are common noise sources in SETs. Measurements of the Fano factor in noise spectroscopy can describe shot noise, which results from the discontinuous nature of electron flow. To reduce thermal noise, the device should be operated at cryogenic temperatures, which are the source of thermal fluctuations. Noise spectroscopy can also be used to study $1/f$ noise, low-frequency noise that frequently results from defects or traps in the SET. Noise spectroscopy provides a quantitative measure of the noise strength at different frequencies.¹⁵¹ This allows researchers to compare the noise performance of different SET devices or assess the impact of design modifications. At 30 mK, researchers studied the noise in a single-electron transistor (SET). The left shows noise levels in both normal and superconducting states, revealing how superconductivity affects noise. The right shows the power spectral density, which details how current fluctuations distribute across frequencies, helping to identify noise sources and optimize SET performance (Fig. 12c). By understanding the dominant noise sources and their behaviour researchers can optimize the design and fabrication processes of SETs to minimize noise and improve their sensitivity.

Noise spectroscopy uses lock-in amplifiers and a spectrum analyser. The lock-in amplifiers provide a selective measurement of the noise power at a specific frequency of interest by rejecting background noise. By sweeping the lock-in frequency, researchers can obtain the complete noise spectrum of the SET.¹⁵² A spectrum analyser can display the entire noise spectrum over a wide frequency range, providing a broader picture of the noise behaviour in the SET. By identifying and mitigating dominant noise sources, researchers can create SETs with better sensitivity and lower noise levels. Noise spectroscopy provides useful information about the fundamental physical processes occurring within the SET, which helps to better understand how the SET functions. Reduced noise levels in SETs are crucial for their application in areas like quantum computing where high sensitivity is essential for reliable operation for gas sensing applications.

Effect of signal-to-noise ratios (SNRs) on charge sensing. The signal-to-noise ratio (SNR) is a crucial factor in charge sensing applications that establishes the precision and dependability of the readings. In charge sensing, the signal refers to the desired electrical response caused by the actual charge that is going to be measured. This could be a voltage or current change proportional to the amount of charge detected.¹⁵³ Abnormal electrical fluctuations that may tamper with the transmission are referred to as noise. There are several possible sources of this noise, including electronic thermal and ambient noise. SNR is a statistic that contrasts the desired signal strength with the amount of noise in the

environment. Usually noise is measured in decibels (dB). An increased signal-to-noise ratio (SNR) yields a more precise and consistent measurement. A high SNR ensures that the measured signal accurately reflects the actual charge present. When noise is significant, it can mask the true signal or introduce errors into the measured charge value. A good SNR enables the sensor to detect and measure even smaller charges. Sensors with a low SNR might struggle to distinguish weak signals from background noise. A high SNR translates to cleaner and more reliable data from the charge sensor. This is crucial for various applications where precise charge measurements are vital.¹⁵⁴ In SETs, shot noise is a phenomenon that may be measured as a function of bias and gate voltages. The noise can be measured at 464 MHz, which is the resonance frequency where the $(1/f)$ noise is lowest. For various bias and gate voltages, low-frequency noise in SETs can also be measured from a few hertz to 10 MHz.¹⁵⁴ The probability that the SET will either release or absorb energy from the resonator is related to its asymmetric shot noise. Measuring the noise at multiple bias points with different gains allows one to ascertain if the noise is associated with variations in resistance or charge.

Careful design of the charge sensor itself can minimize internal noise sources. Techniques like proper grounding and shielding can help reduce environmental noise. The signal intensity in relation to noise can be increased by applying filtering and amplification techniques. However these techniques need to be carefully implemented to avoid distorting the signal itself. In some cases, operating the sensor at lower temperatures can help reduce thermal noise. Additionally shielding the sensor from external noise sources can significantly improve the SNR. By understanding and optimizing SNRs, researchers and engineers can ensure that their charge sensing systems deliver accurate and reliable measurements, paving the way for advancements in various scientific and technological fields.¹⁵⁵ SETs and their electrical, material and noise characteristics have been investigated (Table 5).^{31,37,56,71,73,141,156–187}

Applications of SETs for charge sensing

SETs are a perfect match for QD sensing due to their complementary characteristics. QDs are tiny semiconductor structures that can trap a specific number of electrons. Their properties are highly sensitive to the number of trapped charges. SETs are excellent at reading the occupancy of a QD because of their extraordinary capacity to detect minuscule changes in charge (down to a fraction of an electron). Researchers can accurately count the electrons in the dot by observing the current flowing through the SET. Due to their ability to store quantum information contained in the spin or charge state of trapped electrons, QDs show potential for use in quantum computing applications.¹⁸⁸ SETs function as highly sensitive probes that can “read out” these quantum states by detecting

the subtle changes in charge associated with different spin or occupancy configurations. Researchers might adjust the energy levels of the QD by varying voltage pulses applied to the SET's gate electrode. They can thus investigate the energy spectrum of the dot and gain an understanding of its interactions with its surroundings and electrical structure. Crucially important for quantum information processing, SETs are employed in quantum computers to read out the state of the QD qubit. All things considered, SETs provide researchers exploring the interesting realm of QDs with a priceless instrument. Because of their unmatched sensitivity to charge, which allows new directions for quantum computing spintronics and other cutting-edge sciences, these nanostructures can be exactly defined.¹⁸⁹

Biomolecule detection

SET-based single-molecule biosensors offer a potent means of identifying the presence and activity of individual biomolecules. With great sensitivity, this method lets researchers examine occurrences at the single-molecule level. Many times, when analysing bulk samples, traditional biosensors produce an average response. Biological processes however can show notable variability whereby individual molecules behave differently. By spotting and evaluating the activity of every molecule, single-molecule biosensors can get beyond this restriction and offer a better understanding of biological events.¹⁹⁰ Nevertheless, a significant obstacle facing modern biosensors is achieving real-time single-molecule resolution for *in situ* activity detection in natural materials. The label-free real-time detection of biological molecules, including viruses, proteins and nucleic acids, is made possible by single-molecule electronic biosensors, which have high sensitivity and specificity.¹⁹¹ The outline of the operation of single-molecule electrical biosensors is given in this section.

The working mechanism of biomolecule detection is based on finding the variation in the electrical conductance using SETs.¹⁹² The surface of the SET needs to be modified to selectively bind with the target biomolecule. This is achieved by attaching a receptor molecule to the SET surface. The receptor molecule may be a protein, DNA, RNA (ribonucleic acid) and other biorecognition molecules. The target biomolecule modifies the electrical characteristics of the SET and influences the current flow when it binds to the receptor on the SET surface.²³ By enabling the target molecular electrostatic potential to electrostatically alter the electron fluxes of the conductive channel, a single molecule SET biosensor may detect signals. The target molecules' interactions can be swiftly translated into readable electrical signals in real-time by the molecularly gated sensing method.¹⁹³ This change in current is measured and analysed to detect the presence and potentially the concentration of the target biomolecule. By employing signal processing techniques, it is feasible to improve detection accuracy and the signal-to-noise ratio.²⁷

A recent cutting-edge study suggests that in order to improve the effectiveness of biomolecule detectors, the size of the sensing channel's nanomaterials should be similar to that of the majority of biological entities, including viruses, pro-

Table 5 Survey of SET characteristics

Paper reference***	Design/application	Material	Charging energy E_c	Electrical characterization	Highlight
		Dot/QD size	Sensitivity	Material Characterization	
		Gate capacitance	Temperature	Noise Characterization	
Design of SER (theoretical aspects & experimental) ¹⁵⁶	Design of SER (theoretical aspects & experimental)	Quasi particles	—	• I - V curve • Charge stability diagram (CSD)	• Mathematical background of SET helps to do experimental analysis
		0.1 μm^2 3 $\times 10^{-15}$ F	— 0.3 K	—	
Design of small-area tunnel junction ⁷³	Design of small-area tunnel junction	Au-Cr film	—	• I - V curve	• Observed electric field induced oscillations
		14 nm 0.20–0.23 fF	— 4.2 K	—	
Discovery of conductance oscillations in small transistor ¹⁵⁷	Discovery of conductance oscillations in small transistor	2DEG	—	• I - V curve • CSD	• Discovered the quantum Hall effect
		15–30 nm 10 ⁻¹⁶ F	—	—	
Theoretical understanding of SET ³⁷	Theoretical understanding of SET	Al	—	• I - V curve	• Study the tunneling effect of a single electron on the tunnel junction
		100 nm —	— 4 K	—	
Artificial atom/quantum dot ³¹	Artificial atom/quantum dot	GaAs	—	• I - V curve	• Investigates the effects of quantum confinement
		5 nm —	3 meV 4.2 K	—	
Design of SET for charge sensing ⁵⁶	Design of SET for charge sensing	Heterostructure with 2DEG	—	• I - V curve	• This experiment setup led to best sensitivity being observed • SNR = 50
		100 nm 50 aF	10 ⁻⁵ e per $\sqrt{\text{Hz}}$ 43 mK	—	
Detection of gain dependent noise in SET ¹⁴¹	Detection of gain dependent noise in SET	Al	—	• I - V curve	• Noise at the output closely follows the gain value
		— 4.8 aF	2 $\times 10^{-5}$ e per $\sqrt{\text{Hz}}$ <30 mK	— • Noise spectra were recorded using a dynamic signal analyzer	
Design of SET and investigates the noise sources ¹⁵⁸	Design of SET and investigates the noise sources	Al	—	• I - V curve	• Experimental observation in the superconducting state • Result can be taken at high temperature
		100 nm 10 aF	1 $\times 10^{-3}$ e per $\sqrt{\text{Hz}}$ 150 mK	— • Lock-in amplifier • Spectrum analyzer	
Design of SET at room temperature ¹⁵⁹	Design of SET at room temperature	Carbon nanotube	—	• I - V curve	• Luttinger liquid model is used • Electrical characterization analysed through temperature bias and gate voltage
		20 nm —	2 $\times 10^{-3}$ e per $\sqrt{\text{Hz}}$ 300 K	— • CSD	
Electron transport in Si-based SET ¹⁶⁰	Electron transport in Si-based SET	Nanocrystalline silicon	—	• I - V curve • CSD	• Study the quantum box and transport mechanism
		8 nm 0.7 aF	— 20 K	—	
Quantum confinement effect in QDs by MoS ₂ ¹⁶¹	Quantum confinement effect in QDs by MoS ₂	MoS ₂	—	• I - V curve • Liquid exfoliation • TEM image	• Quantum confinement property used to achieve quantum dots at room temperature
		5 nm —	— 300 K	—	
SET using MoS ₂ ¹⁶²	SET using MoS ₂	MoS ₂	22 meV	• I - V curve • CSD	• Performance of the SET was improved due to the novel 2D material
		100 nm \times 1 μm 94.9 aF	— 30 K	—	
SET using graphene nanoribbon as a QD ⁷¹	SET using graphene nanoribbon as a QD	Graphene nanoribbon	—	• I - V curve • CSD	• Results reveal that increasing graphene nanoribbon width decreases the Coulomb blockade range
		0.369 nm \times 0.492 nm 12.5 μF	— 100–300 K	—	

Table 5 (Contd.)

Paper reference***	Design/application	Material	Charging energy E_c	Electrical characterization	Highlight
		Dot/QD size	Sensitivity	Material Characterization	
		Gate capacitance	Temperature	Noise Characterization	
SET using MGNR and used edge functionalization to yield ultra-clean transport devices ¹⁶³	SET using MGNR and used edge functionalization to yield ultra-clean transport devices	Molecular graphene nano-ribbons	—	• CSD	• This work leads to the exfoliation of spin and vibrational properties in graphene nano-structure
		10 nm	—	• AFM molecular spectroscopy	
		—	20 mK	—	
Hybrid architecture of metal & superconductor used for SET ¹⁶⁴	Hybrid architecture of metal & superconductor used for SET	Metal–copper Superconductor–aluminium	—	• I – V curve	• This work provides precise control and detection of single electrons
		50 nm	—	—	
		—	2 K	—	
SET by Si-nanowire ¹⁶⁵	SET by Si-nanowire	Si-NW	—	• Coulomb oscillation	• This work offers integration of Si SET with CMOS technology for room-temperature operation
		4 nm	—	• I – V curve	
		0.23 aF	300 mK	• TEM	
Design of SET using the organic molecule as a QD ¹⁶⁶	Design of SET using the organic molecule as a QD	Acridinium	—	• I – V curve	• Due to the nature of acridinium's low ionization & affinity energies, it can be used for high-switching applications
		5 nm	—	• CSD	
		3.25 eV	>300 mK	• DFT	
Design of SET using a borane-based molecule ¹⁶⁷	Design of SET using a borane-based molecule	10-Boranyl anthracene-9-yl	—	• CSD	• This work realizes high switching speed & power efficiency
		2.5 Å (2.50×10^{-10} nm)	—	• DFT	
		—	Work function = 5.28 eV	—	
Design and characterization of SET ¹⁶⁸	Design and characterization of SET	Titanium nanowire	0.29 eV	• I – V curve	• Provides a high ON current (10 nA)
		40 nm × 25 nm $l \times b$	—	—	
		—	300 K	—	
Design of molecular SET for human-compatible nanobots ¹⁶⁹	Design of molecular SET for human-compatible nanobots	Some metal–organic molecular compounds	≈6686.69 eV	• CSD	• Riboflavin performs best in terms of high electron transfer rate
		Average size is 100 Å ≈ 10 nm	—	• DFT	
		—	300 K	• DOS	
Design of SET used for readout electrometry ¹⁷⁰	Design of SET used for readout electrometry	Silicon-on-sapphire	—	• I – V curve	• It can be used as a charge/spin-based qubit read-out unit
		—	High sensitivity obtained at 1 nA	—	
		—	4 K	• Noise analysis was done using $1/f$ noise signal	
Design of Si MOS SET for charge sensor ¹⁷¹	Design of Si MOS SET for charge sensor	Si-MOS Si/2DEG/SiO ₂ /TiN	1–2 meV	• I – V curve	• High charge sensitivity opens new path for spin-based quantum computing technologies
		50 nm	—	• CSD	
		13 ± 4 aF	300 K, 1.6 K & 10 mK	• $1/f$ noise with 2 μeV amplitude at 1 Hz (noise spectroscopy)	
Single-electron effect in multiple-gate SOI MOSFET ¹⁷²	Single-electron effect in multiple-gate SOI MOSFET	Silicon	17 meV	• I – V curve	• This work presents a promising scheme to build room-temperature SETs
		1.6 nm	—	—	
		20–30 aF	<300 K	—	
Reduction of shot noise in SET ¹⁷³	Reduction of shot noise in SET	—	Lower charging energy	—	• Shot noise reduced with Fano factor = 0.01
		—	—	—	
		10 ⁻¹⁷ F	Low temperature	• Newton–Raphson method used to improve accuracy • Fano factor = 0.01 (Monte-Carlo simulation)	

Table 5 (Contd.)

Paper reference***	Design/application	Material	Charging energy E_c	Electrical characterization	Highlight
		Dot/QD size	Sensitivity	Material	
		Gate capacitance	Temperature	Characterization Noise	
				Characterization	
Design of SET using nanoparticles at room temperature ¹⁷⁴	Design of SET using nanoparticles at room temperature	Tungsten	—	• I - V curve	• The SET fabricated can be used as a gas sensor (target gas – NO ₂)
		16 $\mu\text{m} \times 16 \mu\text{m}$	Few tens of ppm observed	—	
Fabrication of SET ¹⁷⁵	Fabrication of SET	Si nanowire	—	• I - V curve	• Si NW SET fabricated with high performance
		3 nm	—	—	
		—	77 K & 300 K	—	
Fabrication of dual-gate SET ¹⁷⁶	Fabrication of dual-gate SET	Silicon	2.3 eV	• I - V curve	• By changing the bias conditions, double dots are formed and peak splitting is observed • This will be used for spintronics & sensor efficiency
		10 nm	—	• CSD	
		0.084 aF	300 K & 80 K	—	
Experimental analysis of nanoscale SET ¹⁷⁷	Experimental analysis of nanoscale SET	Silicon	37 meV	• I - V curve	• SET can integrate with CMOS and the fabrication technique is adopted from CMOS technology
		10 nm	—	—	
		10 ⁻¹⁸ F	300 K & 4.2 K	—	
Optimized metallic SET ¹⁷⁸	Optimized metallic SET	TiO ₂	—	• I - V curve	• Using tunnel junction engineering in the SET improves its performance
		25.3 nm	—	—	
		0.087 aF	1.6 K	—	
Fabrication of SET ¹⁷⁹	Fabrication of SET	Si	—	• I - V curve • CSD	• The fabrication of Si SET can be used to make nano-devices with multiple nanodevices
		45 nm	—	—	
		0.1 aF	6 K	—	
Design of SET on SIMOX substrate ¹⁸⁰	Design of SET on SIMOX substrate	Si	70 meV	• I - V curve	• The performance of the designed SET is based on the size of the dot/device
		10 nm	—	—	
		1 aF	30 K	—	
Fabrication of SET ¹⁸¹	Fabrication of SET	Polysilicon	—	• I - V curve	• By using this SET structure, Coulomb oscillation can be observed effectively
		10 nm	—	—	
		10 ⁻¹⁸ aF	High T -180 K Low T -40 K	—	
Modeling of Si SET by Bardeen's transfer Hamiltonian formalism ¹⁸²	Modeling of Si SET by Bardeen's transfer Hamiltonian formalism	Si	—	• I - V curve	• This work fills the knowledge gap in systematic studies on SETs depending on geometry
		3.2 nm	—	—	
		—	300 K	—	
Design of SET used as a microwave detector ¹⁸³	Design of SET used as a microwave detector	Al	100 μeV	• I -charge/ e characteristics	• Since a dot is a superconductor, it can absorb microwave photons, which are extremely sensitive
		70 nm	3×10^{-2} W per $\sqrt{\text{Hz}}$	—	
		—	700 mK/150 mK	—	
Fabrication and characterization of CMOS based SET ¹⁸⁴	Fabrication and characterization of CMOS based SET	Si	1.2 meV	• I - V curve • CSD • Coulomb oscillations	• This CMOS integrated SET can be used for real-time applications
		70 nm	—	—	
		5 aF	30 mK	—	
Design & model of a single molecule transistor ¹⁸⁵	Design & model of a single molecule transistor	Spiro fluorene	—	—	• This SET provides better electrostatic gating
		1.25 nm	• Green's function • SCF • DFT	—	
		—	—	—	
Design and fabrication of SET based on a tunnel junction ¹⁸⁶	Design and fabrication of SET based on a tunnel junction	Al & Nb	0.15 \pm 0.02 meV 1.0 \pm 0.2 meV	• I - V curve	• In both cases, charge effects are clearly observed
		50 nm	—	—	
		2.5 \pm 0.2 $\times 10^{-17}$ F 3.2 \pm 0.1 $\times 10^{-17}$ F	300 mK/150 mK	—	

Table 5 (Contd.)

Paper reference***	Design/application	Material	Charging energy E_c	Electrical characterization	Highlight
		Dot/QD size	Sensitivity	Material Characterization Noise	
		Gate capacitance	Temperature	Characterization	
Design and analysis of a CQD transistor ¹⁶³	Design and analysis of a CQD transistor	Colloidal quantum dots (CQD) – PbS	150 meV	• I - V curve	• It can operate at room temperature because of the large E_c • This is promising for optoelectronic devices
		Less than 10 nm	—	• CSD	
Fabrication of SET by the direct-write method ¹⁸⁷	Fabrication of SET by the direct-write method	—	300 K	—	• FEBID-based SET structures can be useful for charge monitoring devices with high lateral positioning flexibility
		Pt	0.018 eV	• I - V curve	
		40 nm	—	• CSD	
		0.21 aF	30 K–210 K	—	

teins and so on. Thus silicon nanowires (SiNWs),²² single wall carbon nanotubes (SWCNTs)¹⁹⁴ and 2D materials (graphene, transition metal dichalcogenides)¹⁹⁵ can be used as a biosensor. Because of their complementary size scale, changes in a trapped molecule can immediately alter the carrier density at the tiny nanometric sensing channel surface.²² When a single biomolecule interacts with the conductive channel, the field effect or dispersion effect, like a switch valve, causes the modification of the sensor site to substantially modify the conductivity of the entire device. Consequently the electrical nano-biosensors have sufficient sensitivity to distinguish specific proteins. The devices' electrical impulses make it possible to directly identify and track the dynamic actions of individual molecules. In order to connect with other target molecules in the solution, the single molecule that is attached can also be used as a probe. This probe–target interaction technique enables single-molecule resolution to identify target molecules over a broad concentration range (millimicrons).¹⁹⁶ Target biomolecule concentrations are provided and summarized for single-molecule detection employing representative electronic biosensors (Table 6).

Because single-molecule detection technology is developing so quickly, the integration of electrical and optical detection of single molecules has proved to be beneficial for the research of single-molecule biodynamics, especially the single molecular junction.

Table 6 The reported SET based bio-sensors and their limits of detection

Type of sensor	Investigation	Goal	Target concentration
SiNW ²²	DNA	DNA binding protein	10 μ m
SiCNT ¹⁹⁴	DNA polymerase	Native dNTP (deoxynucleotide triphosphate)	10 μ m
Molecular bridge ¹⁹⁵	DNA polymerase	DNA	2.5–15 μ m

Scanning microscopy

Owing to its submicron spatial resolution in detecting static electric fields, SETs can be employed as scanning probe microscopes. In addition to that, scanning SET microscopy uses the characteristics of sensing charges with fractional electron charge sensitivity of $0.01e$. There is a specialized technique called scanning SET microscopy (SETSM) that utilizes a SET as a probe. Here, the SET is mounted on a tip and scanned very close to the sample surface.¹⁹⁷ The SET's capacity to detect the electric field from the sample allows researchers to map static electric fields and charges with remarkably high sensitivity down to a fraction of an electron charge. This provides information complementary to that of SEM, offering insights into the electrical properties of the sample at the nanoscale. Building a scanning SET microscopy (SETSM) involves crafting a tiny transistor on a sharp tip and then integrating it with supercooled electronics and a precise scanner. This delicate dance requires advanced fabrication techniques to create the transistor followed by meticulous mounting onto a probe tip. Electrical connections are established and the whole setup is chilled to near absolute zero for optimal performance. Finally, a computer-controlled scanner meticulously moves the tip across the sample, capturing the electrical landscape with unmatched sensitivity (Fig. 13a).

With the ability to detect electron charge fractions as small as -1% of an electron, SETSM exhibits exceptional sensitivity. This surpasses other scanning probe microscopy techniques in electrical field detection. While not quite reaching atomic resolution, SETSM offers excellent spatial resolution of around 100 nm, allowing for detailed imaging of electrical features on the nanoscale. Scanning SET microscopy consists of various applications, such as the characterization of the electrical properties of semiconductor materials and devices, including dopant profiles, band bending and trapped charges. Investigating the electrical characteristics of several nanomaterials, including graphene and other two-dimensional materials, benefits from the method. Investigating the electrical activity of biomolecules and biological systems is one of

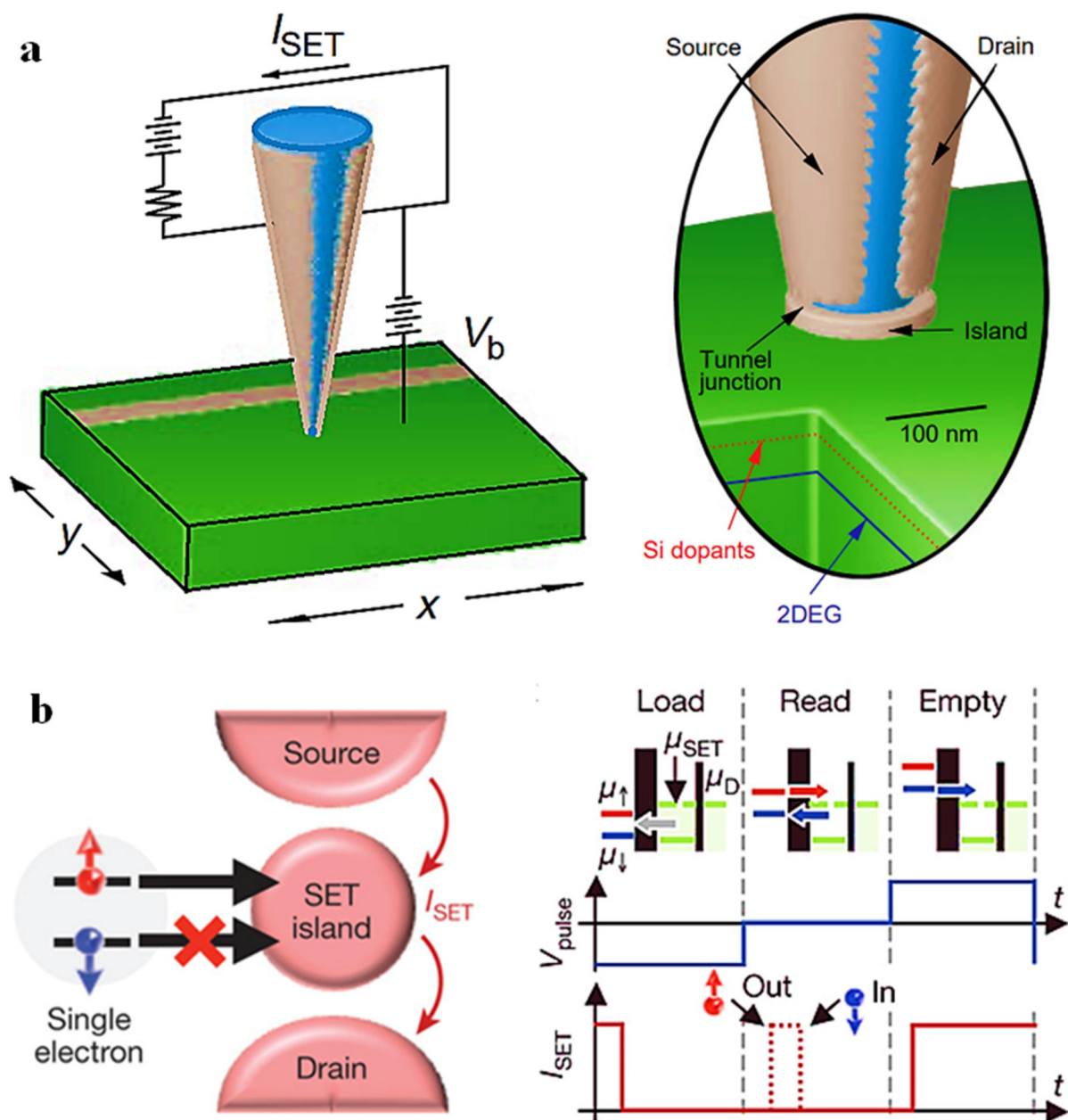


Fig. 13 a. Schematic representation of a SET with a probe tip located above the 2DEG heterostructure. An enhanced picture of the tip and an example of a cutaway (inset) (this figure has been reproduced from ref. 200 with permission from Elsevier copyright 2024). b. Spin-based tunneling mechanism (left) and the readout mechanism (right) (this figure has been reproduced from ref. 59 with permission from Springer Nature copyright 2024).

the recently developed uses. SETSM needs cryogenic temperatures often below 1 K for the best performance. This restricts its more general usefulness. The fabrication of SET probes can be challenging and requires specialized techniques. SETSM measurements can be slow due to the need for precise positioning and high sensitivity. Despite these limitations, scanning single-electron transistor microscopy is rapidly evolving technology with immense potential for pushing the boundaries of electrical characterization at the nanoscale.¹⁹⁸

SETs and probes with greater sensitivity or smaller size will need to be developed in order to further enhance the SETSM. It is possible to enhance the current SETSM's resolution to approximately 10 nm by utilizing smaller fibers and tips, along with somewhat thinner sheets. The operating temperature would rise proportionately with this configuration. Although it is feasible, room temperature operation would necessitate the creation of SET tips that were atomic or molecular in size. This microscopic technique's sensitivity to potential charge capaci-

tance, interface potential, conductance and dielectric materials could be useful for a number of basic and applied challenges.¹⁹⁹ For example, SETSM investigations are relevant for the characteristics of electrons in the quantum Hall regime and their edge states. By applying single-electron capacitance spectroscopy, a potent technique for capturing the entire electron energy structure of mesoscopic systems, SETSM may be able to increase its capacity for spatial mapping.

Spin-readout mechanism (spintronics)

The spin readout mechanism can be implemented with a SET. With regard to spintronics, the single-electron charge sensor's readout process is based on one electron's spin. The weak spin-orbit from the bulk crystal in silicon allows for an electron spin to represent an independent quantum bit with lengthy coherence durations. Therefore, it is extremely difficult, if not impossible, to observe and manipulate a single electron to observe and manipulate an atom's single spin.²⁰¹ According to recent studies, a single-shot method can be used to read out an electron spin in silicon. This is made possible by implanting phosphorus donors alongside a metal oxide semiconductor SET. The spin readout was usually obtained by spin-dependent tunneling where the electron was shifted to a different location according to its spin. The charge detector, which sensed whether the charge had shifted, was electrostatically coupled to the electron site and determined the spin state. Charge sensing has been accomplished by both tunnel coupling to the electron location and electrostatically coupling the detector (Fig. 13b left).⁵⁹ An "electron site" is a designated area within the device where an electron might be confined. This could be a real physical location, such as a defect or a QD, whereby the electron's energy is reduced, therefore trapping it in the surrounding area. By tracking the characteristics of this location and deducing information regarding the presence or absence of a single electron, researchers can accomplish single-electron charge sensing. In the end, the robust coupling configuration will enable high fidelity and a speedy spin readout. A charge sensor or detector is one used for a SET. A characteristic pattern of sharp current peaks as a function of gate voltage results from the QD's electrochemical potential having to take particular values before a current may flow from source to drain. A single electron tunneling into the SET QD from a nearby charge centre causes an electrochemical potential change that allows the current to be switched from zero to its maximum value. This tunneling event becomes spin-dependent when a strong external magnetic field B is present. The energy difference between the spin-up $|\uparrow\rangle$ and spin-down $|\downarrow\rangle$ states represented by $E_Z = g\mu_B B$, with $g \approx 2$ as the spin gyromagnetic ratio and μ_B as the Bohr magneton, is due to the spin-up state's higher energy. The thermal and electromagnetic spreading of energy states in the SET QD must be greater than the Zeeman splitting, E_Z . Thus, in order to perceive the sensing effect, a high magnetic field, $B > 1$ T, and a very low electron temperature, $T_{el} \approx 200$ mK, should be maintained.²⁰²

A phosphorus atom intrinsically gives its bound donor electron a strong confinement potential in silicon. Like phosphorus, in silicon donor atoms bring extra energy states to the SET channel. As already noted, these states can function as isolated "electron sites".²⁰¹ Donor atoms offer a varied and well-defined electron location. This makes the behavior of the SET more predictable and under control than depending on possible fluctuations or channel-owning flaws. The additional energy level introduced by the donor can improve the stability of the single-electron QD, reducing thermal noise and unwanted charge fluctuations.²⁰³ As a result, a set of devices was created and P donors were inserted into a tiny area adjacent to the SET. Three donors are located between 30 and 60 nm away from the SET QD. These donor atoms are tunnel-coupled to the SET QD to achieve a parallel double-quantum dot system. To perform spin readout, the gates of the SET were biased. Then the electrochemical potentials on the SET (μ_{SET}) and a nearby donor were tuned such that the SET current, I_{SET} , was zero when the electron resided on the donor while $I_{SET} \neq 0$ when the donor was ionized.

The gates of the SET are biased in order to achieve spin readout. The electrochemical potentials of the SET (μ_{SET}) and a nearby donor were then adjusted so that, in the absence of an electron on the donor, the SET current, I_{SET} , was zero. In the presence of an electron on the donor, I_{SET} is not zero. There are three phases of the readout mechanism (Fig. 13b right). (1) A load phase is defined as follows: $\mu_{SET} > \mu_{\uparrow\downarrow}$, where an electron from an unknown spin state can tunnel from the donor to the SET QD. I_{SET} decreasing to zero indicates electron loading. (2) A read phase where $I_{SET} = 0$ is caused by a spin-down electron that is trapped onto the donor; nevertheless, $I_{SET} = I_{max}$ can be caused by a spin-up electron that tunnels onto the SET QD. Later the other spin-down electron from the SET QD returns to the donor through a tunnel once more obstructing the current. As a result, at the start of the read phase, the signal's spin state $|\uparrow\rangle$ is just one current pulse. (3) To guarantee that an extra electron with a random orientation can be loaded at the next cycle, the donor is ionized during an "empty" phase.²⁰⁴

Memory devices

There is still more research to be done on the SET and its potential as a memory device. SETs exploit the principle of the Coulomb blockade. This effect essentially restricts the flow of current through a narrow channel (QD) due to the repulsion between electrons. By applying a voltage to a gate electrode on the SET, researchers can modify the number of electrons in the QD. An electron's existence or absence can correspond to a binary state (1 or 0) in a memory unit.²⁰⁵ Due to their small size, SETs offer the potential for very high-density memory compared to conventional transistors. On a chip, the tiny components involved in a SET can be packed far more densely than on conventional transistors. The storage capacity per unit area therefore rises dramatically as a result. By adding or subtracting electrons from the quantum dot, one can create information that can be read by either the presence or absence of

electrons. SETs are perfect for low-power memory uses since their running operation requires little current flow. SETs are inherently resistant to radiation damage, a significant concern for memory units in space electronics.²⁰⁶ The QD's electron count can be difficult to regulate accurately, which increases the risk of read/write errors in the memory unit.²⁰⁷ Researchers are striving to overcome these obstacles right now. Here are some key focus areas: Developing new materials aims to create SETs that operate at higher temperatures. Also, advancements in nanofabrication aim to simplify and reduce the cost of SET production. Methods under investigation are meant to reduce read/write mistakes and guarantee data integrity. SET memory is a promising path for future memory technology, even if the discussed restrictions prevent it from being widely adopted now. Based on SETs, ongoing research might produce low-power, high-density, radiation-resistant memory devices.

Matsumoto *et al.* employed an MTJ (multiple tunnel junction) memory in GaAs operating at 4.2 K to develop the first single-electron memory cell ever purposefully made.²⁰⁸ Using an atomic force microscope, Nakazato *et al.* created a room temperature MTJ single-electron memory. To precisely control a finite quantity of electrons stored on a memory node, Nakazato *et al.* developed a substitute apparatus comprised of a silicon-on-insulator (SOI) multiple tunnel junction (Fig. 14a). Another important aspect of single-electron memory is the need for a very sensitive SET electrometer current to identify the minute charges of stored electrons.²⁰⁹

Due to their minuscule size and low power consumption, single-electronic transistors or SETs are a promising component for the next generation of transistors. More researchers

are focusing on *N*-dimensional multi-QD SETs since single-QD SETs cannot function well at high temperatures. The cited article presents a novel design for single-electron memory.²¹⁰ For memory operation, SETs and a two-dimensional regular array of multiple tunnel junctions (MTJs) on a nanowire make the perfect combination. Thermionic and Coulomb blockade effects play important roles in the system's carrier conduction at ambient temperature. The charge of the memory node is found with a nanowire MTJ electrometer. A properly defined parameter lets individual electrons in tunnel junction circuits be charged at ambient temperature.²¹¹ By sufficiently restricting and regulating electron behavior, quantum dots present a viable path for creating high-density memory systems. Faster read and write speeds and better data retention follow from this compared with conventional memory technology.

Operating conditions

SETs exhibit optimal performance at low operating temperatures and hence often require cryogenic conditions (extremely low temperatures). A key principle behind SET operation is precise control over single electrons.²¹² The energy levels of the SET's conducting channel determine this control since the gate voltage allows for changing of these levels. The irregular thermal mobility of electrons inside the device causes thermal noise, which disturbs this control. Thermal noise becomes more important at higher temperatures, which makes it challenging to separate the random fluctuations resulting from thermal effects from the single-electron energy levels. By lowering the operating temperature, researchers can significantly reduce thermal noise in SETs.²¹³ This allows for clearer distinctions between the discrete energy levels and enables more

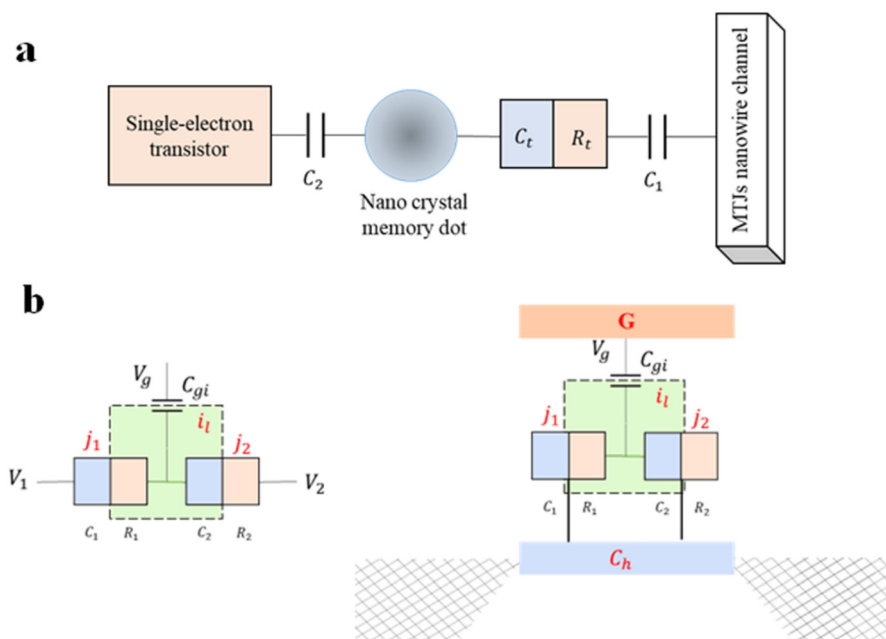


Fig. 14 a. Schematic circuit diagram of a single-electron memory cell. b. Circuit diagram of a SET (left). Circuit implementation of a SET using MOSFET (right).

precise control over single electrons using the gate voltage. A low temperature environment also helps to reduce the leakage current in SETs. Leakage currents, where unintended current flows through undesirable paths, can be a challenge in SETs. Lower temperatures can help minimize these leakage currents, leading to more accurate control over single-electron transport.²¹⁴ Also, a low temperature environment improves the subthreshold swing. The subthreshold swing measures the gate voltage's ability to control the current passing through the SET. Lower temperatures can lead to a steeper subthreshold swing, indicating a sharper transition between the ON and OFF states of the SET.

There are several techniques used to achieve cryogenic temperatures for SETs. One way to implement a low-temperature environment is dilution refrigeration. The temperature can be lowered to a few millikelvin (thousandths of a Kelvin) with this extremely effective method. It utilizes a mixture of two isotopes of helium (He-3 and He-4) to achieve cooling through a complex process involving pressure changes and phase transitions. Dilution refrigerators are expensive, complex to operate and require a pre-cooling stage with liquid helium. The helium-3 refrigeration method uses liquid He-3 to achieve temperatures in the range of 0.3 K.²¹⁵ It is simpler to operate than dilution refrigerators but still requires a pre-cooling stage with liquid nitrogen and liquid helium. A liquid helium bath, involving immersing the SET device in a bath of liquid helium (boiling point around 4.2 K), is a relatively simple and cost-effective approach.²¹⁶ However it does not reach the ultra-low temperatures achievable with other methods. Stirling cycle cryocoolers utilize the Stirling cycle, a closed regenerative thermodynamic cycle, to achieve cryogenic temperatures (around 50 K) using electrical power. They offer a more compact and portable solution compared to liquid-based cooling but may not reach the extremely low temperatures needed for some SET applications.²¹⁷

However the requirement for low-temperature environments in SETs poses several limitations for practical applications in certain environments, making them less suitable for real-world use in many cases. Implementing and maintaining cryogenic cooling systems is complex and expensive. This includes the cost of the cooling equipment itself, the infrastructure needed to operate it (e.g. liquid helium supplies, vacuum pumps) and the expertise required for system maintenance. These factors make SETs less attractive for cost-sensitive applications. Cryogenic systems are often bulky and energy-intensive. This makes it challenging to integrate a large number of SETs into a single device or system, limiting their scalability for applications requiring high-density circuits. Cryogenic cooling systems are not portable due to their size and complexity. This makes SETs impractical for applications requiring mobile devices or operations in remote locations with limited access to cryogenic infrastructure. Maintaining extremely low temperatures can be difficult or even impossible in certain environments such as those with high ambient temperatures or limited power availability. This restricts the use of SETs in these scenarios. SETs are appealing candidates

for application in the development of quantum computing because they have the ability to control individual electrons. However the cryogenic requirement makes large-scale quantum computers using SETs challenging to achieve. SETs' compact size and single-electron control make them potentially capable of providing ultra-dense memory. However the complexity and cost of cryogenic cooling make them less competitive with existing memory technologies for most consumer applications. SETs have the potential for being highly sensitive sensors due to their precise control over single electrons. Their applicability in portable or remote sensing projects is limited nonetheless by the cryogenic requirement.

Challenges and limitations of SETs for charge sensing

Issues due to noise

SETs are well-known for their incredible sensitivity in spotting minute changes in charge. Still, diverse noise sources impede their strive for absolute precision therefore influencing their performance. Various types of noise can influence SETs; each one influences the functioning of the device in a different manner. Electronic noise in the form of burst noise or random telegraph noise (RTN) is present in ultra-thin gate oxide layers and semiconductors. Generally the sub-micrometre device will be subjected to the impact of RTS noise on its operation. Specifically for SETs, as nanoscopic devices, RTN noise may be the major obstacle to their operation. It is caused by a single electron trapping and de-trapping in a defect state, which can lead to undesirable current fluctuations. The fluctuations are caused by switching events that depend on capture and emission events of individual electrons by traps in the gate oxide. Both the channel charge and the channel mobility are impacted by changes in a trap's charge. The oscillations in universal conductance are another source of RTN noise in mesoscopic systems.¹⁵⁸ One characteristic that distinguishes RTN is abrupt step-like transitions between two or more voltage or current levels at random and unpredictable periods. Each offset voltage or current shift may last anywhere from a few milliseconds to many seconds. Thermal fluctuations of the SET might arbitrarily trap and release charge carriers. This takes place at fault sites or transistor interfaces. The random trapping and release of charges cause the current measured by the SET to vary. RTN causes undesired noise in the SET's signal therefore compromising the accuracy of the ultra-sensitive charge detecting capacity. Then thermal noise is produced due to thermal vibrations of atoms, which can create noise in the SET. This may cause very small changes in the current passing through the apparatus, which would compromise the measurement precision of the charge. Additionally, the statistical character of electron flow is the source of shot noise.¹⁴¹ When electrons tunnel through tunnel barriers, they produce that shot noise. Typically, a two-junction configuration without a gate produces shot noise. Even in a constant current, electrons do not arrive perfectly uniformly, leading to

slight random fluctuations. This phenomenon resembles water dripping from a leaky faucet – there will be occasional spurts and drips, not a perfectly smooth flow. Finally, flicker type noise has a specific frequency dependence and can mask the desired signal from the SET. It characterizes noise in which the inverse relationship between frequency and power spectral density leads to a $1/f$ dependence. This indicates that as the frequency increases, the noise level progressively decreases from a higher level at lower frequencies. Flicker noise appears when the SET frequency drops below 1 kHz. It is common to observe deviations from a $1/f$ spectrum typically in conjunction with telegraph noise. Variations from a $1/f$ spectrum are frequently observed, usually in combination with telegraph noise. Flicker noise occurs when electrons make random transitions at a single trap.²¹⁸ A single trap can introduce significant noise into a SET, limiting its accuracy and performance at the single-electron level. A trap is a flaw or imperfection in the SET's conducting channel or insulating layer. Like little capacitors, these traps can capture or release electrons. When an electron is trapped or released from a trap, the local charge distribution inside the SET changes suddenly. This charge change could throw off the fragile single-electron transport equilibrium.

One important metric that aids in comprehending how noise impacts the sensitivity of SETs is the signal-to-noise ratio (SNR). The signal-to-noise ratio or SNR is defined as the signal volume divided by the noise level. A low SNR makes it challenging to discern the signal from the noise, whereas a high SNR indicates that the signal is distinct and easy to see. High noise levels cause the faint signal from the small charge shift to be buried. The SET thus battles to separate the real signal from noise-induced random variations. High noise levels essentially lower a SET's sensitivity since it depends on identifying these little changes in charge. To be seen over the noise, a higher signal is needed; hence the range of charge changes the SET can consistently detect is limited.

Noise mitigating techniques. To lower noise even more and enhance SET performance, researchers are always investigating novel materials, manufacturing methods and device designs. Furthermore, developments in cryogenic cooling technology could make ultra-low temperature functioning practically possible. By implementing these strategies, scientists aim to create SETs with significantly lower noise levels, unlocking their full potential for ultra-sensitive charge sensing in various fields from medical diagnostics to quantum computing. The RTN noise can be mitigated by modifying the structure of a SET to model a trap in the gate oxide of a MOSFET (Fig. 14b). The quantization of the trapped energy is undoubtedly something that should be considered in a thorough treatment. However we disregard quantization and use the so-called “orthodox theory” of single-electron tunneling to illustrate the key aspects of the model. The trapped charge varies and the trap and channel may trade one electron back and forth. The channel charge and the channel mobility are impacted by the discrete variations in the trap charge. As a result, the MOSFET experiences RTN. This altered structure explains why gate

voltage and temperature have a significant influence on the duty cycle and the existence of random telegraph signals in MOSFETs.¹⁴²

A theoretical modeling of the Debye–Lorentzian distribution can help reduce flicker noise. The $1/f$ noise behaviour in SETs is simulated using a mathematical function known as the Debye–Lorentzian distribution. The Debye function captures the low-frequency feature of the noise, which is a gradual reduction in noise power density with increasing frequency. The Lorentzian function represents the noise's high-frequency behaviour, where the noise power density falls off more quickly at higher frequencies.²¹⁹ Researchers can determine the primary noise sources in their SET devices by applying the Debye–Lorentzian distribution to analyse the $1/f$ noise spectrum. And one can develop strategies to minimize $1/f$ noise and improve the performance and reliability of SETs. A SET can only allow consecutive electron transmission because of the Coulomb barrier. For symmetric tunnel couplings, this results in a minimal Fano factor of $F_{\text{SET}} = S/S_P = 0.5$. Therefore, shot noise measurements provide a profound understanding of the underlying physical mechanisms of a system. More time correlations between the tunneling events are needed in single-electron devices in order to further reduce shot noise. One method is to use turnstiles and single-electron pumps to drive the tunneling process on a periodic basis, catching and releasing one electron every cycle. However, the random fluctuations of the underlying quantum mechanical tunneling process are not well-absorbed by these open-loop devices, which inevitably causes shot noise to rise.²²⁰

Given noise is the main issue impeding SETs' ultimate sensitivity, researchers have developed several approaches to address it. Using materials with fewer flaws and higher purity will help reduce charge-trapping sites that support RTN. Optimizing the SET's geometry such as channel size and gate control will reduce noise sensitivity.²²¹ Precise control during fabrication ensures consistent device characteristics and minimizes unwanted variations that can introduce noise. Cooling the SET to cryogenic temperatures significantly reduces thermal noise, improving the SNR. However this approach has limitations for practical applications. Applying specific voltage pulses to the SET's gate can help average out some noise sources like RTN, leading to a more stable signal (gating technique). Using filters designed for specific noise frequencies can help remove unwanted components from the SET's output signal.²²² Designing low-noise readout electronics minimizes additional noise introduced during signal processing and amplification. Carbon nanotube SETs offer the potential for reduced RTN due to their unique properties. Double-QD SET design can improve noise immunity compared to traditional SETs.¹⁷³

Integration challenges

Integrating SETs with other electronic components for complex sensing systems presents several challenges. SETs often require specialized materials with unique properties different from those used in conventional electronics. This can

make it difficult to integrate them seamlessly with standard CMOS (complementary metal–oxide–semiconductor) processes used for most electronic components. Creating reliable and low-resistance electrical connections between SETs and other components can be difficult. Interface problems can lead to unwanted noise and degraded performance.²²³ Most SETs, as already stated, currently need cryogenic temperatures to function best. The integration of them with other components that usually run at room temperature is a major difficulty. Designing and running a system including room-temperature and cryogenic components increases complexity. The weak signal from a single electron in a SET needs to be amplified and converted into a usable signal for further processing. Designing and integrating low-noise, high-fidelity readout electronics specifically for SETs can be a challenge. SETs are highly sensitive to noise, which can disrupt their operation. Integrating them with noisy components or operating them in noisy environments can significantly impact their performance and reliability.²²⁴

The 3D integration and heterogeneous packaging are novel integration techniques that offer advantages over traditional planar integration methods for electronic devices. The 3D integration technique involves stacking multiple layers of integrated circuits (ICs) vertically on top of each other, creating a three-dimensional circuit structure. Interconnections between layers are made through holes etched through the layers and microbumps (tiny solder joints). 3D stacking allows for more components to be integrated within a smaller footprint, which is crucial for the miniaturization of complex sensing systems.²²⁵ By placing components closer together vertically, 3D integration reduces interconnection lengths between SETs and other components. This minimizes signal delays and improves overall system performance. Heterogeneous integration allows for the stacking of different types of ICs including SETs fabricated on specialized materials with conventional CMOS components on separate layers. This enables the integration of SETs with other electronic components despite potential material mismatches.²²⁶

The heterogeneous integration approach focuses on packaging pre-fabricated ICs or individual electronic components together using advanced packaging techniques.²²⁷ Unlike 3D integration, the components are not necessarily stacked vertically but can be arranged in a more flexible way within the package. Heterogeneous packaging allows for a modular approach where SETs fabricated on their optimal materials can be integrated with pre-fabricated CMOS readout electronics or other components in a single package. This simplifies the overall fabrication complexity. Developments in high-density low-parasitic interconnects, miniaturized packaging materials and advanced thermal management solutions will improve the capabilities of heterogeneous packaging for integrating SETs with different components. This offers more flexibility in terms of component placement and routing compared to 3D stacking.²²⁸

Beyond 3D integration and heterogeneous packaging, there are a few other emerging techniques being explored for inte-

grating SETs with other electronic components. The nanowire integration technique utilizes nanowires, which are extremely thin semiconductor wires, to fabricate SETs and interconnect them with other components. Nanowires can be made from various materials, including silicon gallium nitride or carbon nanotubes. Nanowires can be grown and patterned with high precision, allowing for flexible integration with other components on a variety of substrates.²²⁹ However forming reliable and low-resistance electrical connections between nanowire SETs and other components can be challenging due to their small size. Another technique is transfer printing. This technique involves fabricating SETs on a sacrificial substrate and then transferring them onto another substrate where they are integrated with other electronic components. This makes it possible to optimize the SET fabrication process and system integration as a whole independently. Another solution is the integration of SET with the CMOS technique.²³⁰ This approach aims to develop fabrication processes that allow for the simultaneous fabrication of SETs and conventional CMOS (complementary metal–oxide–semiconductor) components on the same chip. This would significantly simplify integration and potentially reduce overall system costs.

While integrating quantum mechanics devices with conventional electronic devices, one of the major issues is combining low-temperature devices with room temperature control unit/readout circuits. Thus integrating low-temperature SETs with room-temperature devices presents several significant challenges that hinder the development of practical SET-based systems. SETs typically operate at cryogenic temperatures (around 4 K or -269 °C) to minimize thermal noise. However, most electronic components are designed to function at room temperature (around 300 K or 27 °C). This vast temperature difference leads to a significant thermal expansion mismatch between the materials used in SETs and room-temperature devices. As the temperature changes, the materials in the system expand or contract at different rates. This may result in physical harm as well as tension and strain where the SET interacts with other components, which could impair the SET's functionality. SETs are highly sensitive to noise. Readout electronics operating at room temperature might introduce additional noise that could disrupt the weak signal from the SET, requiring specialized low-noise designs for reliable signal processing. The characteristics of readout electronics can change with temperature. This can lead to calibration and performance issues when interfacing with a cryogenic SET.

One remaining major challenge is interfacing low-temperature SETs with room-temperature electronics. Ongoing materials science thermal management integration and room-temperature SET development research promises to overcome these obstacles nevertheless. The development of advanced materials with minimal thermal expansion coefficient mismatch between the SET and other components could reduce stress and strain issues. In addition to that, techniques like 3D integration or heterogeneous packaging could potentially minimize the physical separation between the SET and other components, reducing thermal gradients and signal degra-

dation. Similarly, developing low-noise high-fidelity readout electronics specifically designed for interfacing with cryogenic SETs is crucial for reliable signal processing. If not, the most significant remedy would be creating SETs with room temperature efficiency. This would simplify integration with other components and remove the need for intricate cooling systems.

To develop more integrable SET based sensors, recent research work has moved to cryo-CMOS implementation.²³¹ An integrated circuit that is specifically made to function at very low temperatures, usually around 4 K (−269 °C), is known as a cryogenic CMOS. Since SETs can regulate single electrons, they have extraordinary sensitivity. But the necessity for cryogenic cooling systems now limits their useful utilization, particularly in sensor development. This limits their portability and increases complexity and cost. For interacting with SETs in sensor systems, a cryogenic CMOS is a possible answer. Cryo-CMOS circuits are specifically designed to function efficiently at very low temperatures similar to the operating environment required for SETs. Cryo-CMOS technology helps to build control and readout circuitry for SETs able to operate in the same cryogenic environment. This simplifies system design and might increase the general performance by removing the requirement for a sophisticated interface between SETs and room-temperature circuits. In SETs, as well as cryo-CMOS circuits, cryogenic temperatures greatly lower thermal noise. This reduces noise interference with the SET's weak signals, thereby producing more dependable and precise sensor data. Cryo-CMOS circuits can be designed to perform signal amplification filtering and data conversion within the cryogenic environment. This reduces the need for additional room-temperature electronics, leading to more compact and integrated sensor systems.²³²

But cryo-CMOS technology is still under development and commercially available options might be limited. Continuous research aims to raise the performance and manufacturing feasibility of cryo-CMOS circuits. Designing and fabricating cryo-CMOS circuits can be complex and expensive compared to standard CMOS processes. The whole sensor system—including cryo-CMOS components and SETs—must be built to operate within the cryogenic environment. This calls for sensible packing techniques and heat control. Before a cryo-CMOS is extensively applied in SET-based sensor applications however, problems with cost scalability and complexity of system design still have to be addressed. A cryo-CMOS offers a valuable approach for overcoming the limitations of SETs in sensor development by providing control and readout circuitry that can operate efficiently at cryogenic temperatures. While challenges remain, ongoing research holds promise for a cryo-CMOS to become a key enabler for next-generation, highly sensitive and miniaturized SET-based sensors.

Other quantum sensor technologies

Nitrogen vacancy (NV) centres in diamond. The NV centre is actually a point defect in the diamond crystal lattice with a nitrogen atom instead of a carbon atom and it has a nearby vacancy state because of the missing carbon atom. This defect

in the diamond structure can provide unique quantum properties. According to its electron spin state, the NV centre can emit light due to its photoluminescence property. By measuring the light signal, the spin state can be read. This NV centre's spin state is highly sensitive to external factors like magnetic fields, electric fields, temperature and strain. Due to their sensitivity, NV centres are used to create exact sensors for measuring magnetic fields, electric fields, temperature and pressure at the nanoscale.²³³ The NV centre has two main energy levels, namely, the ground energy state and excited energy states. The energy levels of the NV centre's spin states are sensitive to electric fields. When a charged object is brought near to the NV centre, it creates an electric field and this field perturbs the NV centre's energy levels. This perturbation affects the NV centre's spin state, which means a transition occurs between these energy states. And it alters its fluorescence intensity, which involves the absorption and emission of light. Specifically, the NV centre can absorb green light and emit red light. By monitoring the fluorescence intensity and changes in the electric field, the presence of nearby charges can be detected (Fig. 15a).

Generally, NV centres can be made by implanting nitrogen atoms and by an annealing process. Also microwaves are used to manipulate the NV centre's spin state and laser used to read the spin state through fluorescence. The changes in fluorescence intensity can be correlated to the amount of charge present. Techniques like dynamic decoupling can be used to enhance the sensitivity of NV centre charge sensors. By applying specific microwave pulse sequences, the NV centre's spin coherence time can be extended, leading to improved sensitivity.²³⁴ However, in the case of the NV centre, the readout mechanism is based on optical signals, which measure changes in fluorescence intensity. Hence, the NV centre requires optical and microwave instrumentation. But the SET readout mechanism relies on electric signals, which are measured in terms of voltage or currents. Thus the SET leads to relatively straightforward electrical signal processing.

Trapped ions. When charged atoms or molecules are confined in a space using electromagnetic fields, this is called ion trapping. This is typically achieved using Paul traps or Penning traps. Due to the confinement effect, the trapped ions have well-defined electronic states and motional states. These two well-defined states of the trapped ion can be controlled and manipulated. If the trapped ion is affected by an electric field, it exerts a force on the ions and affects the motion and electronic states of that trapped ion. The Stark effect is another way that the electric field can alter the electronic energy levels of the ions. They have high sensitivity because they can hold these quantum states for long stretches of time.²³⁵ High-precision measurements of the read-out mechanism of trapped ion quantum states can be made with lasers and microwaves. Because the energy levels and motional states are precisely defined, very small changes in the electric field can be detected (Fig. 15b).

In practice, a single ion can be trapped in an electromagnetic field. The first quantum state is initialized using a laser.

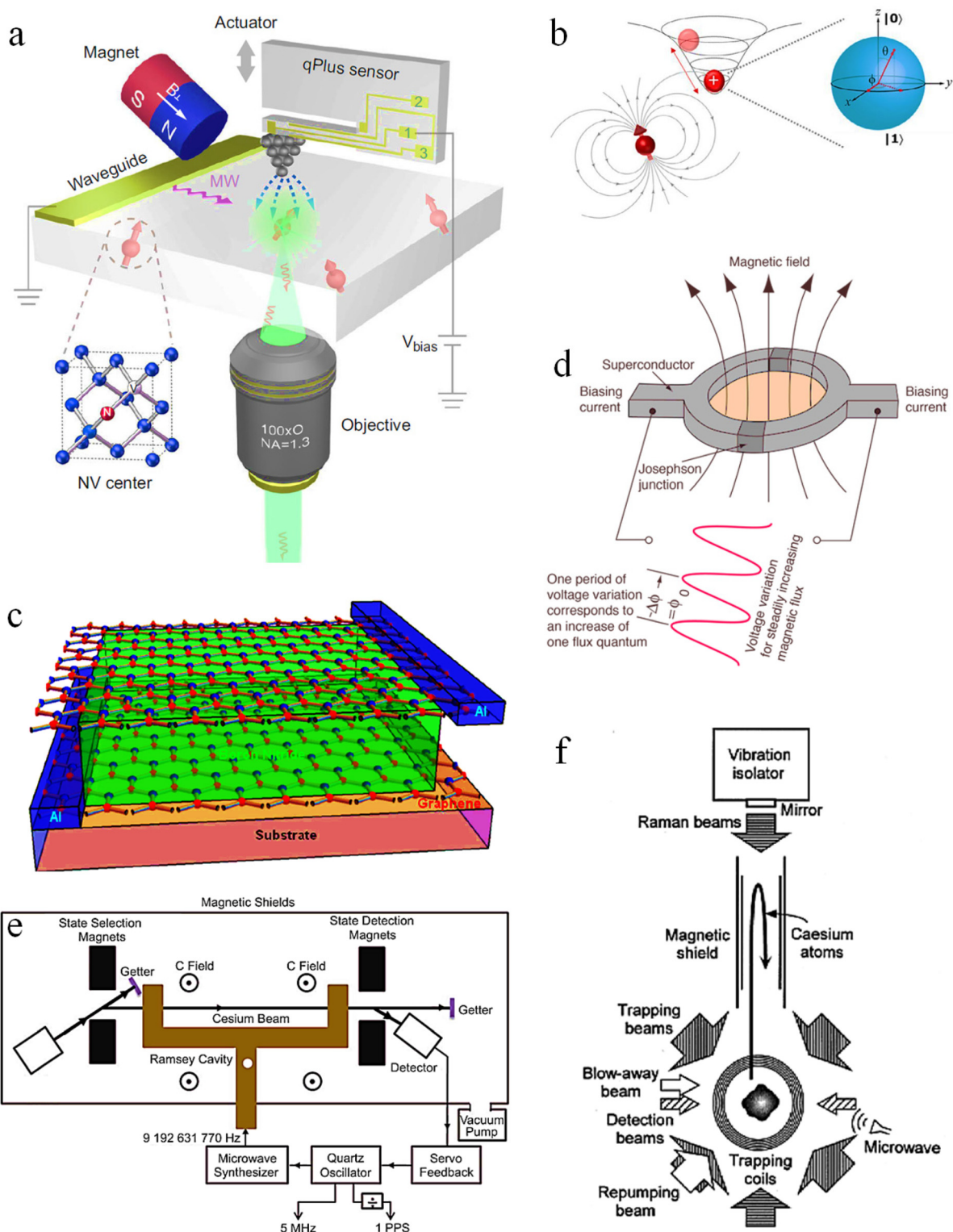


Fig. 15 a. Principle of the NV centre for measuring a magnetic field (this figure has been reproduced from ref. 234 with permission from Springer Nature copyright 2024). b. Trapped-ion quantum sensor (this figure has been reproduced from ref. 235 with permission Springer Nature copyright 2024). c. Schematic of quantum capacitance spectroscopy (this figure has been reproduced from ref. 236 with permission from Springer Nature copyright 2024). d. Illustration of a superconducting quantum interference device (SQUID). e. Block diagram of a cesium atomic clock (this figure has been reproduced from ref. 237 with permission from Springer Nature copyright 2024). f. Diagram of an atomic interferometer gravimeter (this figure has been reproduced from ref. 238 with permission from Taylor & Francis copyright 2024).

Then the electric field to be measured is applied to the trapped ion. The lasers are used to probe the trapped ion state and the change in state indicates the presence and strength of the electric field. In the case of a charge sensor, any nearby charge will generate an electric field that influences the trapped ion. The sensor is calibrated by applying known electric fields and measuring the corresponding changes in the ion's state. Thus trapped ions are more stable but require complex optical systems for the read-out mechanism. But SET provides a direct and simple read-out system. However, the coherence time in SETs can be limited by noise and environmental factors.

Quantum capacitance spectroscopy (QCS). Quantum capacitance spectroscopy (QCS) harnesses the quantum nature of charge carriers to probe the electronic properties of materials and devices for analysing nanoscale devices. In classical capacitance, the charge stored in a conductor is proportional to the applied voltage ($Q = CV$). But the quantum capacitance is directly related to the density of states of the charge carriers. Changes in the density of states due to factors like charge doping or confinement affect the quantum capacitance (Fig. 15c). The QCS measures capacitance changes of a device as a function of applied voltage or other physical parameters such as electric field, magnetic field and temperature. This change of capacitance will provide information regarding the electronic structure of the device, including density of states, energy levels and charge distribution. Because the quantum capacitance is sensitive to changes in charge distribution, it can be used to detect very small charge fluctuations.²³⁹

Initially, a nanoscale device based on a quantum dot, nanowire, or 2D material structure is fabricated with electrodes. Then the applied voltage is provided and the respective capacitance is measured. A voltage is swept across the device and the capacitance is measured as a function of voltage. Changes in the capacitance signal indicate changes in the charge distribution within the device.²³⁶ QCS can achieve high sensitivity because it directly probes the quantum nature of charge carriers. QCS can be a non-invasive technique, as it does not require a direct current flow through the device. QCS can provide an overview of the electronic structure, while SETs can provide detailed information about individual charge states and tunneling events.

SQUIDs (superconducting quantum interference devices). A SQUID is actually a magnetometer and it acts as a quantum sensor. SQUIDs rely on the principles of superconductivity, a state where certain materials exhibit zero electrical resistance below a critical temperature. Superconductors actively repel magnetic fields, which is why they can cause magnets to levitate. This expulsion of a magnetic field is called the Meissner effect. Also SQUIDs are based on the Josephson effect, a phenomenon that occurs when two superconductors are separated by a thin insulating layer. But Cooper pairs of electrons can tunnel through this barrier, creating a supercurrent. The supercurrent is highly sensitive to magnetic fields. The most common type of SQUID is the DC SQUID, which consists of a superconducting loop interrupted by two Josephson junctions.

And the RF SQUID is another type of SQUID, which consists of a single Josephson junction in a superconducting loop (Fig. 15d).

A SQUID essentially consists of a loop made of superconducting material. This loop is crucial for the device's ability to detect extremely subtle changes in magnetic fields. Within this superconducting loop, there are one or more Josephson junctions. These junctions are weakly coupled to the superconducting circuit created by thin insulating barriers between superconducting materials. The Josephson junctions make the SQUID so sensitive. They allow for the quantum mechanical tunneling of superconducting electrons. When a magnetic field is applied to the SQUID loop, a circulating current is induced within the loop. The Josephson junctions cause interference effects in this current, which are highly sensitive to even the tiniest changes in the magnetic flux passing through the loop. By measuring these interference effects, the strength of the magnetic field can be determined with incredible precision. SQUIDs can be used as sensitive detectors for manipulating and reading out quantum information. SQUIDs are primarily designed to measure magnetic fields, and SETs are primarily for electric charge. Both quantum sensor technologies require a cryogenic operating temperature but they are meant for different purposes.

Atomic clock. The atomic clock known for its exceptional accuracy in measuring time, and it can also act as a highly sensitive quantum sensor. Atoms have discrete energy levels. Transitions between these levels occur at specific frequencies. These transition frequencies are highly stable and reproducible, making them ideal for use as frequency standards. Atomic clocks typically use microwave transitions between hyperfine energy levels in atoms like cesium, rubidium or hydrogen.²³⁷ But in the case of optical atomic clocks, these use laser transitions between electronic energy levels, which have even higher frequencies and potentially higher accuracy. Atoms are prepared in a vacuum chamber with a specific quantum state. A microwave or laser is applied to the atoms tuned to the specific transition frequency. It gauges the response of the atoms to the applied field. If the field frequency is the same as the atomic transition frequency, the atoms will change their quantum state. A feedback loop adjusts the frequency of the applied field to optimize the amount of atoms that go through the transition. This ensures that the field's frequency is precisely locked to the atomic transition's frequency. The frequency of the locked field is then used to generate a very stable time signal (Fig. 15e).

The time is measured by counting the number of oscillations of these atomic transitions. The transition frequencies of atoms are sensitive to external fields such as a magnetic field, an electric field, the gravitational field and temperature. Because atomic clocks can measure frequency with extremely high precision, they can detect very small changes in these external fields. Atomic clocks and single-electron transistors (SETs) are both highly precise quantum devices, but they operate on vastly different principles and are designed for distinct purposes. Atomic clocks are optimized for precise time

and frequency measurements, leveraging the stability of atomic transitions. SETs are optimized for detecting minute changes in electric charge, leveraging the controlled tunneling of single electrons. Atomic clocks are very stable and are used as a standard where SETs are very sensitive to charge changes.

Atomic interferometer. Atomic interferometers are fascinating quantum sensors that exploit the wave-like nature of atoms to achieve extremely precise measurements. The wave-like nature means atoms can behave as both particles and waves. Interferometry involves splitting a wave into two or more paths, allowing those waves to propagate and then recombining them. The interference pattern that results from recombination reveals information about the phase difference between the waves, which is influenced by the environment along the paths.²³⁸

Usually when deploying lasers, atoms are chilled to extremely low temperatures, producing a cloud of cold atoms or possibly a Bose–Einstein condensate (BEC). This is essential to improve an atom's wave character. “Mirrors” and “beam splitters” for the atom waves are laser pulses (Fig. 15f). These laser pulses separate and recombine the momentum states of the atoms through manipulation. The atoms are in a quantum superposition, meaning they exist in several states concurrently and follow several routes simultaneously. As the atoms propagate along their respective paths, they accumulate a phase that depends on the forces and fields they encounter such as gravity, acceleration, rotation and magnetic fields. The atom waves are then recombined and the resulting interference pattern is measured. The interference pattern reveals

the phase difference between the waves, which is directly related to the forces or fields that are present. Atom interferometers are extremely sensitive to minute changes in forces and fields due to the high precision with which the phase of atom waves can be measured. Thus atomic interferometers and single-electron transistors (SETs) are optimized for measuring forces related to motion and gravity by utilizing the wave properties of atoms. SETs are optimized for measuring electric charge by utilizing the controlled flow of individual electrons. They are both very sensitive quantum tools that are used in very different applications. Table 7 provides a comparison between different quantum sensor technologies with SETs.

Future outlook and potential developments

Exploring novel materials for advanced SET charge sensing

Advancements in SET technology for charge sensing are focused on overcoming two main hurdles: achieving room-temperature operation and improving integration with other electronic components. For this, researchers are investigating low-noise materials with inherently lower thermal noise.²⁴⁰ The unusual electrical characteristics of 2D materials like transition metal dichalcogenides or graphene nanoribbons show promise for enabling SETs to function at higher temperatures. Tunable bandgap, high strength, flexibility, strainable electronics and layer structures are some of the distinctive features

Table 7 Comparative analysis of quantum sensors and SETs

Technology	Principle	Sensitivity	Primary applications	Operating conditions	Strengths	Limitations
Single-electron transistors (SETs)	Coulomb blockade	Extremely high (charge)	<ul style="list-style-type: none"> • Charge sensing • Ultra-sensitive electrometers • Advanced electronics 	Typically cryogenic	<ul style="list-style-type: none"> • Exceptional charge sensitivity 	<ul style="list-style-type: none"> • Cryogenic operation • Fabrication complexity
Atomic clocks	Atomic transition frequencies	Extremely high (time)	<ul style="list-style-type: none"> • Timekeeping • Navigation (GPS) 	Varies (can be robust)	<ul style="list-style-type: none"> • Unparalleled time accuracy 	<ul style="list-style-type: none"> • Complexity of atomic physics techniques
NV centers in diamond	Spin properties of NV defects	High (magnetic fields <i>etc.</i>)	<ul style="list-style-type: none"> • Magnetic field sensing • Biological imaging • Materials science 	Room temperature	<ul style="list-style-type: none"> • Room-temperature operation • Versatile sensing 	<ul style="list-style-type: none"> • Sensitivity can vary depending on application
SQUIDS	Superconducting loops	Extremely high (magnetic fields)	<ul style="list-style-type: none"> • Medical imaging (MEG) • Geophysical surveys 	Cryogenic	<ul style="list-style-type: none"> • Exceptional magnetic field sensitivity 	<ul style="list-style-type: none"> • Cryogenic operation
Atomic interferometers	Wave nature of atoms	High (acceleration rotation)	<ul style="list-style-type: none"> • Navigation • Gravity measurements • Geodesy 	Varies	<ul style="list-style-type: none"> • High accuracy in inertial force measurements 	<ul style="list-style-type: none"> • Complex setups
Quantum photonics	Single and entangled photons	High (light magnetic fields)	<ul style="list-style-type: none"> • LIDAR • Optical sensing • Medical imaging 	Varies	<ul style="list-style-type: none"> • High precision optical measurements 	<ul style="list-style-type: none"> • Complex optical setups

that make transition metal dichalcogenide (TMDC) materials a good choice for SETs with increased charge sensitivity.²⁴¹ A monolayer 2D material with a direct bandgap allows for efficient electrostatic gating compared to a bulk 2D material with an indirect bandgap. This suggests that the gate voltage can efficiently regulate the energy levels inside the 2D material channel, hence influencing electron transport. Thus the direct bandgap of the 2D material improves gate controllability, reduces the leakage current and obtains a sharper Coulomb blockade.¹⁶²

Similarly new gate dielectric materials with minimal intrinsic noise are being investigated to reduce noise contributions and improve signal fidelity from the SET. Traditional materials often require extremely low temperatures (around 4 K or -269 °C) for efficient SET operation. New materials aim to enable SETs to function at higher temperatures closer to room temperature.²⁴² Minimizing intrinsic noise levels within the dielectric material is crucial for accurate and reliable charge sensing in SETs. Some of the new dielectric materials are hafnium lanthanum oxide, aluminum oxide, zirconium oxide and perovskites. Hafnium lanthanum oxide offers a potential combination of high dielectric constant (k) and good bandgap properties, leading to improved gate control and reduced leakage currents in SETs. Aluminum oxide improves the charge sensing property by reducing defects and interface traps.²⁴³ This can minimize noise levels and potentially enable higher temperature operation. Zirconium oxide is being investigated for its potential to reduce gate leakage currents and improve overall SET performance.²⁴⁴ Generally high- k dielectric materials such as perovskites, hexagonal boron nitride and TMDCs offer a wide range of possibilities with varying chemical compositions. Researchers are exploring specific perovskite compounds with high dielectric constants that can improve gate control over single electrons in SETs. However challenges remain regarding interface quality and stability. TMDC materials like MoS₂ and WS₂ offer unique electronic properties and are being explored for their potential application as gate dielectrics in SETs.²⁴⁵ Research is ongoing to understand their suitability and integration challenges.

Optimizing SET device architectures for next-generation charge sensing

The charge sensing behaviour can also be improved by optimizing the SET device design. To realize this, the QD size or channel size should be made small as possible because SETs with smaller channel dimensions strengthen the Coulomb interaction between electrons. This makes them less susceptible to thermal noise, even at higher temperatures, leading to more robust charge sensing. However there are significant fabrication challenges associated with shrinking the channel size of SETs. Current photolithography techniques have limitations in achieving extremely small feature sizes (below 10 nm). This can make it difficult to fabricate precise and uniform channel dimensions for SETs. While EBL offers higher resolution, it is a slow and expensive process, making it impractical for the

large-scale production of SETs with very small channels. New techniques like extreme ultraviolet (EUV) lithography or directed self-assembly hold promise for achieving smaller feature sizes and more precise patterning during fabrication. When the resolution of the QD is made small enough, defects and impurities at the atomic level within the channel can significantly impact the electrical properties of the SET, leading to increased noise, unreliable behaviour and reduced sensitivity. As channel sizes shrink, even a few defects or impurities can have a more significant impact. Precise control over material purity and defect minimization during fabrication becomes crucial. To get rid of material defects and impurities, material growth techniques should be advanced. Moreover, the size reduction will lead to short-channel effects in SET devices. In very small channels, quantum mechanical tunneling effects can lead to increased leakage currents, even with good material quality. This can negate the benefit of reduced leakage currents expected with smaller channels. Thus, this effect weakens the Coulomb blockade effect, reducing the ability to control single electrons and potentially compromising the core functionality of the SET. For this, careful channel engineering should be required for optimizing the channel geometry and exploring alternative materials with superior properties at the nanoscale could help mitigate short-channel effects and maintain a strong Coulomb blockade, even in smaller channels. The nanoscale fabrication faces some integration challenges, such as interconnection issues and yield issues. Connecting very small SET channels with other components like electrodes or leads becomes increasingly challenging as the dimensions shrink. This can lead to reliability issues and performance degradation. Fabrication challenges at the nanoscale can significantly impact the yield (percentage of successfully fabricated devices) of SETs with very small channels. This can increase the cost and limit the practicality of mass production. To overcome these issues, exploring alternative fabrication methods like bottom-up approaches or self-assembly techniques might offer new possibilities for creating highly precise and defect-free SET channels with smaller dimensions.

Towards room-temperature functionality in SET-based charge sensors

Another level of research is on investigating less susceptible to temperature variations as alternative approaches for managing single electrons. This can include light-gated SETs, which achieve room-temperature operation by means of light pulses to control electron flow, hence perhaps eliminating the requirement for cryogenic cooling.²⁴⁶ By changing the electron spin states instead of charge, spin-based SETs thus present a possible temperature-independent approach for charge sensing. Furthermore, advanced fabrication techniques like atomic layer deposition (ALD) are needed to enhance the SET's performance. With this method, the insulating layer and gate dielectric can be precisely controlled, which could lower leakage currents and enhance SET performance generally at higher temperatures, resulting in more precise charge sensing.

3D integration strategies for next-generation SET sensors

Recently, there has been a lot of interest in the heterogeneous integration of various crystalline materials because of their promise for high-performance electrical systems. 3D heterogeneous integration (3DHI) is a promising packaging technology for creating advanced SETs with enhanced functionality and performance.²²⁸ This 3D heterogeneous integration overcomes limitations posed by traditional 2D scaling. By stacking devices vertically, 3DHI enables better space utilization, improved performance and enhanced functionality. But 3DHI will dissipate heat, which becomes critical in densely packed 3D structures.²⁴⁷ 3DHI requires vertical interconnects, which are essential for signal and power distribution, while coordinating different technologies needs careful development. 3DHI can lead to mixed-signal systems by combining analog and digital components. And it incorporates sensors with SET based circuits.²²⁵ Also this feature can develop stacking memory and logic layers. Researchers continue to explore 3DHI for SETs aiming for efficient and powerful electronic systems. Heterogeneous 3D integration offers a path toward more efficient and compact electronic devices by vertically combining different technologies, including SETs.

Emerging applications for advanced SET-based charge sensing

SETs hold immense potential for revolutionizing various scientific fields, especially biology and medicine, due to their exceptional sensitivity in detecting and manipulating single electrons. Because of their incredibly high sensitivity, SETs are perfect for identifying even the smallest alterations in electrical signals brought on by the presence of biomolecules. SETs can be used to find and measure particular biomolecules, such as proteins, DNA or disease-related biomarkers. This has potential applications in early disease diagnosis, drug discovery and personalized medicine. Multiple biomolecules can be detected concurrently by highly sensitive biosensors made from arrays of SETs. This has potential applications in disease profiling, monitoring cellular processes and environmental monitoring for biohazards. Because SETs have great sensitivity in identifying electrical impulses from neurons or muscles, they could be included in prosthetic limbs or brain-computer interfaces to offer a more natural and exact control interface.

Moreover, allowing real-time monitoring and pollution management makes sense, since SET-based sensors can identify dangerous compounds or trace amounts of contaminants in the surroundings. SETs allow one to explore individual molecular features, therefore providing insights into their behavior and interactions.¹⁷⁴ This could be crucial for developing new materials, catalysts and drugs. SET-based sensors can be designed to detect specific chemicals at trace levels, enabling real-time monitoring of environmental pollutants, hazardous materials or chemical reactions. SETs can be used to study the electrical properties of materials at the nanoscale, leading to the creation of novel materials with the necessary properties.

The charge detection ability of the SET has been involved in the invention of many physics and quantum technologies. SETs are useful for single-electron exploration of basic physics concepts like quantum mechanics and electron tunneling. The basic building block of quantum computing is the qubit, which is made from SETs. Their suitability for producing very exact and coherent quantum states stems from their control of single electrons. SETs allow one to investigate and control electron spin as a possible path for future spintronic devices with new purposes. And SET sensors can be used in electronics and nanotechnology for ultra-low-power electronics, high-density memory devices and as next-generation sensors. SETs require minimal power to operate, making them ideal for developing low-power electronic devices with extended battery life. This is especially important for internet of things (IoT) applications and wearable electronics. Because SETs control single electrons, they provide the possibility to design ultra-dense memory devices with very small feature sizes. Miniaturization, great sensitivity and the ability to detect a broad spectrum of physical, chemical and biological signals are all possible with SET-based sensors. This could revolutionize various sensing applications. And SETs can be integrated into imaging devices to capture high-resolution images with superior sensitivity, potentially leading to advancements in medical imaging and scientific research.

Brief future pathways

In this section, some of the notable scope for future research and current research directions are described. An important research direction is related to noise, which arises in the SET. The noise signals in the SET device hinder the range of sensitivity. A deeper understanding of noise mechanisms in SETs is crucial for achieving reliable and high-performance operation, especially for practical applications beyond cryogenic temperatures. A theoretical understanding of noise behaviour for SET operation has to be studied and analysed. For this, developing accurate models and simulations of noise mechanisms in SETs is crucial for understanding their impact and identifying effective mitigation strategies. Applying advanced quantum transport theory to model the behaviour of electrons in SETs can provide insights into noise generation mechanisms at the fundamental level. Thus, current research focuses on understanding the theoretical background of noise impacts on SETs. As mentioned previously, device design optimization is also fascinating for SET charge sensors. For this, researchers are exploring and optimizing device design. Smaller channels can improve noise performance but require precise fabrication techniques and mitigation of short-channel effects. In addition to that, the double-dot design has attracted much attention.²⁴⁸ This design introduces an additional closely spaced conducting region (QD) adjacent to the main channel, forming two closely spaced dots. A gate electrode can be applied to each dot or a single gate can be used to control both dots simultaneously. These designs can enhance control over single electrons, potentially improving the noise perform-

ance at higher temperatures compared to single-dot designs.²⁴⁹

Another important research direction involves improved readout electronics and signal processing units. Read-out electronics is essential for real-time applications. Even though the operation of SETs is carried out at cryogenic temperature, the read-out mechanism is based on room temperature.²³¹ Thus, low-noise, high-fidelity readout electronics have been specifically designed for SETs to minimize noise introduced during signal processing. Integrating low-noise readout circuits with standard CMOS technology can facilitate on-chip signal processing and miniaturization of SET-based sensors and is an active research area. Concurrently, studies are being carried out to explore progressively intricate techniques for noise cancellation with the goal of improving the signal-to-noise ratio in SET readout circuits. In SET technology, temperature-compensating readout is a critical approach for ensuring reliable and accurate signal detection, especially as SETs are increasingly explored for applications beyond cryogenic temperatures. The electrical characteristics of SETs, particularly the threshold voltage and tunneling current, are sensitive to temperature variations. This can lead to signal drift and inaccuracies in the readout signal. Utilizing feedback loops and reference current/voltage sources in the readout circuit design allows for automatic correction of temperature-related SET signal drift. Overall, temperature-compensating readout is a crucial area of development for advancing SET technology beyond cryogenic limitations. By employing innovative circuit design approaches, material selection and calibration techniques, researchers aim to create SET-based sensors that are robust, reliable and functional over a wider range of temperatures.²⁵⁰

Diamond nitrogen-vacancy (NV) centres are an intriguing kind of defect that show promise for use in SETs and quantum sensors.²⁵¹ The NV centre's electron spin state is very sensitive to electric forces, magnetic fields and outside temperature. This makes them ideal for developing high-sensitivity quantum sensors. The idea of manipulating the NV centre's spin state to regulate the movement of individual electrons within a SET is being investigated by researchers. This could potentially lead to a new class of spin-based SETs with unique functionalities. Quantum error correction techniques typically used in quantum computing to protect quantum information could be conceptually applied to SETs for error detection and correction. This could involve encoding the information carried by the single electron in a redundant way, allowing for the identification and correction of errors caused by noise. The field of QEC has also emerged and is very important for mitigating the error caused by noise sources.²⁵²

Another active research area is cryo-CMOS as an interface between a SET working at cryogenic temperatures and a control unit working at room temperature. The entire sensor system, including both SET and cryo-CMOS components, needs to be designed to function effectively within the cryogenic environment. This requires careful thermal management and packaging strategies. But cryo-CMOS technology is still under development and commercially available options might

be limited. Research efforts are ongoing to improve the performance and manufacturability of cryo-CMOS circuits.²⁵³ In practical terms, it will simplify connecting SETs with other electronic components. Furthermore, an enhanced signal-to-noise ratio and providing more precise and consistent sensor data by means of the abovementioned methods all help with the creation of small and portable SET-based sensor systems.

Quantum sensors are changing space science with their unparalleled sensitivity and accuracy for tracking the Earth's vital signals from orbit. Quantum sensors in orbit could find value in monitoring climate change. Accurate measurement of minute variations in the Earth's magnetic fields, temperature and gravity helps scientists to better understand the complex processes behind global warming. Quantum sensors work by utilizing the special qualities of atoms that have been cooled to extremely low temperatures (near absolute zero). Atoms behave in a way that makes them useful for ultrasensitive measurements at these extremely cold temperatures.²⁵⁴ Hence, there is the possibility of using SETs for space applications due to their enhanced sensitivity behaviour.

The nano-fabrication of a SET as a charge sensor and measuring the outputs in a cryogenic environment address scalability and cost impacts. Developing cost-effective fabrication techniques for large-scale, cost-effective fabrication methods are crucial for the widespread adoption of SET-based sensors. The development of design tools and standardization of manufacturing techniques can help to create more reasonably priced SET-based sensors. By concentrating on these important areas of research and development, scientists can overcome the constraints of SET technology and unleash its full potential for highly sensitive miniaturized and next-generation charge sensors for many uses in healthcare diagnostics, environmental monitoring, scientific research and beyond.

Current developments in SET based charge sensors

The research community continuously tries to enhance the sensitivity of SETs by modifying their structures. An essential SET is a quantum dot between the source and drain electrodes through tunnel junctions. The gate electrode can control the electron flow between the electrodes. However, to improve the sensitivity, researchers have tried to reduce the size of the quantum dot, which can increase the impact of a single electron on a device's performance. In addition to that, researchers have optimized the thickness, material and area of the tunnel junctions to get a stronger read-out signal so that the strong signal can easily be measured, which leads to an increase in the sensitivity of the charge sensor. Also by lowering the operating temperature to the cryogenic level, the sensitivity of the charge sensor has been improved. Since the lowered temperature prevents random thermal fluctuation, a sharper Coulomb blockade response can occur, which makes the SET more sensitive to a tiny change in charge.²⁵³ Recently, the quantum dot size has been reduced to less than 10 nm, which can help to pack many SETs in one chip. These days, researchers are exploring a way to combine SETs with CMOS technology to fabricate them using the same methods as those

used for regular computer chips.²⁵⁵ This would lead to SETs being used in a wide range of real-time applications. Moreover, exploring new materials suitable for SETs is critical to current research. Generally, silicon is used for SET charge sensors. However, it has some issues with operating temperature, sensitivity, stability and fabrication complexity. Thus, researchers actively explore new materials that can work under high temperatures, exhibit strong quantum effects and are less susceptible to environmental factors such as graphene, CNTs and perovskites.²⁵⁶ Nowadays, SETs are actively implemented in various fields like quantum computing, single-molecule detection and metrology.

Room temperature operation of SETs is considered one of the main unresolved challenges. Designing SETs with tiny quantum dots and tunnel junctions to raise the charging energy so that it is sufficient to overcome thermal energy at room temperature presents a problem. Using current fabrication methods makes this quite challenging. Charge noise is another unresolved issue for the SET-based charge sensor since it produces random fluctuations when the charge comes near the QD.²¹⁹ Establishing better fabrication techniques to lower defects and contaminants and creating digital techniques to either offset or filter the impact of charge noise are highly desirable. Defects, contaminants and interface roughness can all influence electron transport and device performance during fabrication; these are difficult to control completely. Small changes in temperature, pressure and other factors can affect the finished device, even in very regulated cleanrooms. Sophisticated fabrication methods include electron beam lithography, atomic force microscopy, lithography and other sophisticated techniques that are thus being enhanced to produce nanoscale structures with increasing precision.²⁵⁷ Furthermore, employing chemical techniques whereby nanostructures organize themselves can help to increase homogeneity and lower the necessity for intricate manufacturing techniques. Making SETs viable for real-world uses, including quantum computing, sensing and nanoelectronics, requires improved repeatability and production. A good readout and control mechanism is challenging, despite charge, noise, thermal fluctuations, minor signal issues and high bandwidth issues. For SET-based sensors, efficient readout is crucial for detecting small environmental changes.²⁵⁸ Developing ultrasensitive amplifiers, low-noise measurement techniques, pulse shaping multiplexing techniques and feedback control is highly advisable to detect the small signals from SETs.⁵⁹

Conclusion

This extensive review shows the exciting potential of next-generation SETs to revolutionize charge sensing applications. We have explored the underlying ideas of SETs, emphasizing how special they are at manipulating and detecting individual electrons. Due to their unmatched sensitivity, SETs are at the cutting edge of a new era of ultra-precise charge detection and as a quantum sensor. This literature review provides a detailed

survey of existing works related to SETs in terms of their geometry characterization and fabrication methods. Also, the review highlighted the significance of the Coulomb diamond for comprehending the behaviour of SETs. Moreover, a visual representation of the relationship between the source–drain bias and gate voltage provides a road map for maximizing SET performance for specific sensing applications. Moreover, improvements in fabrication techniques like electron beam lithography, molecular beam epitaxy, deep reactive ion etching, UHV sputtering and deep UV lithography, which are essential for achieving single-electron control, make the development of extremely accurate and repeatable SET designs possible. In addition, to fabricate these miniaturized devices, structural integrity and functionality are highly dependent on nanoscale characterization methods such as cryogenic probe station and cryo-TEM. Next-generation SET applications for charge sensing are remarkable. Their incredible sensitivity makes it possible to identify even the smallest variations in charge, which paves the way for groundbreaking advances in single-molecule detection, ultrasensitive biosensing and real-time cellular biological process monitoring. Beyond biological applications, SETs have enormous potential as qubit read-out devices in the rapidly developing field of quantum computing. However, the investigation reveals that current obstacles are blocking the broad implementation of SETs. A key drawback of cryogenic operation is the consequent need for further research into achieving room-temperature operation. Furthermore, problems include scalability and cost-effectiveness resulting from the complex and expensive manufacturing techniques being applied. Notwithstanding these shortcomings, next-generation SETs have quite bright futures. A fascinating area of continuous materials science research that opens up new practical uses is the development of novel materials with higher temperature operation capability. Furthermore, improvements in fabrication methods could lead to more affordable and scalable SET production, allowing for greater integration of these devices into other technical fields. Next-generation SETs have a lot of fascinating possibilities ahead of them. When these devices are combined with microfluidic platforms, sophisticated lab-on-a-chip devices that can carry out intricate bioanalytical tasks with previously unheard-of accuracy may be developed. Moreover, the investigation of SETs in neuromorphic computing provides insights into the development of better processing power computers that are modelled after the human brain. Ultimately, this review has brought to light the tremendous potential that next-generation SETs have to bring in a new era of ultrasensitive charge sensing. As research continues to address existing constraints and investigate novel applications, SETs can potentially transform many scientific and technical domains, thereby influencing the direction of electronics at the nanoscale. Next-generation semiconductor epitaxial systems (SETs) promise to open up new avenues in various disciplines, including quantum computing and healthcare, by utilizing the power of single electrons. The process of achieving this potential is well underway and this revolutionary technology has a bright future.

Author contributions

Jency Rubia J: writing – original draft review & editing data curation visualization. Julaiba Tahsina Mazumder: writing – review & editing validation. Arun B. Alosious: investigation funding acquisition supervision. Ravindra Kumar Jha: investigation funding acquisition supervision.

Data availability

No primary research results, software or code have been included and no new data were generated or analysed as part of this review.

Conflicts of interest

The authors declare no competing interests.

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